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(54) **FREQUENCY TUNABLE RESONANT
SCANNER AND METHOD OF MAKING**

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H01J 3/14 (2006.01)

(52) **U.S. Cl.** **250/235**; 359/199

(58) **Field of Classification Search** 250/235,
250/559.29, 216; 359/198–201, 212–215
See application file for complete search history.

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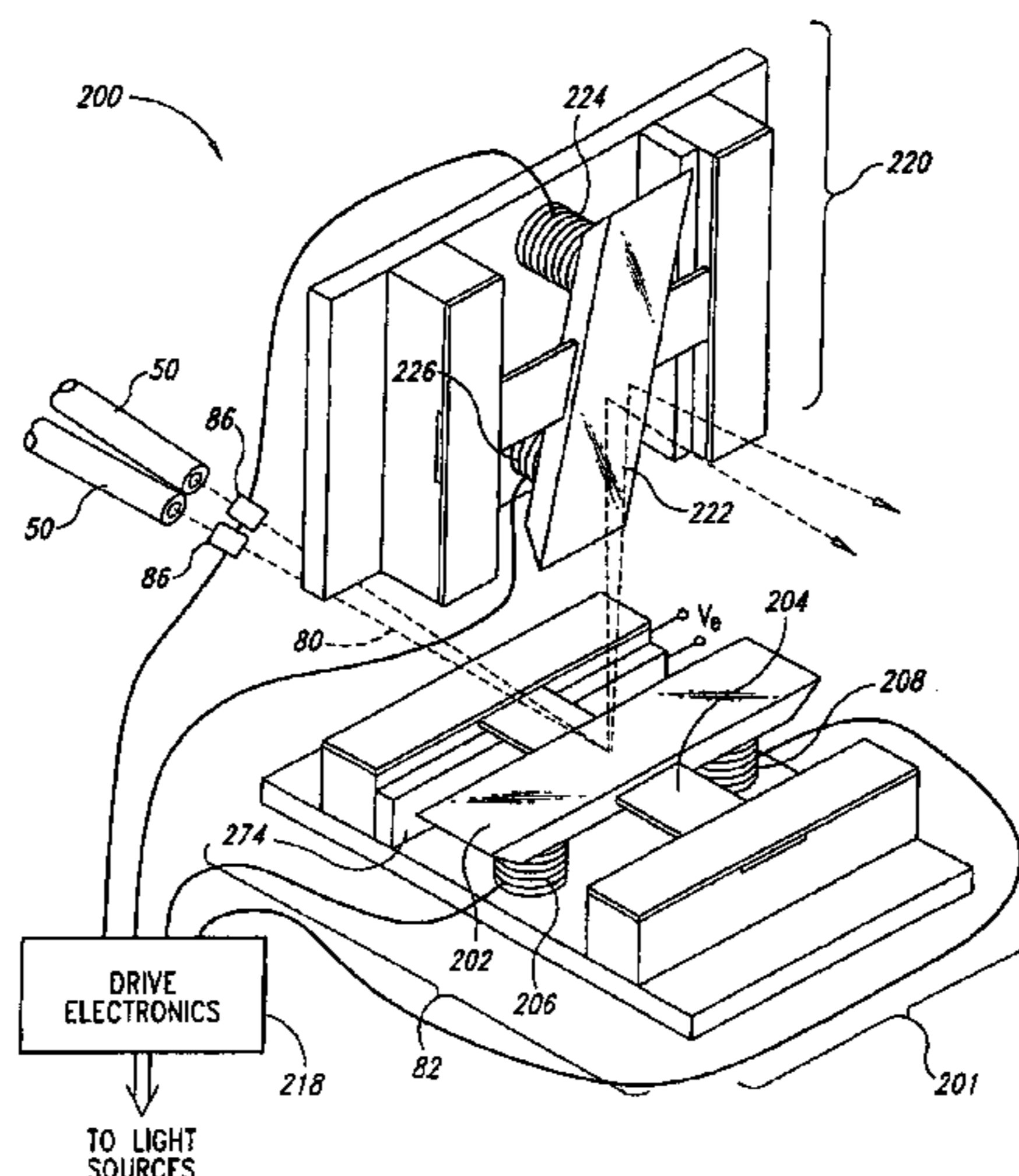
Primary Examiner—Que T Le

(74) *Attorney, Agent, or Firm*—Kevin D. Wills

(57) **ABSTRACT**

A MEMs scanning device has a variable resonant frequency. In one embodiment, the MEMs device includes a torsion arm that supports an oscillatory body. In one embodiment, an array of removable masses are placed on an exposed portion of the oscillatory body and selectively removed to establish the resonant frequency. The material can be removed by laser ablation, etching, or other processing approaches. In another approach, a migratory material is placed on the torsion arm and selectively stimulated to migrate into the torsion arm, thereby changing the mechanical properties of the torsion arm. The changed mechanical properties in turn changes the resonant frequency of the torsion arm. In another approach, symmetrically distributed masses are removed or added in response to a measured resonant frequency to tune the resonant frequency to a desired resonant frequency. A display apparatus includes the scanning device and the scanning device scans about two or more axes, typically in a raster pattern. Various approaches to controlling the frequency responses of the scanning device are described, including active control of MEMs scanners and passive frequency tuning.

7 Claims, 24 Drawing Sheets



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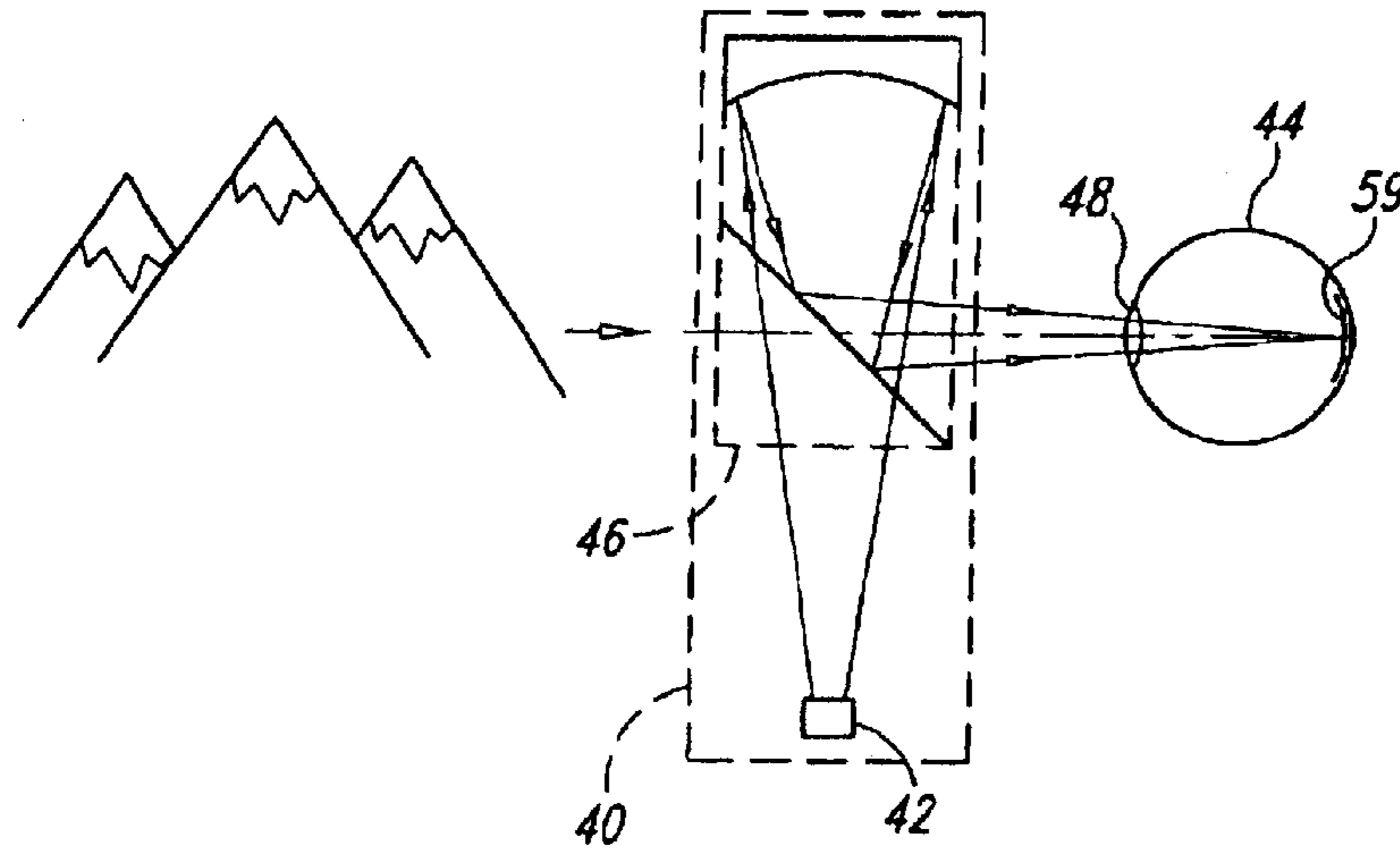


Fig. 1

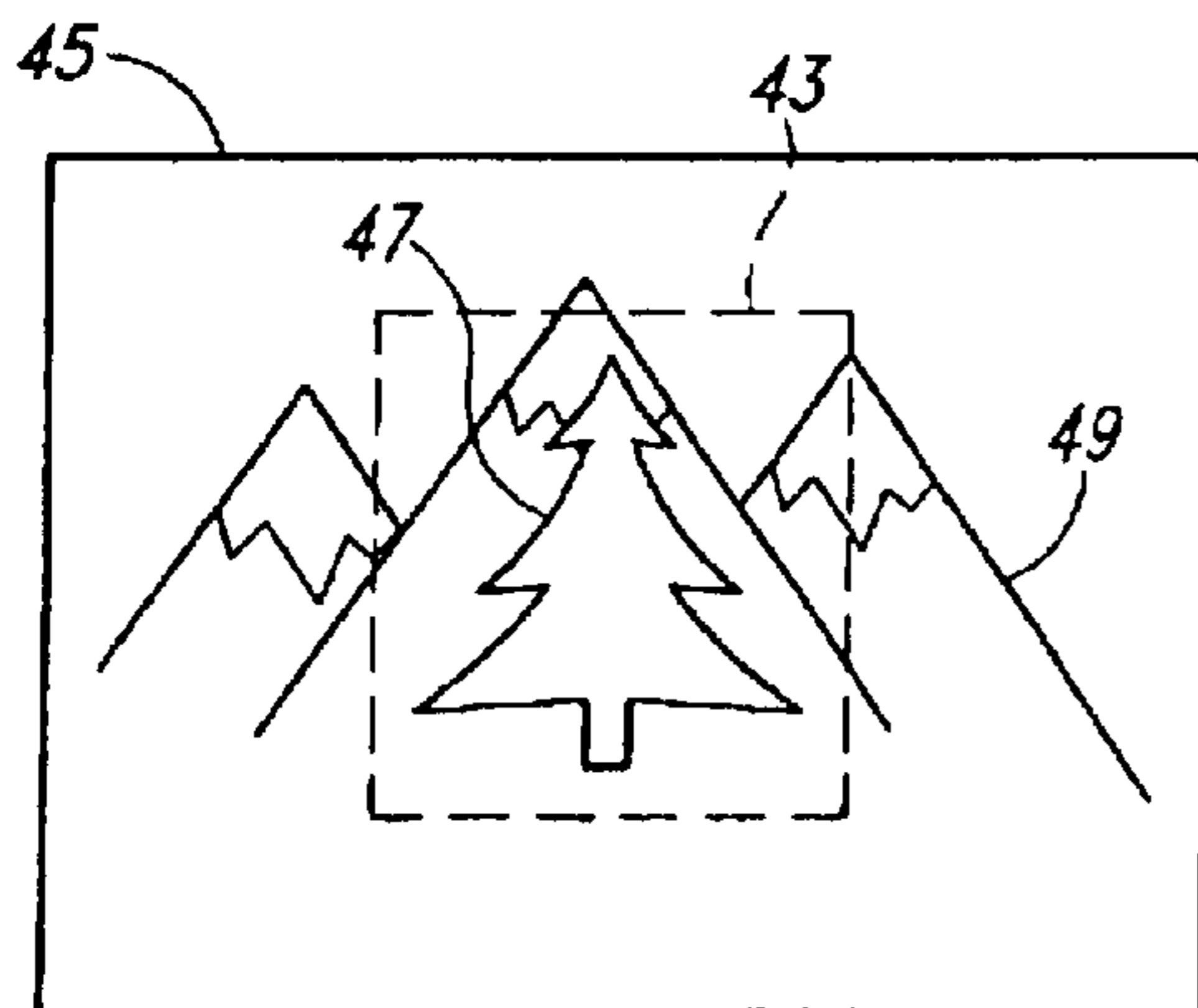


Fig. 2A

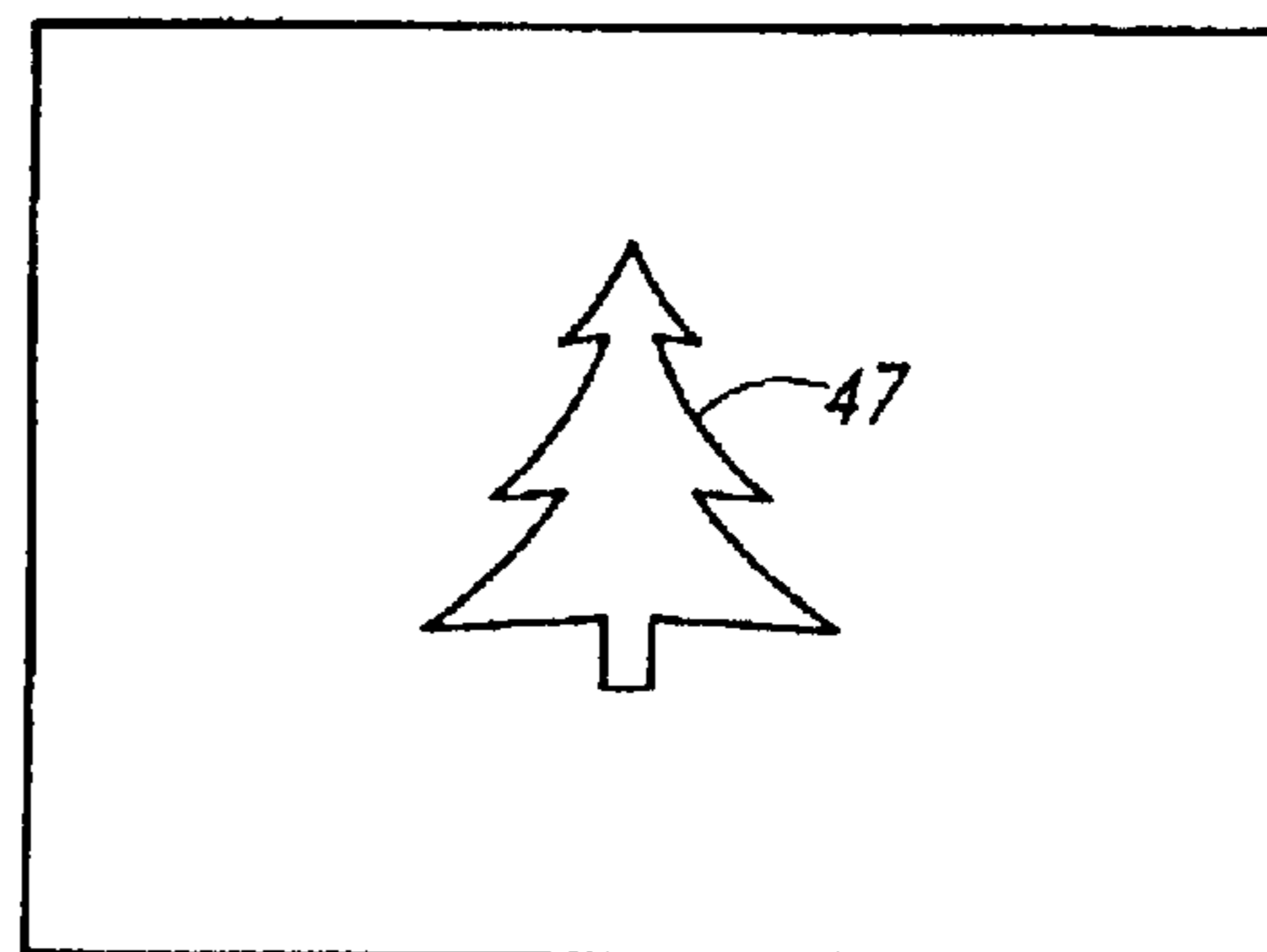


Fig. 2B

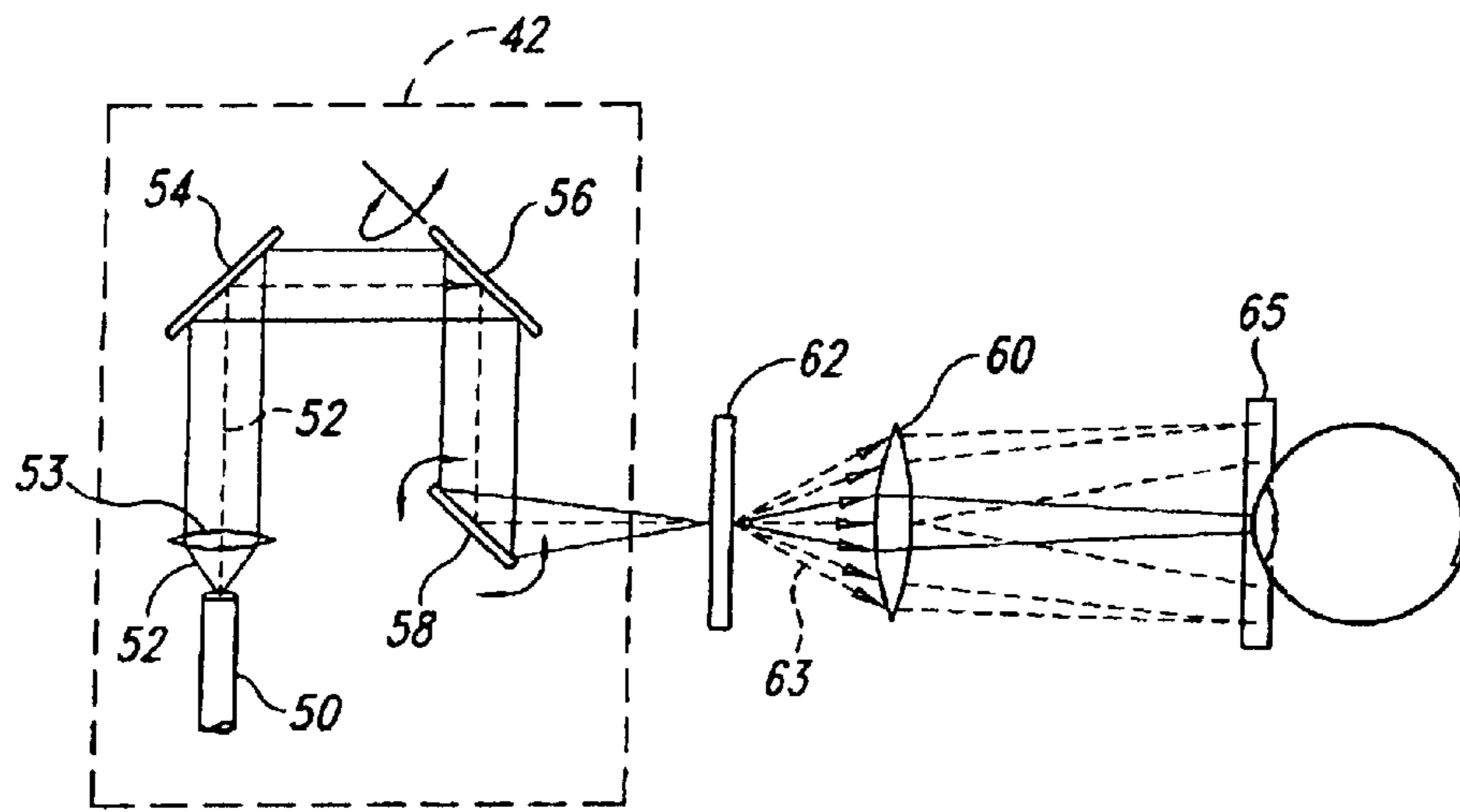


Fig. 3

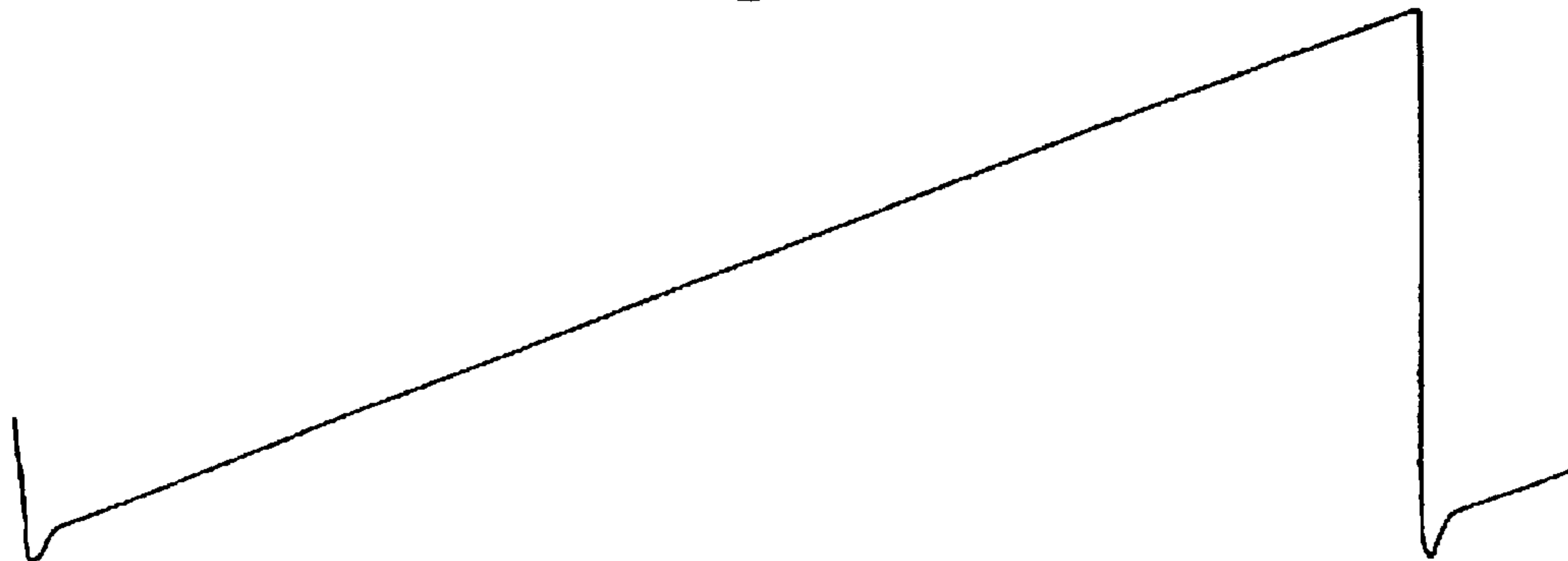


Fig. 4A

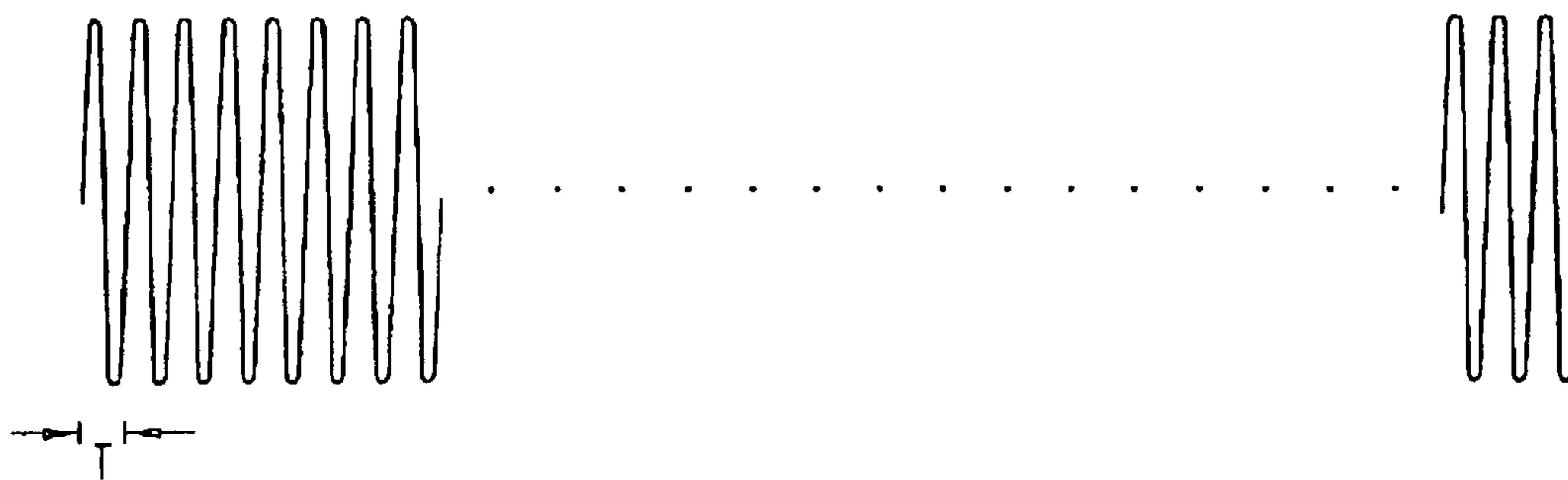


Fig. 4B

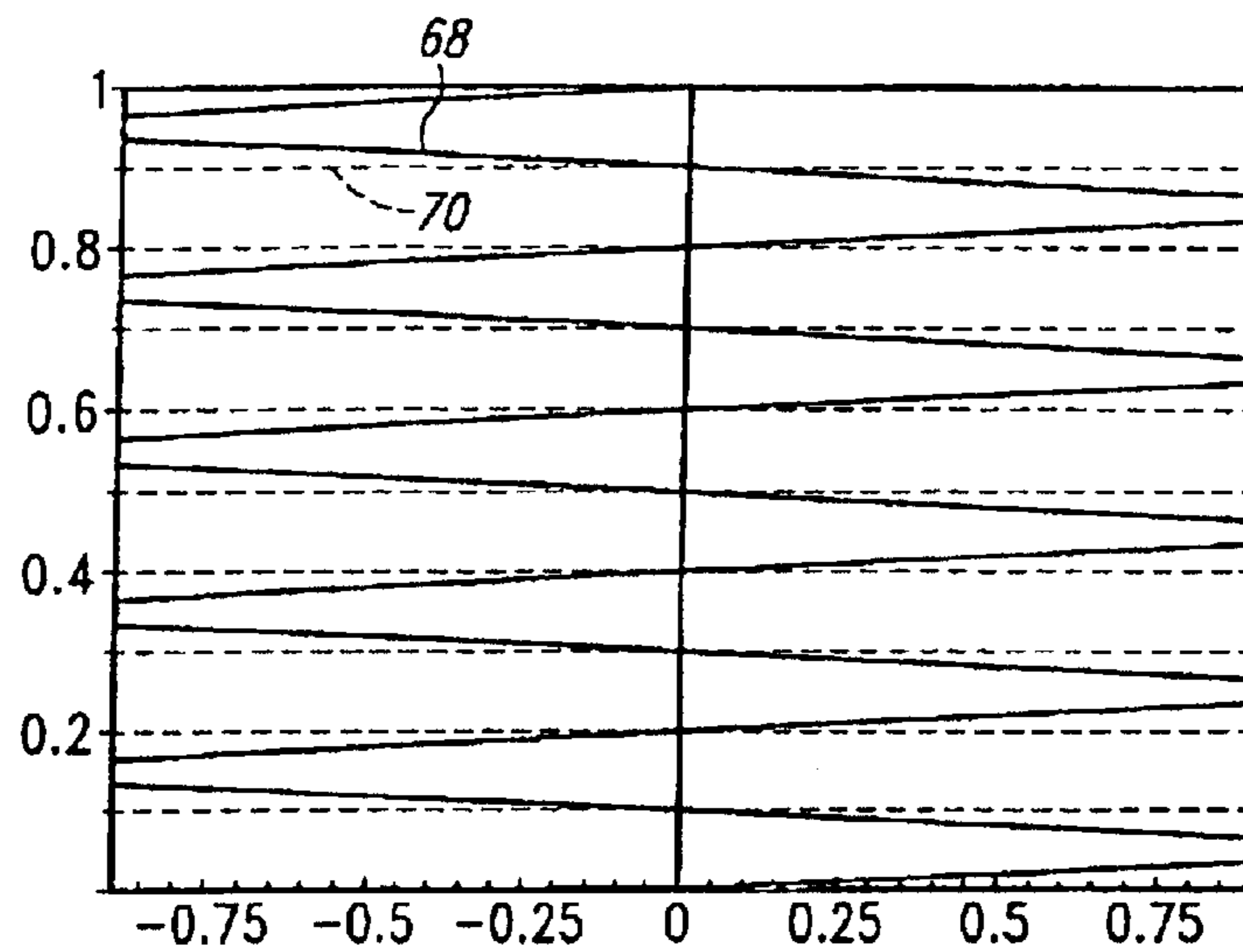


Fig. 5

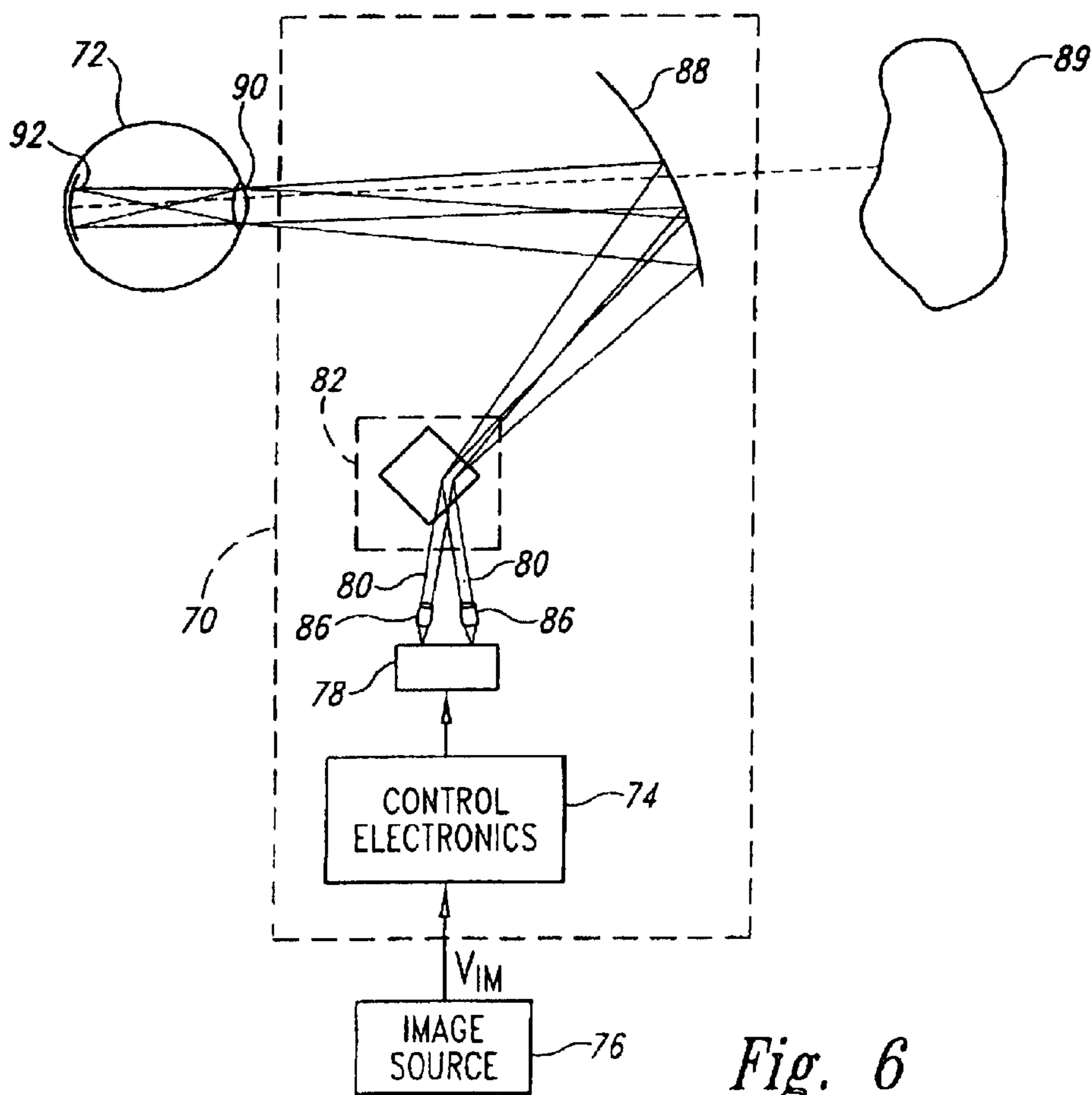
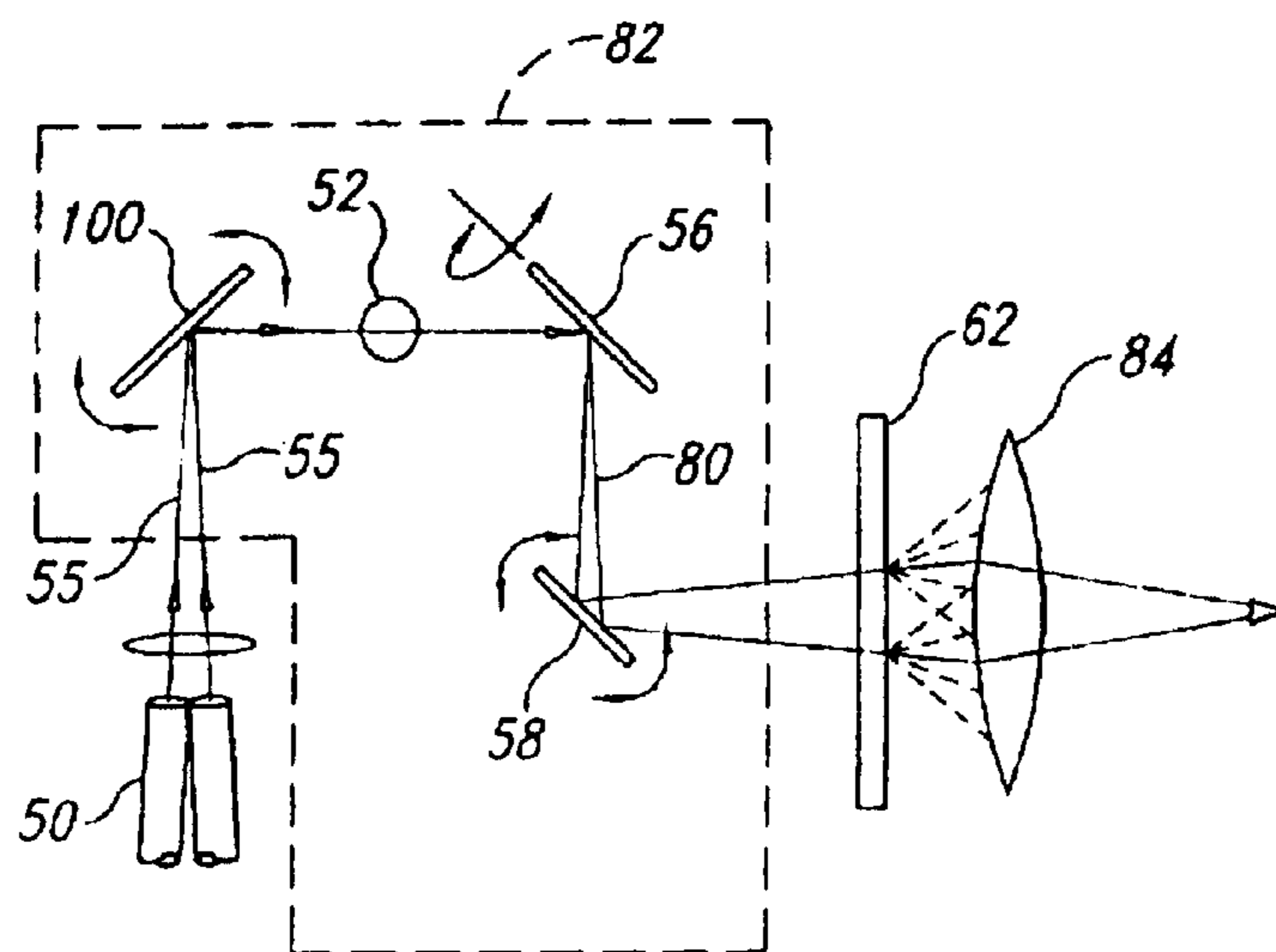
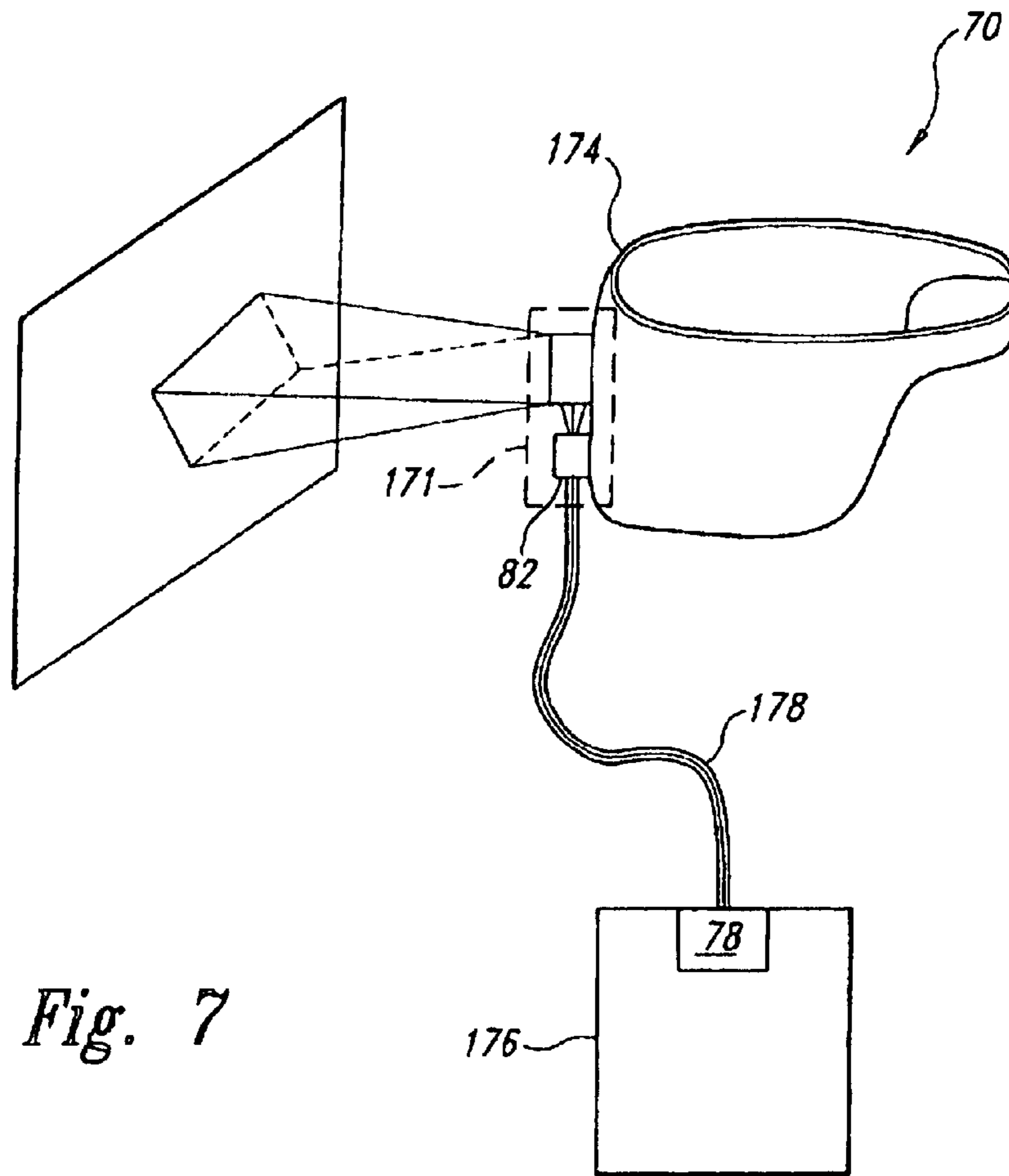


Fig. 6



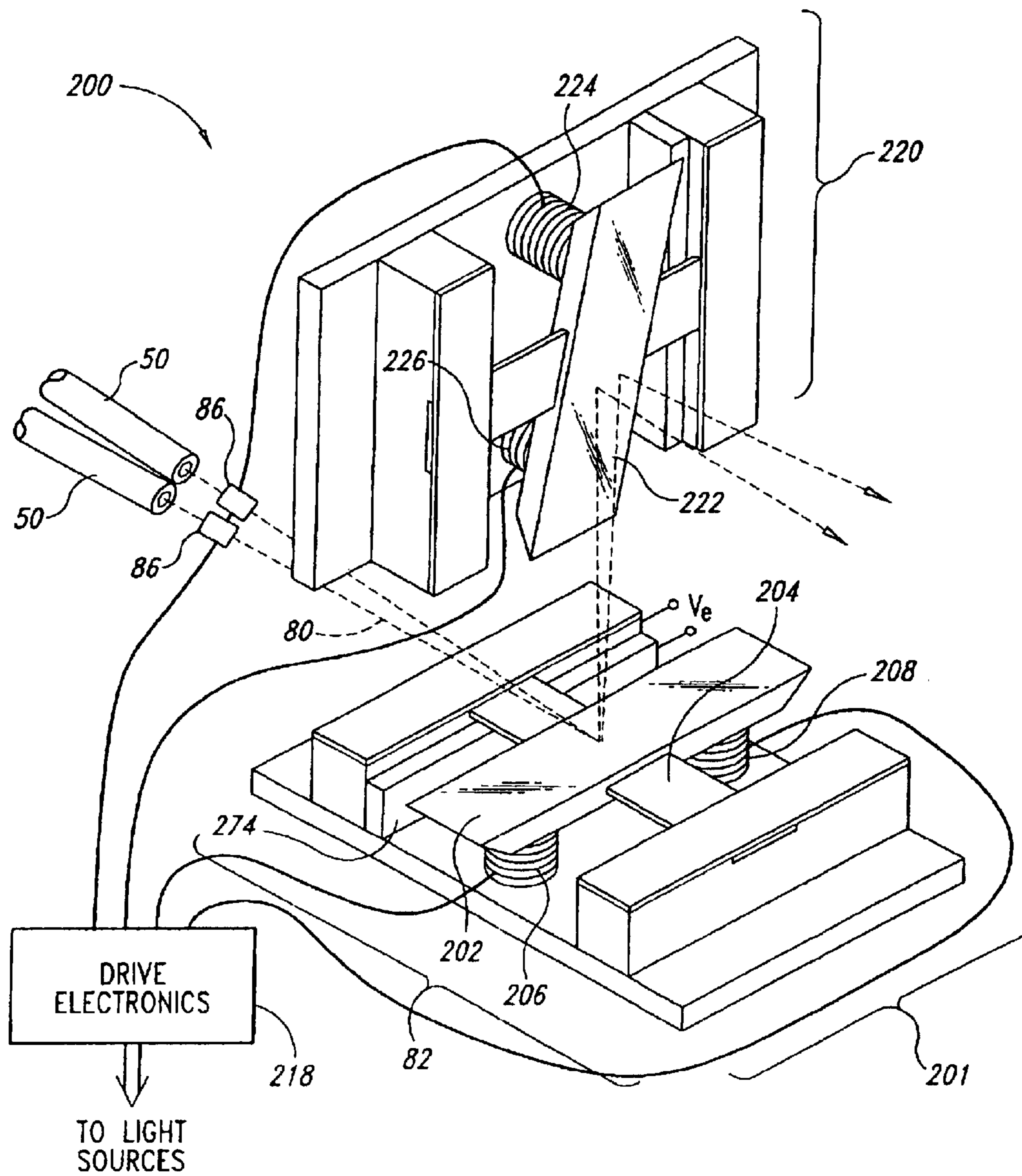
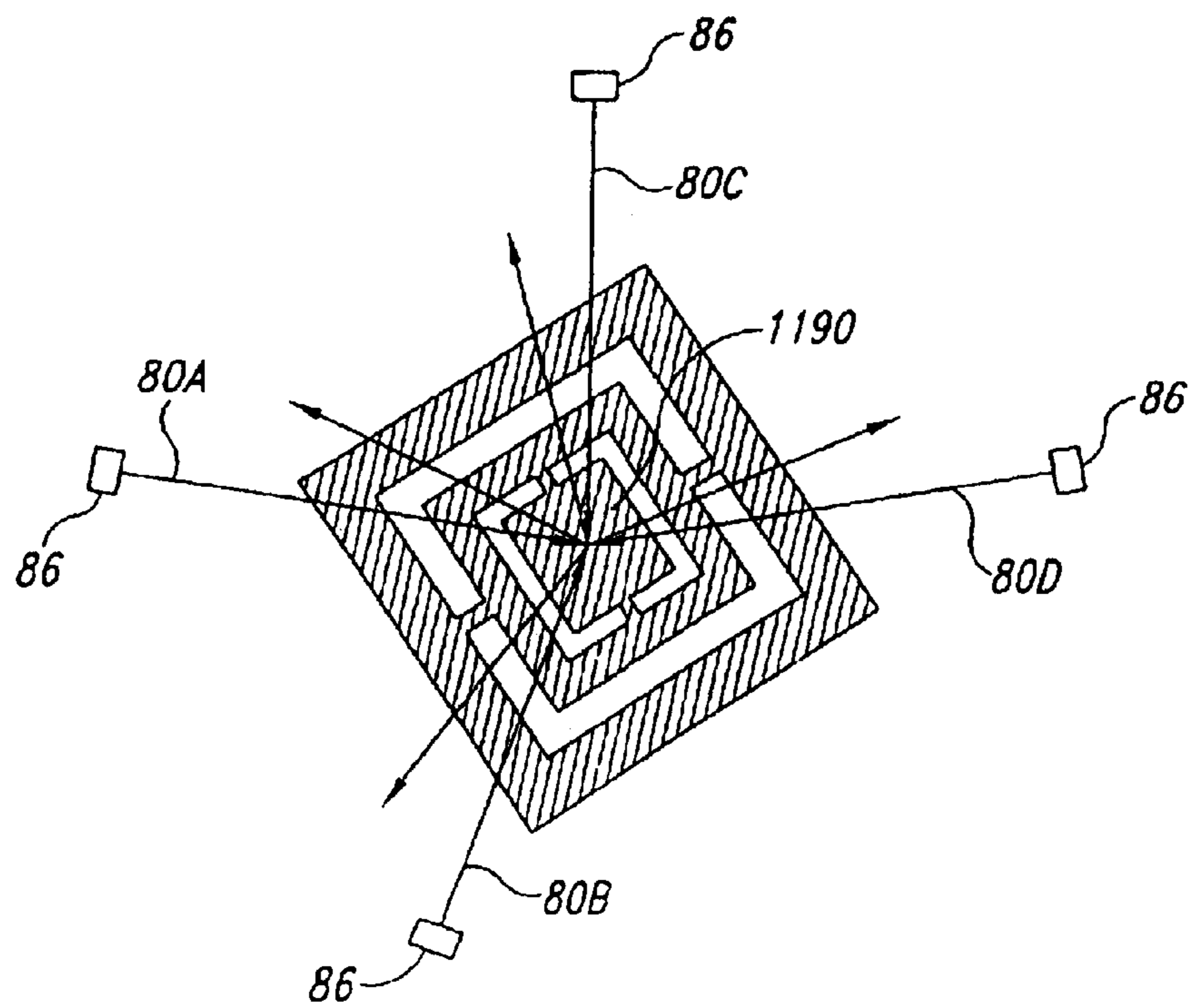
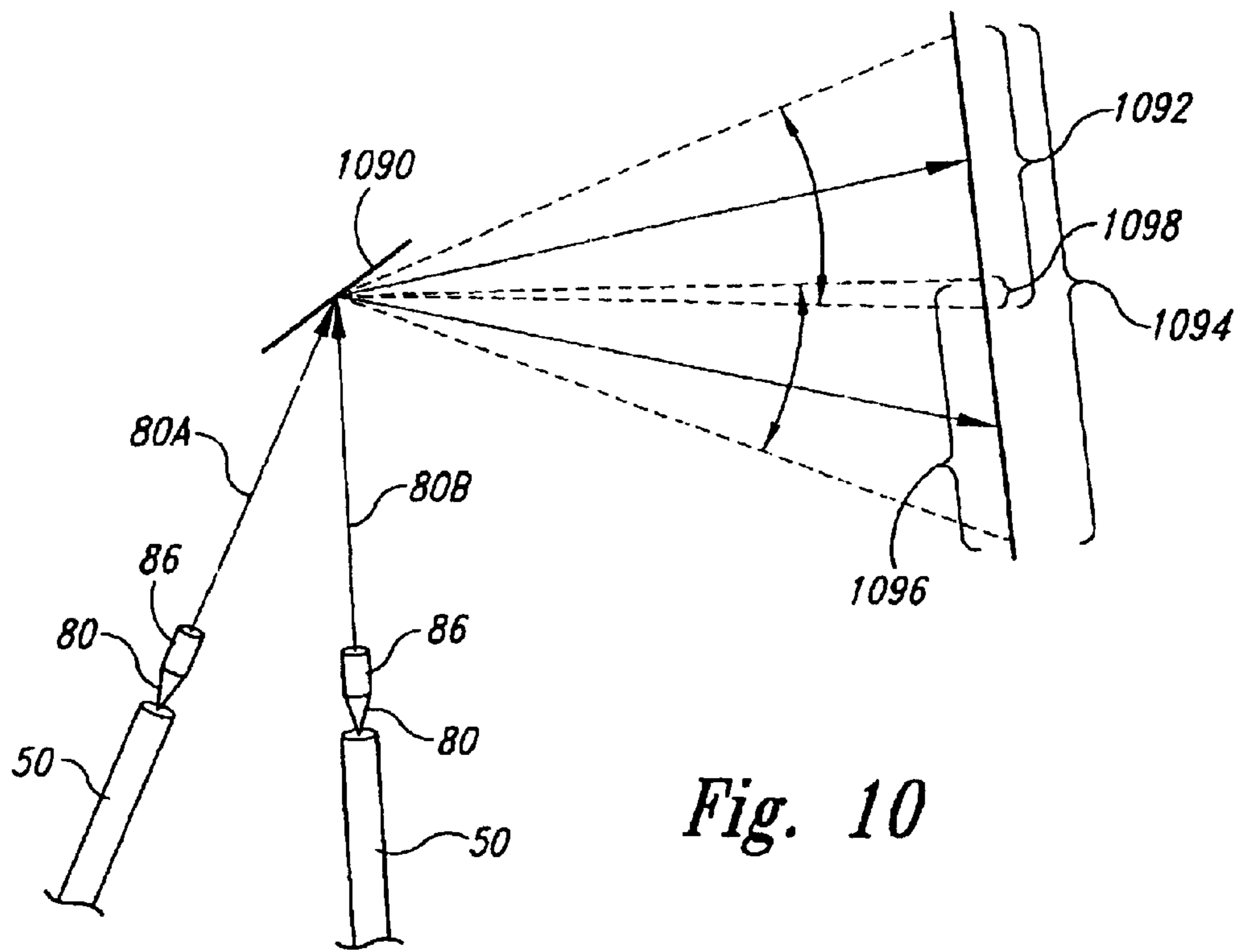


Fig. 9



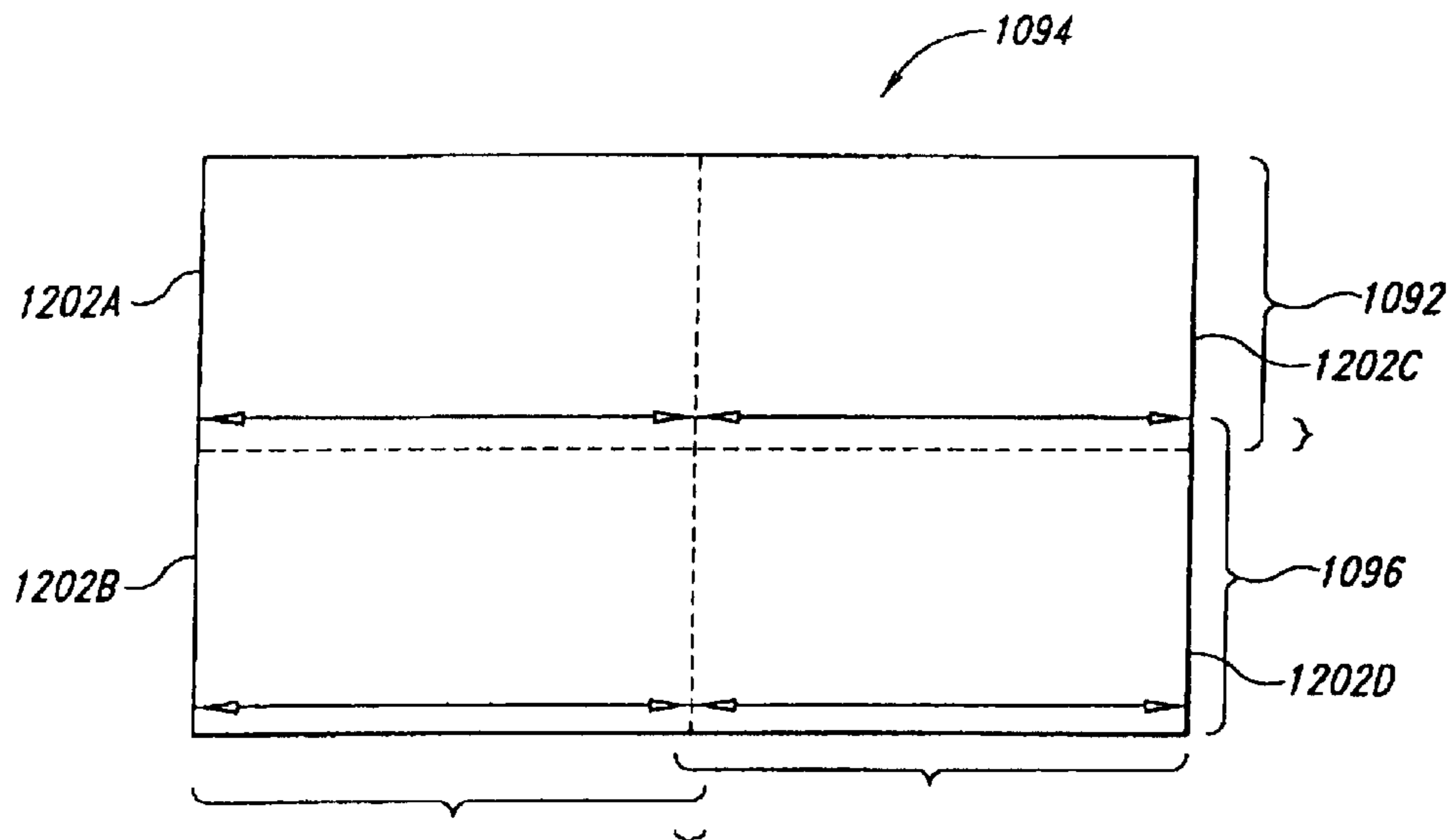


Fig. 12

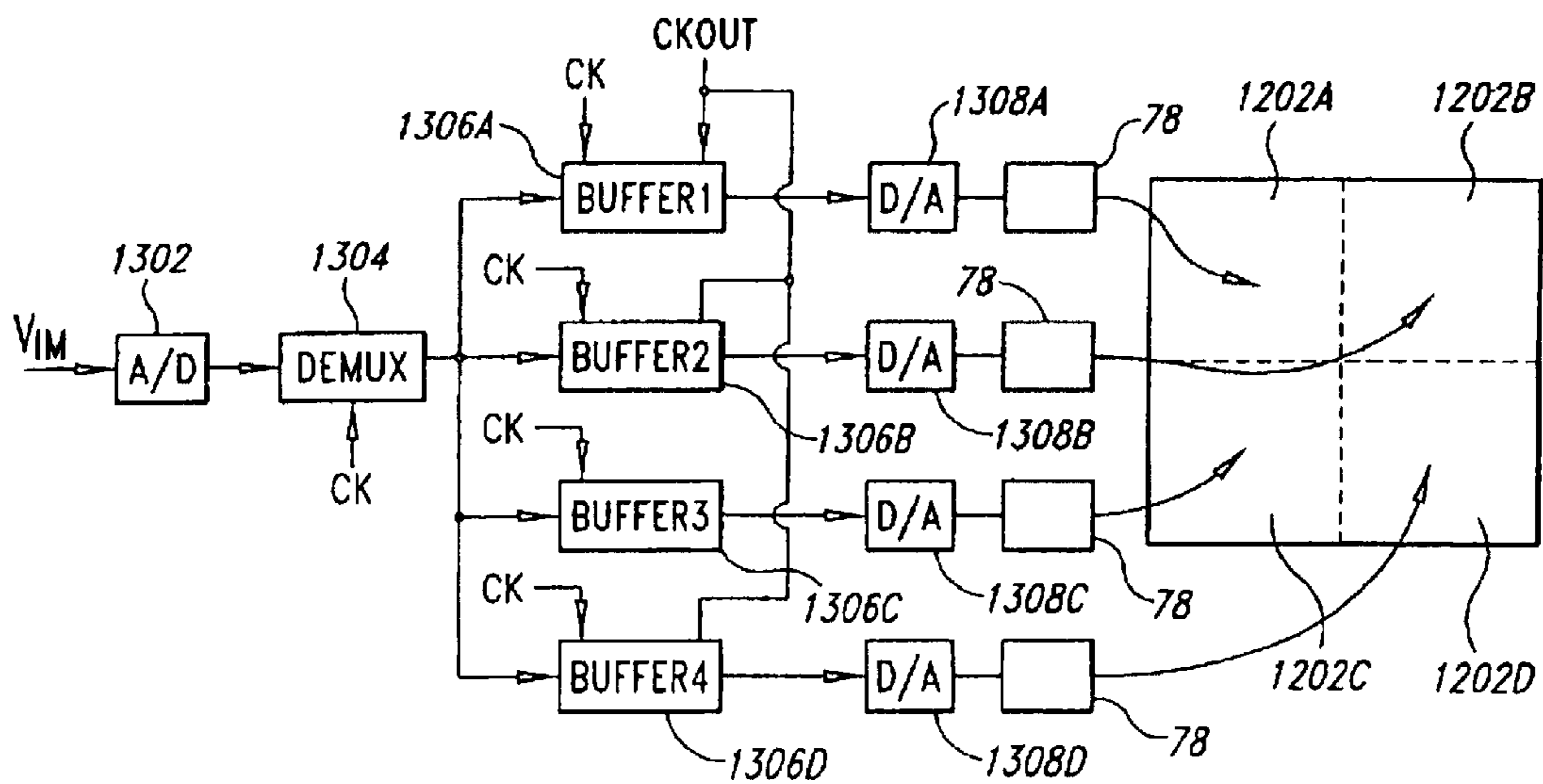


Fig. 13

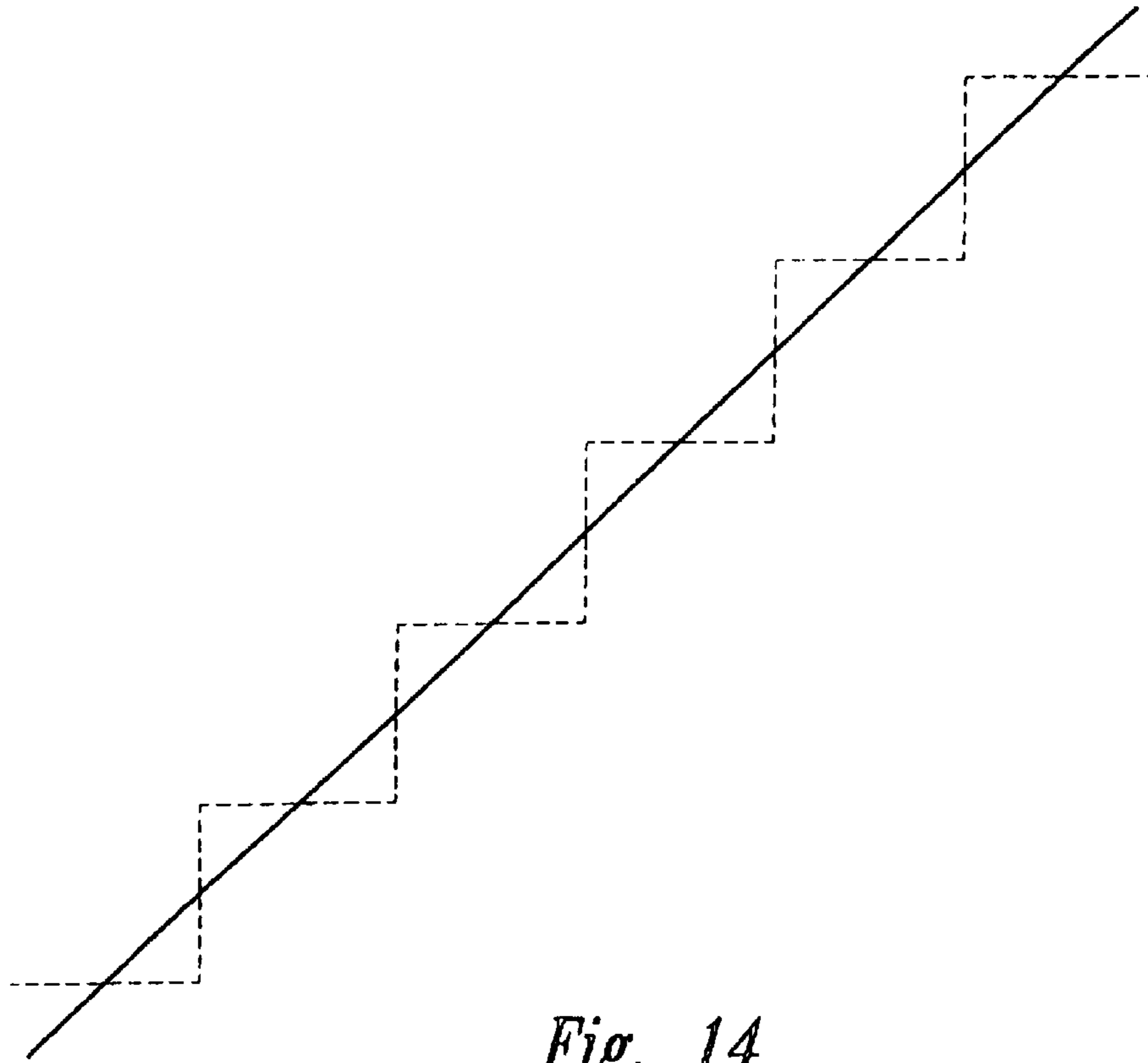


Fig. 14

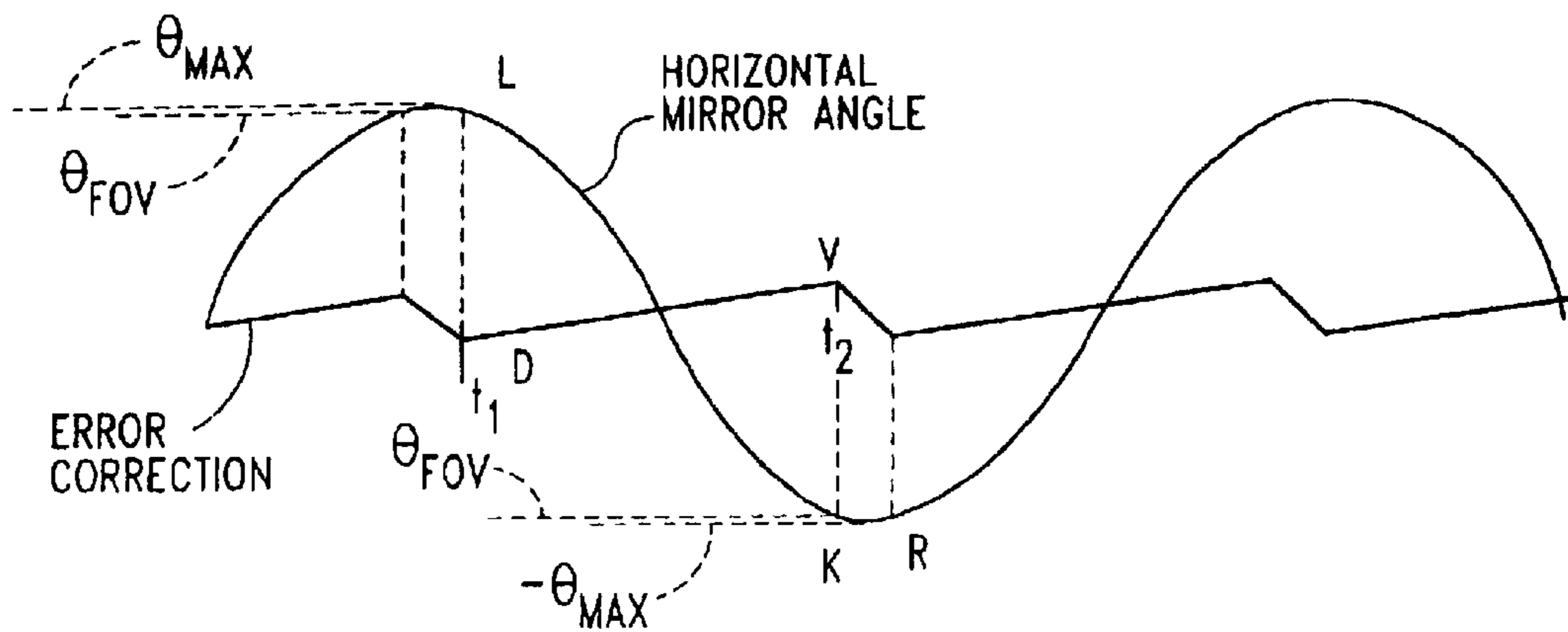


Fig. 15

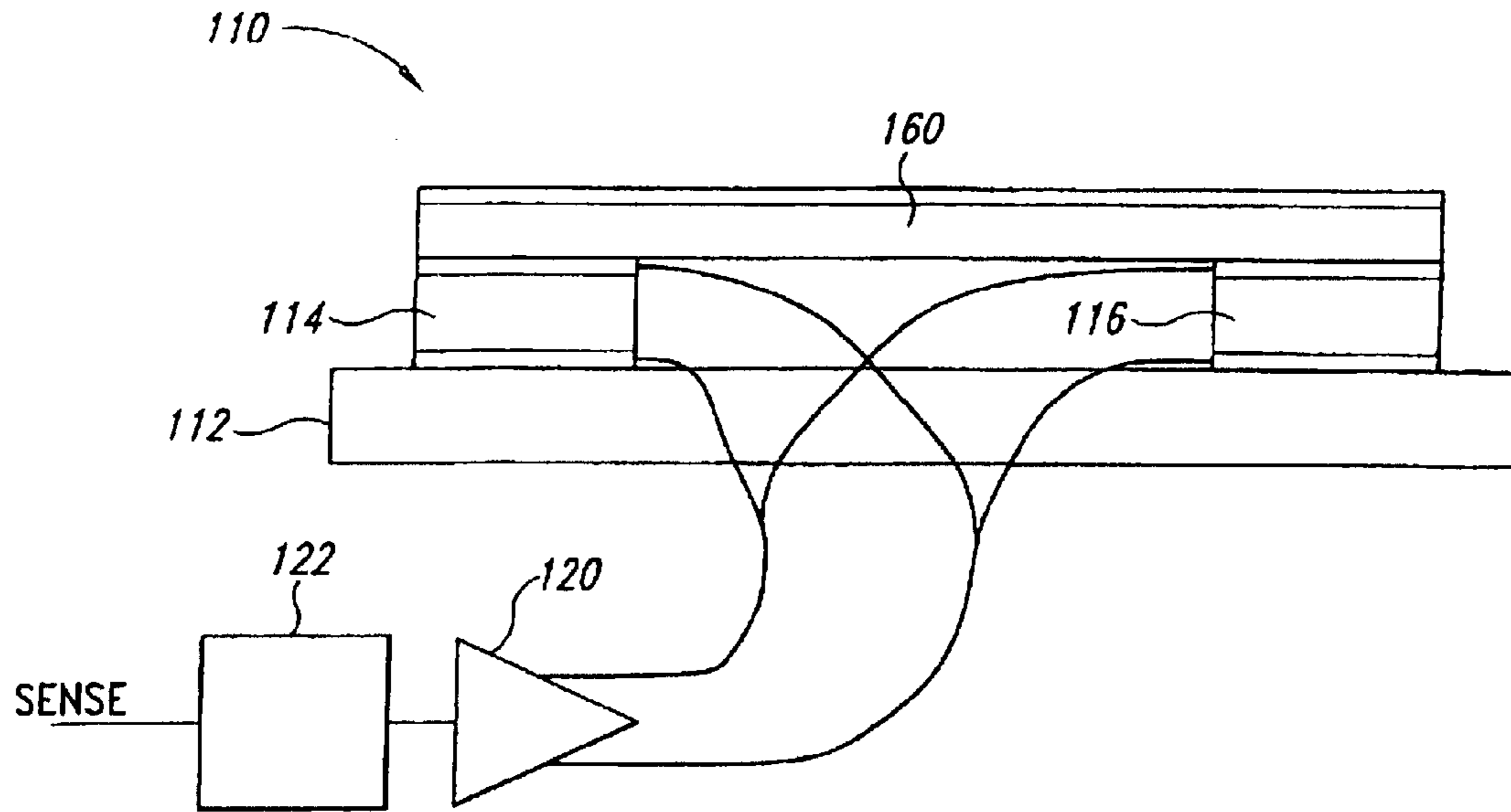


Fig. 16

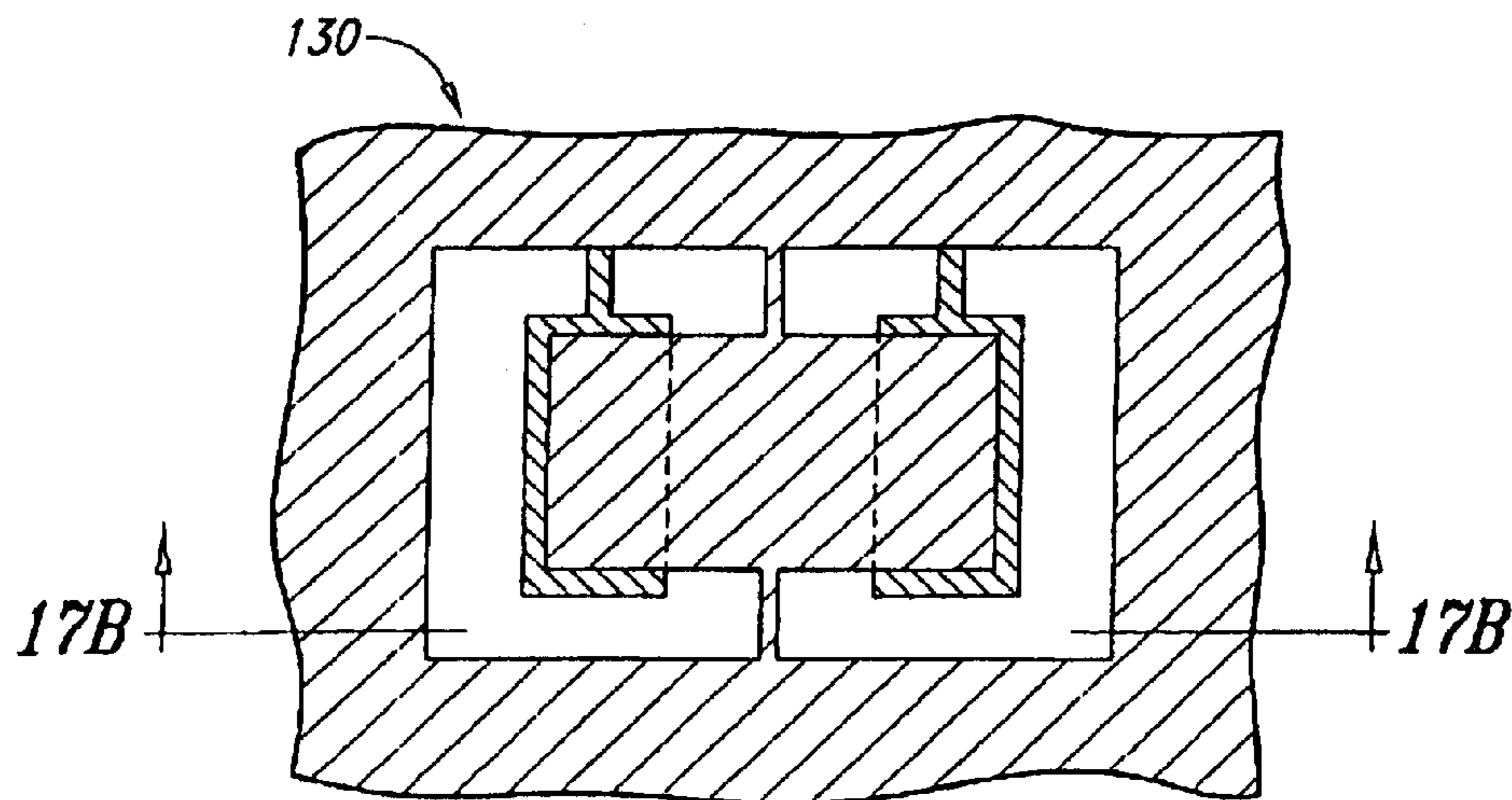


Fig. 17A

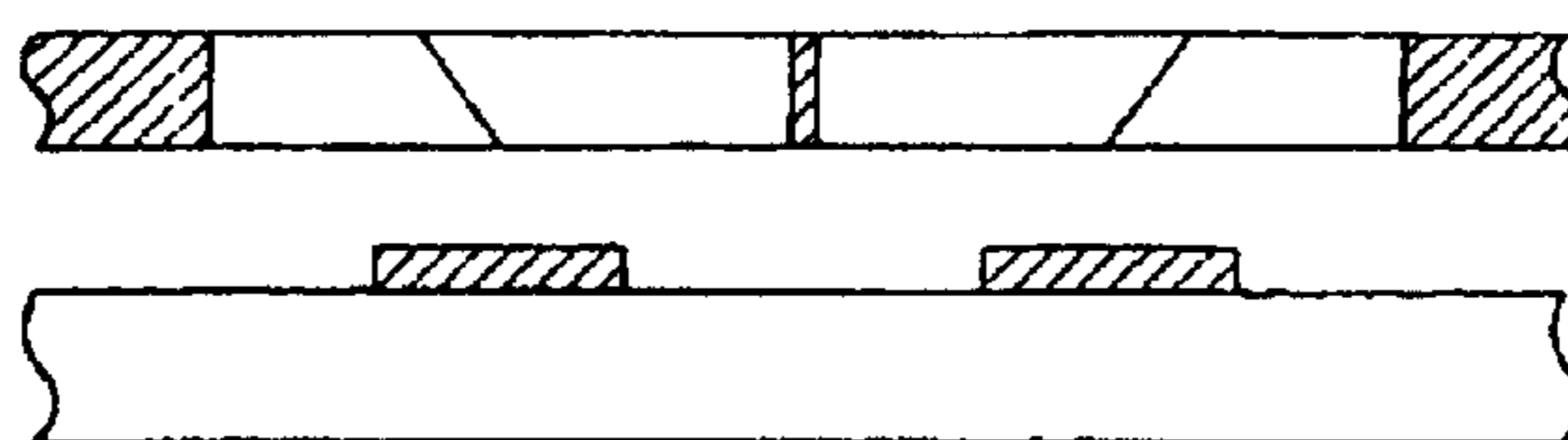


Fig. 17B

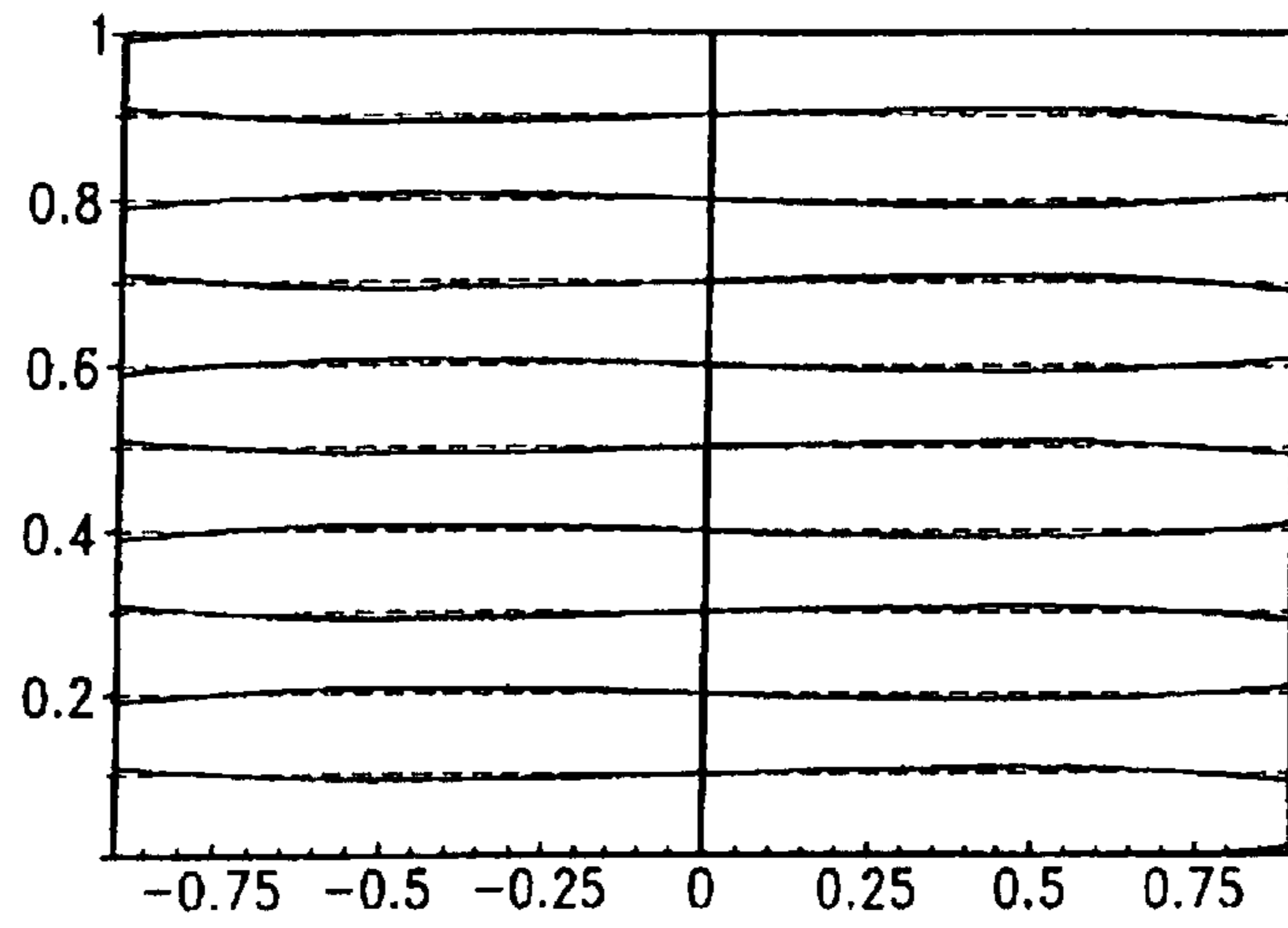


Fig. 18

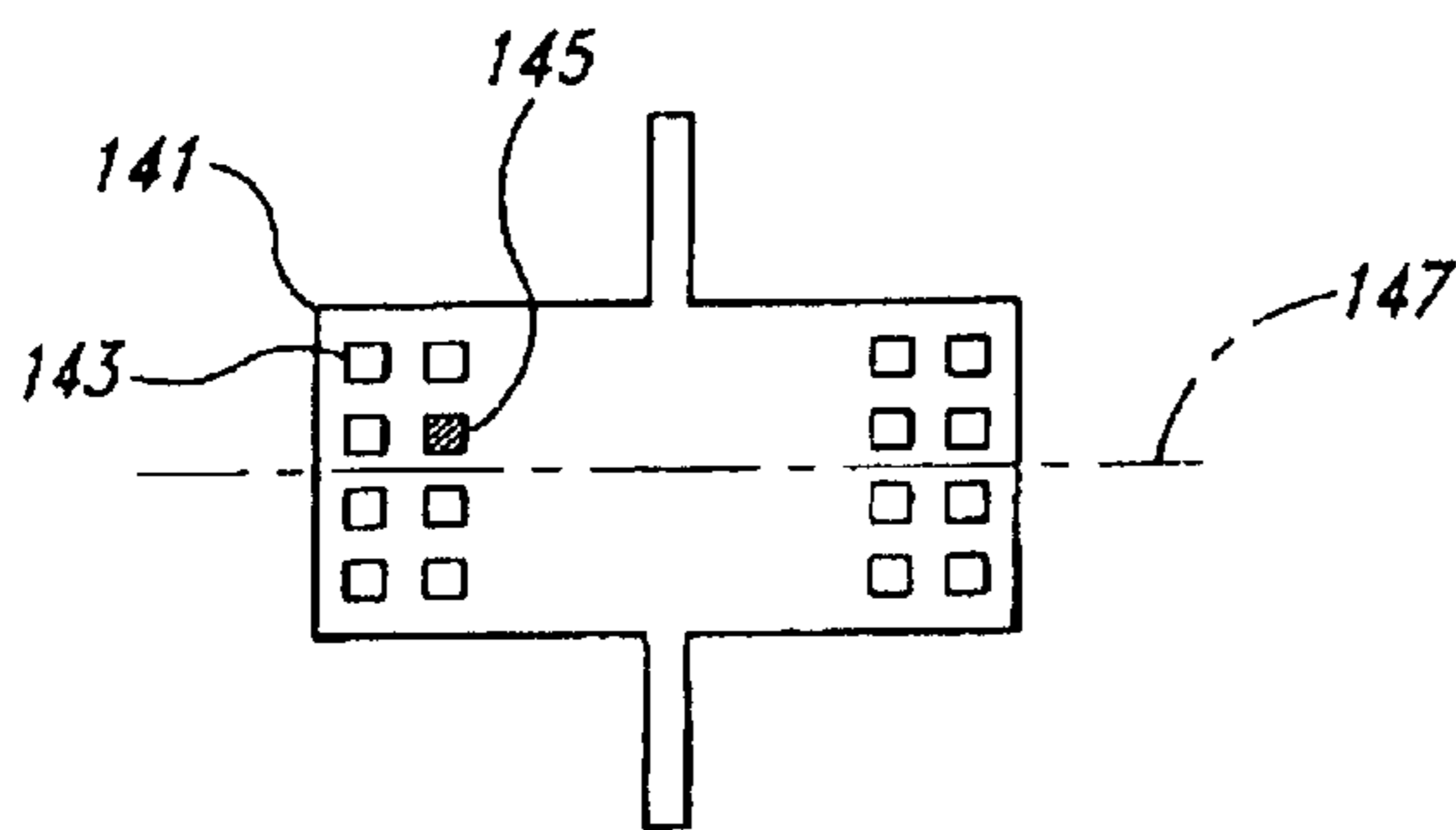


Fig. 19

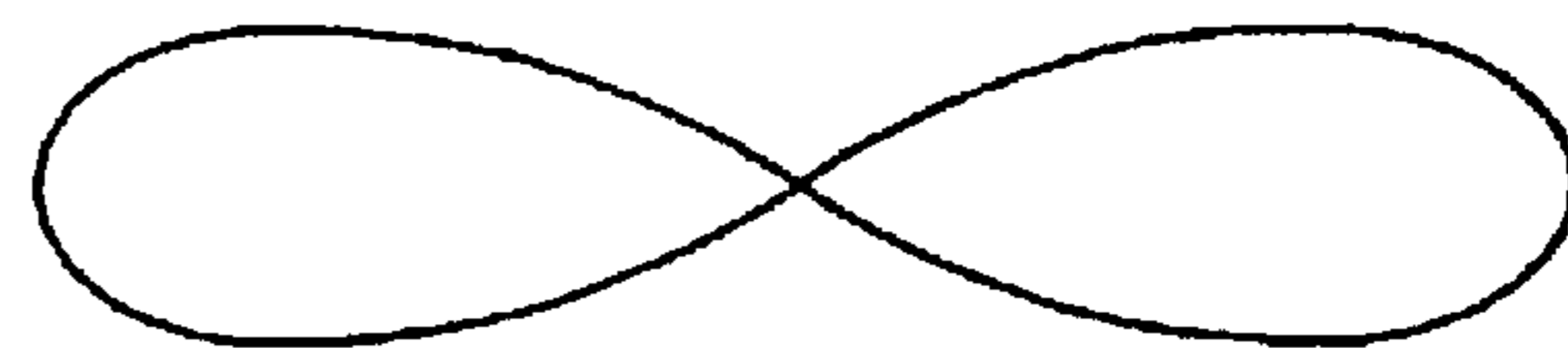


Fig. 20

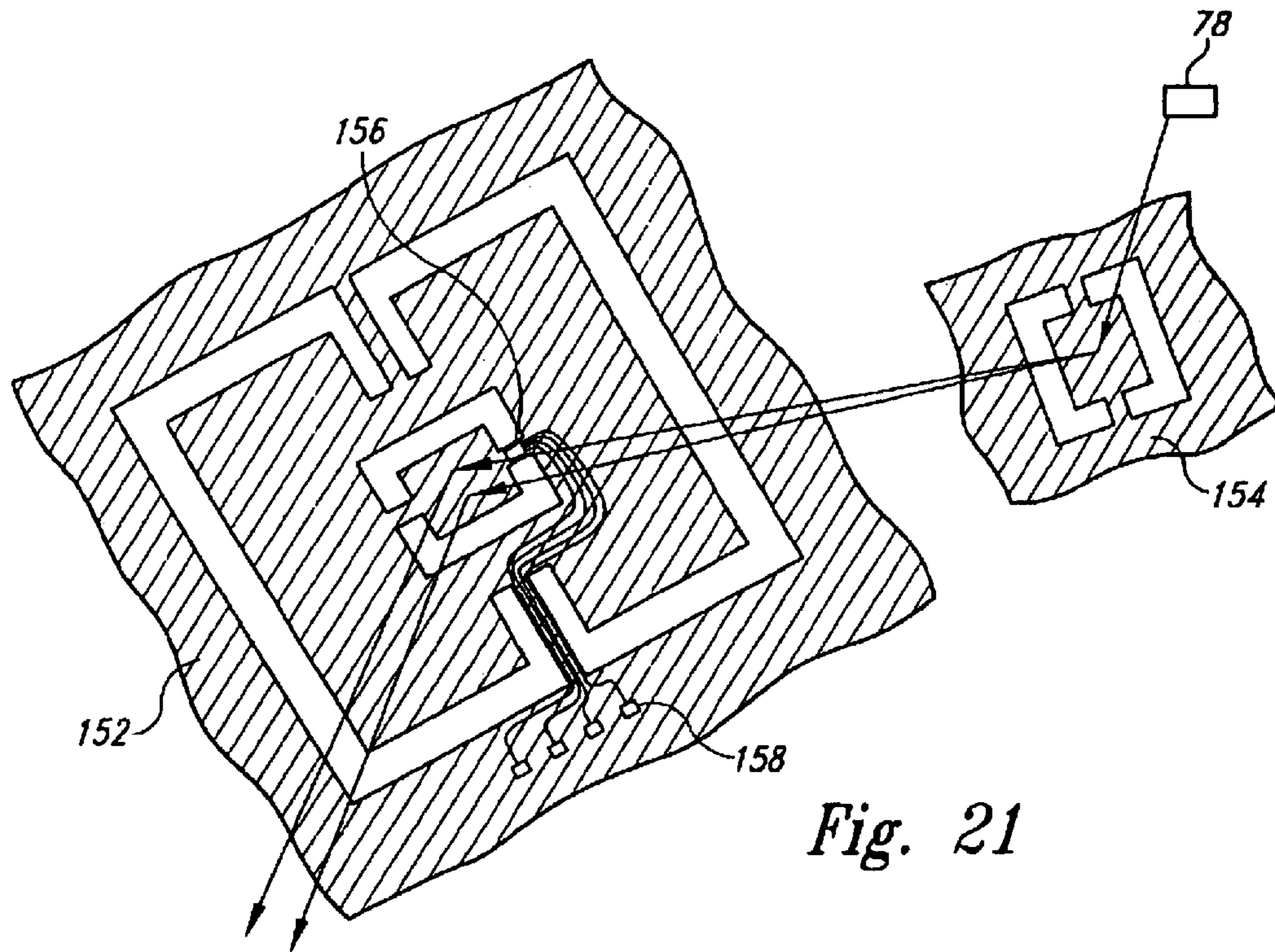


Fig. 21

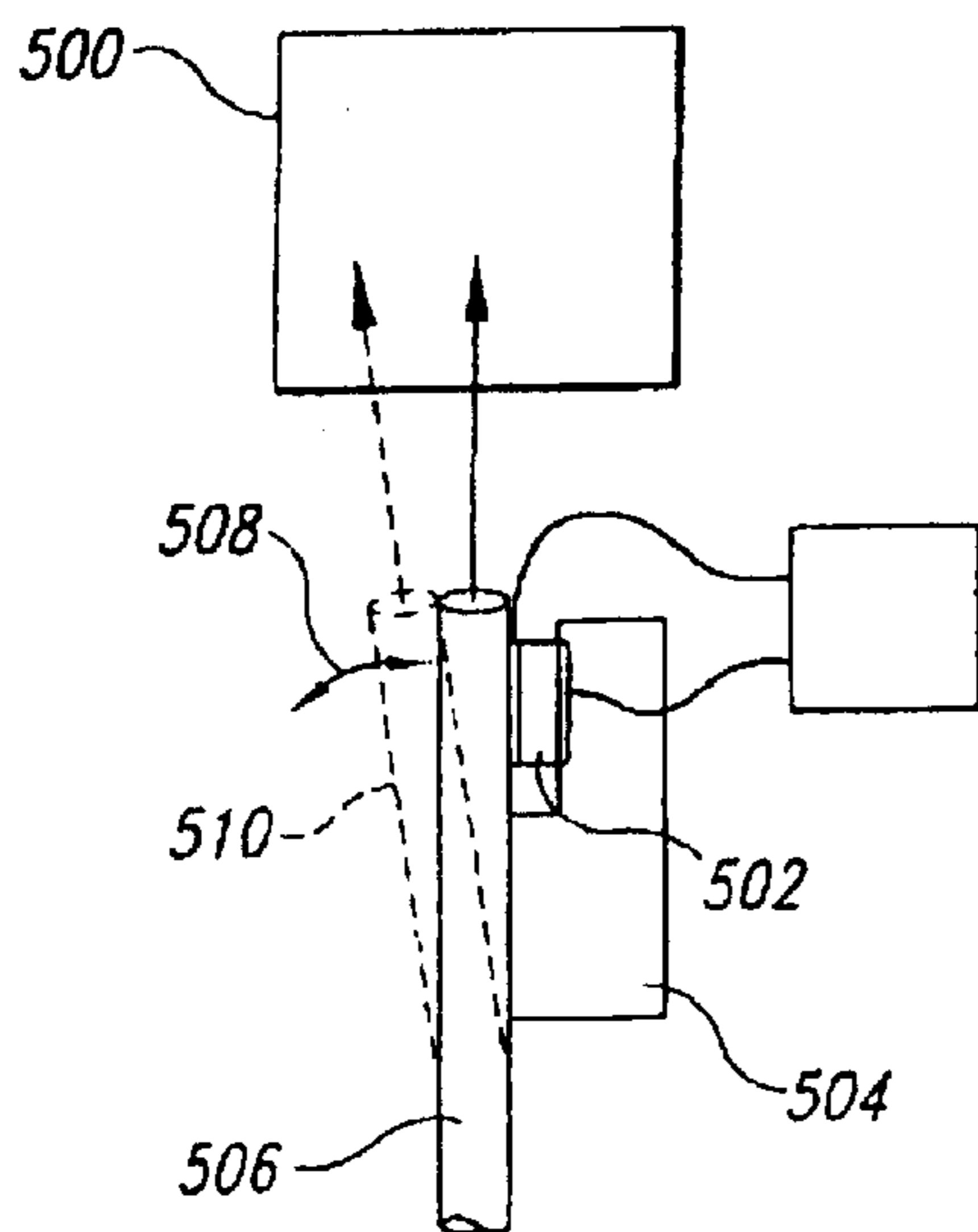


Fig. 22

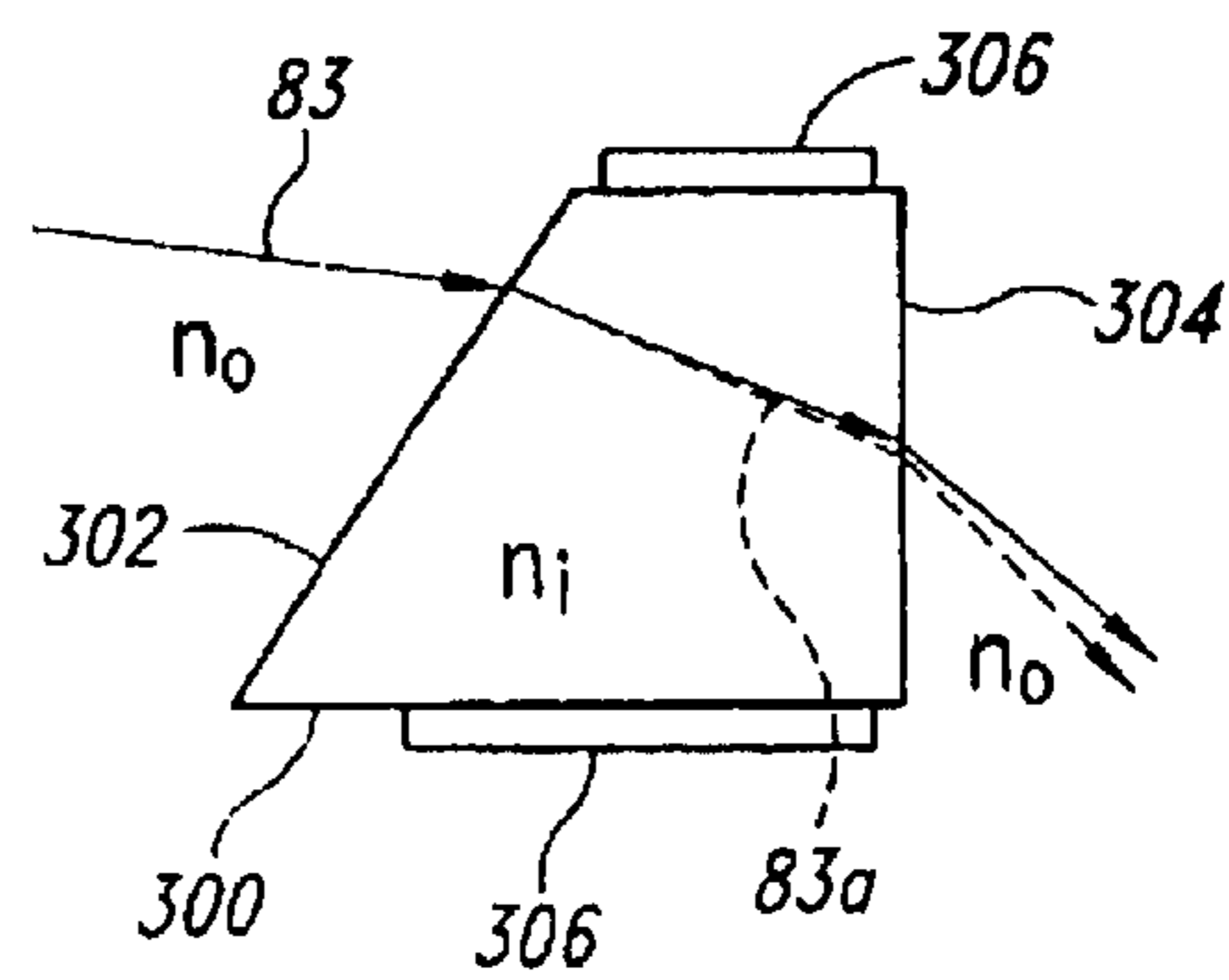


Fig. 23

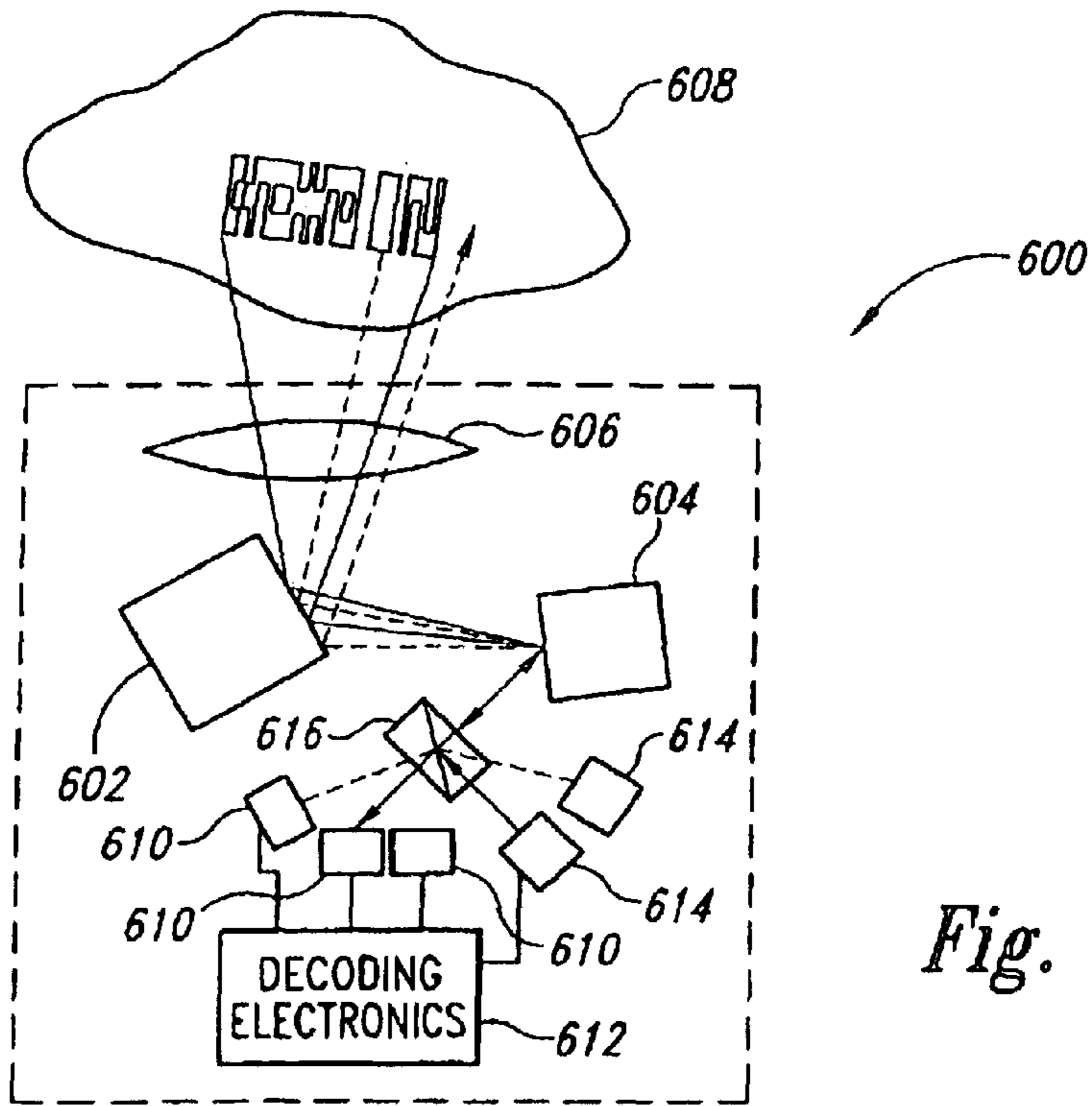


Fig. 24

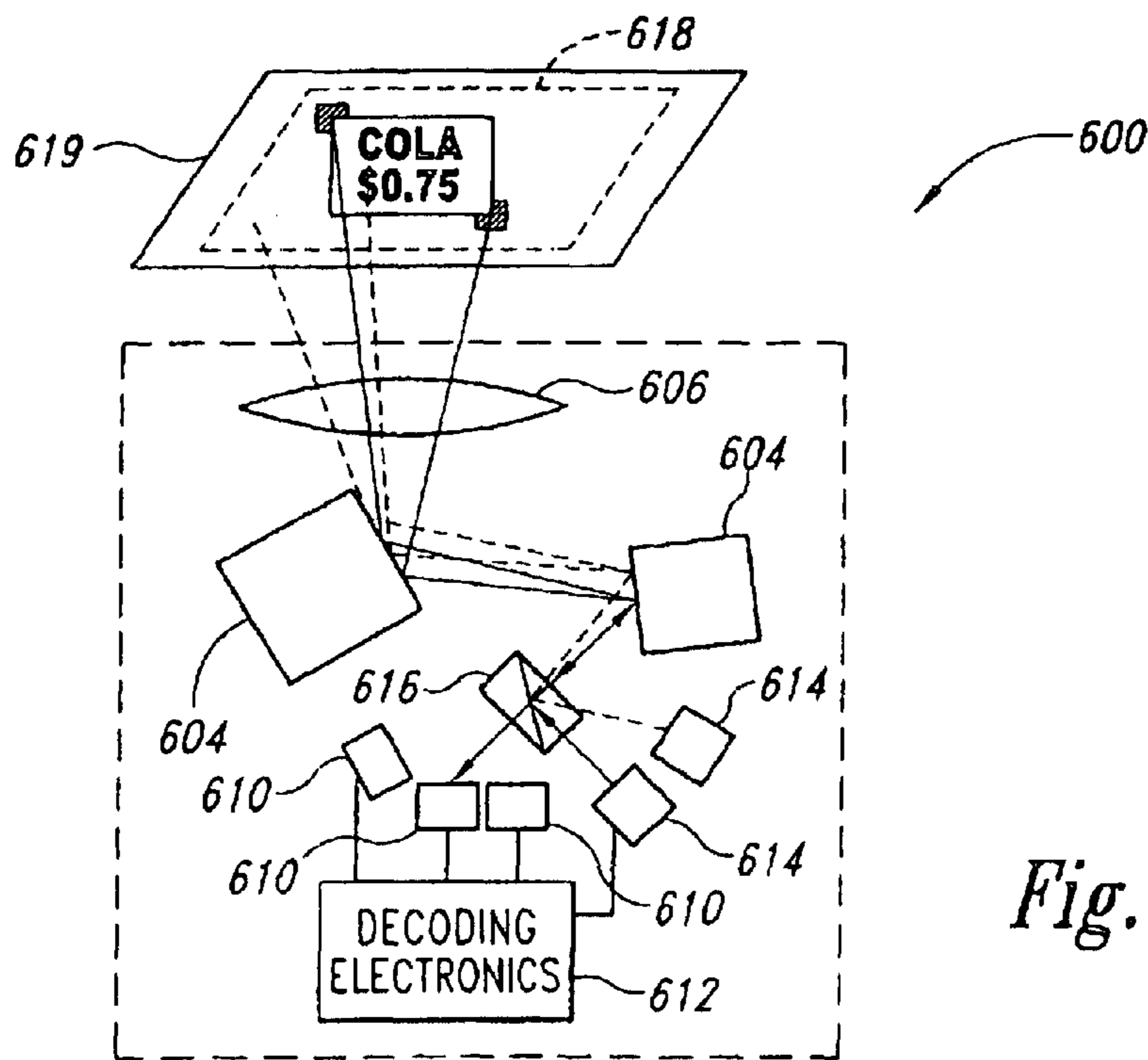


Fig. 25

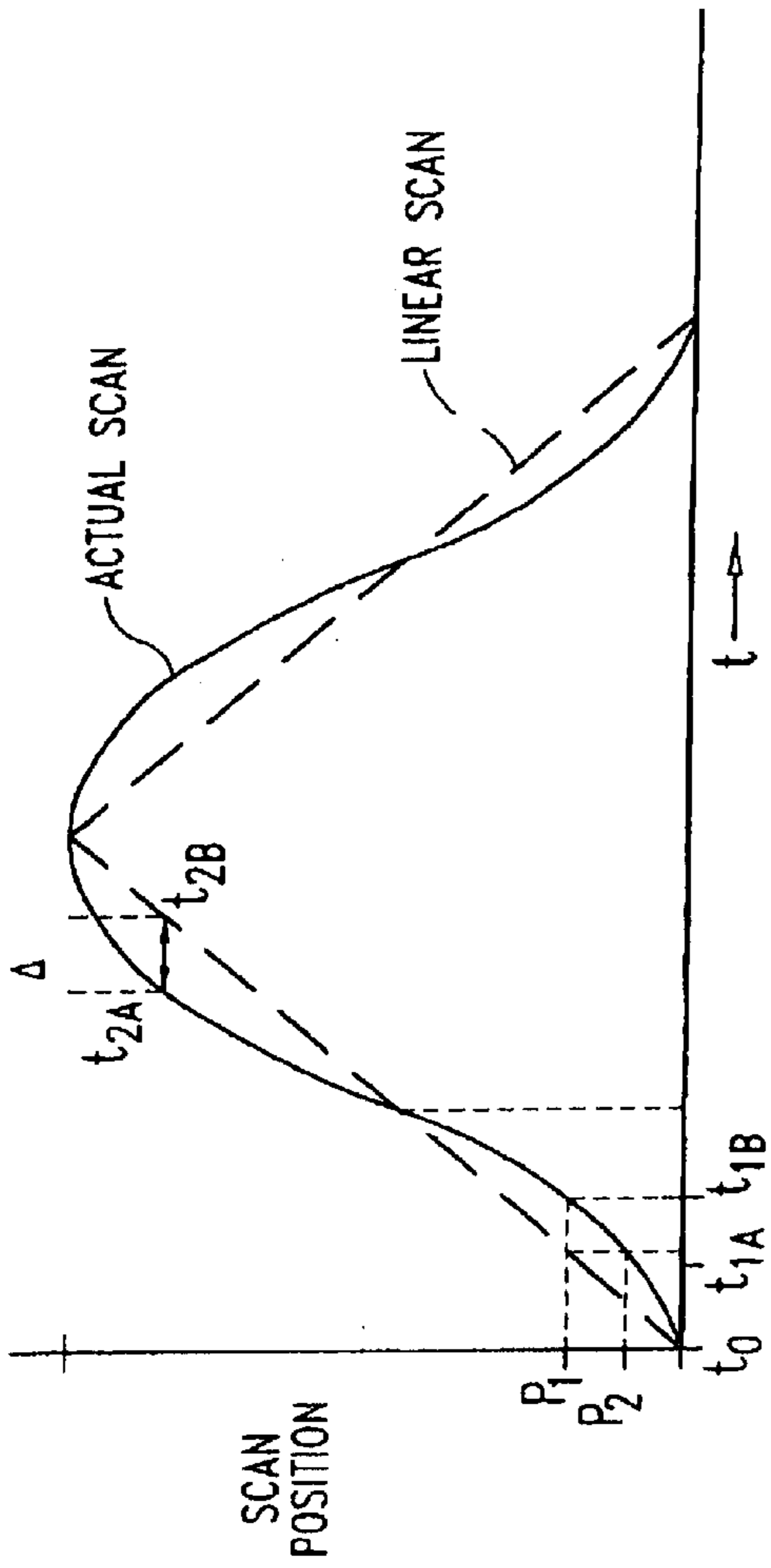


Fig. 26

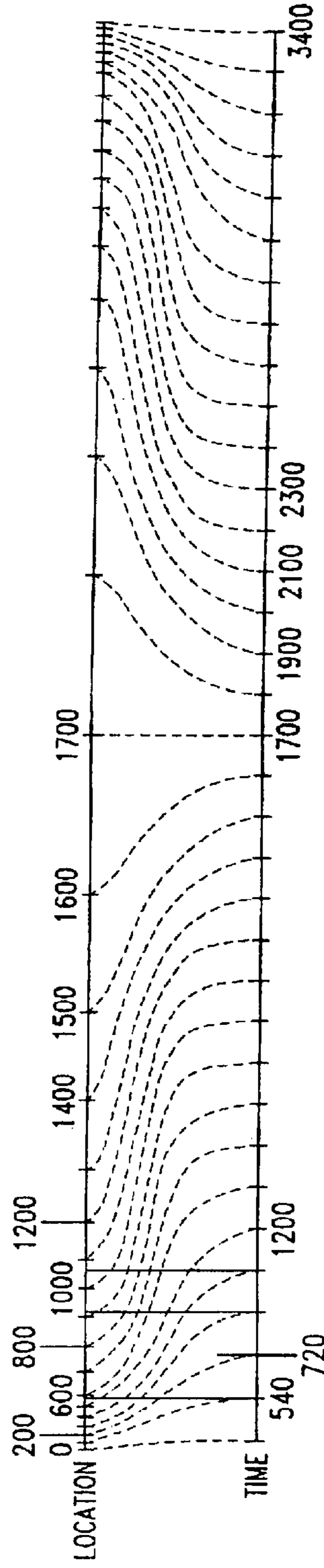


Fig. 27

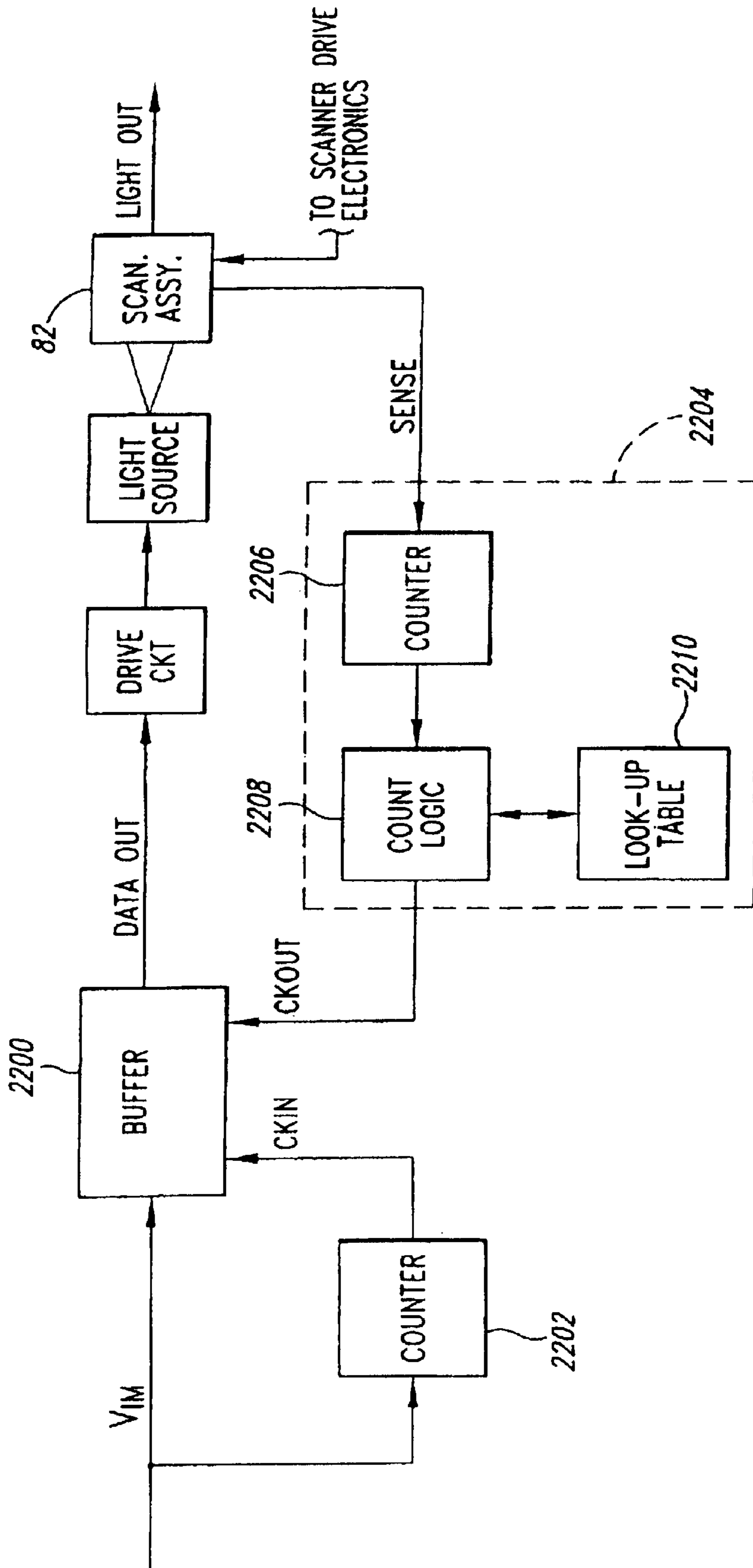


Fig. 28

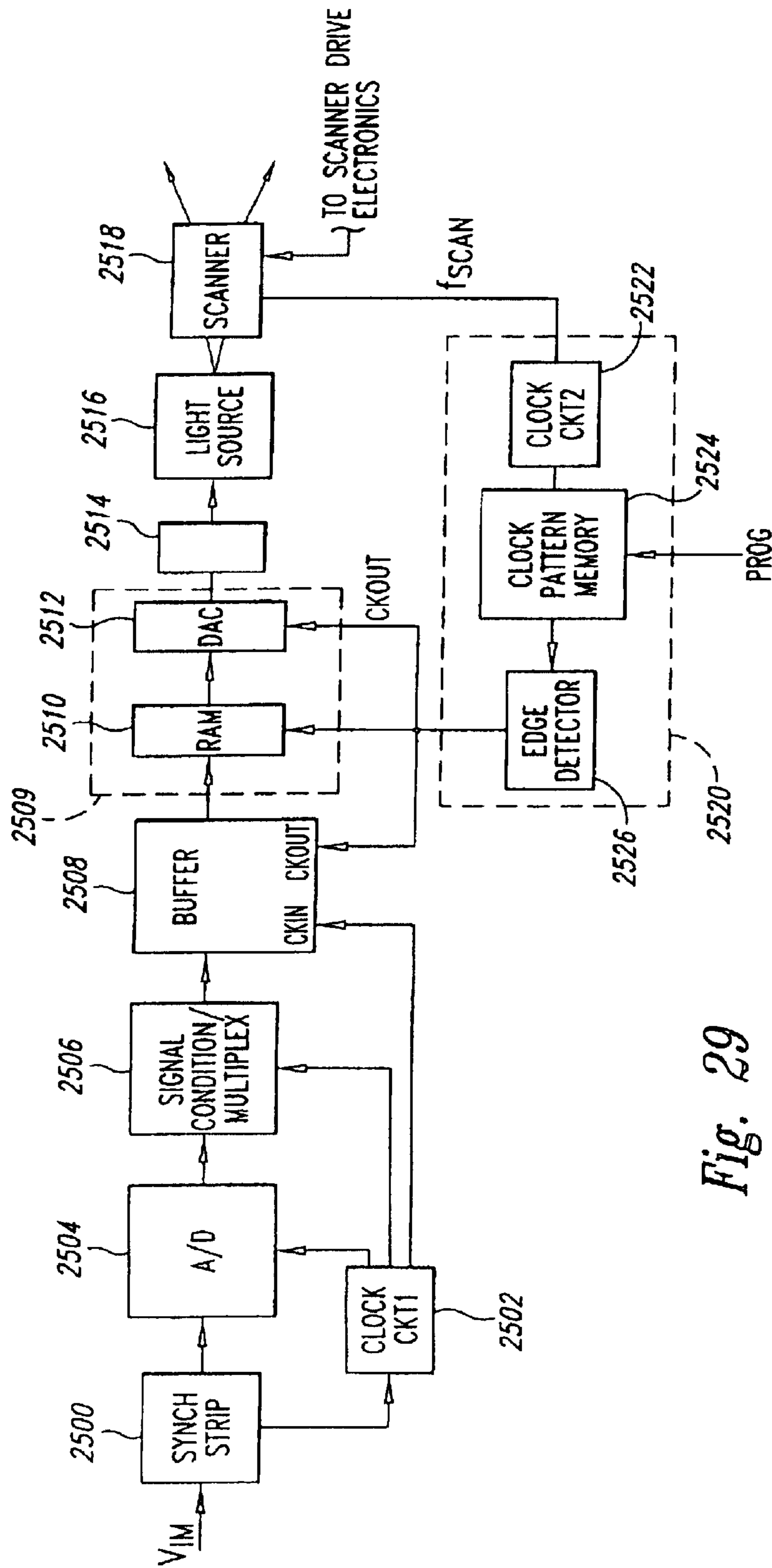


Fig. 29

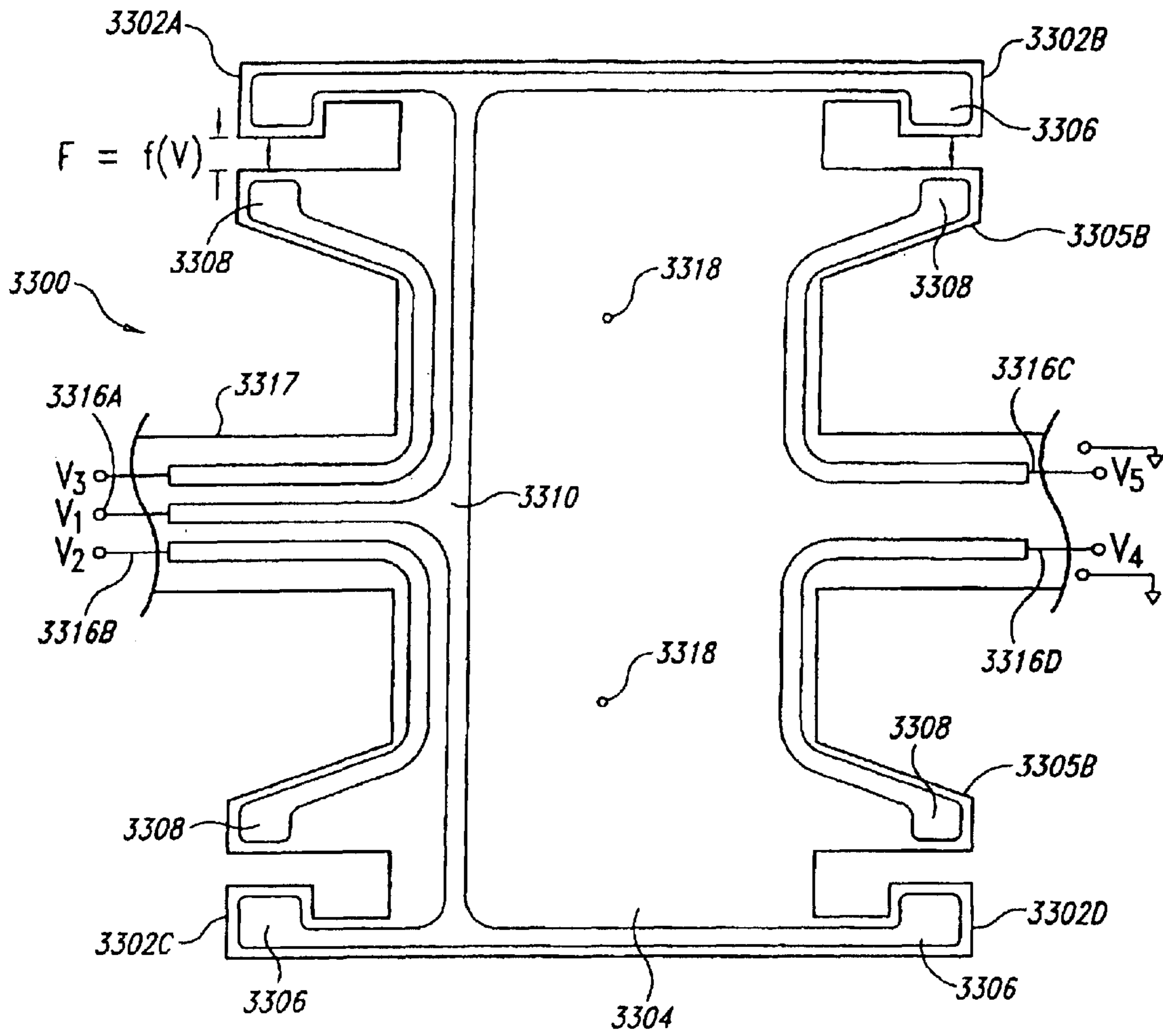


Fig. 33

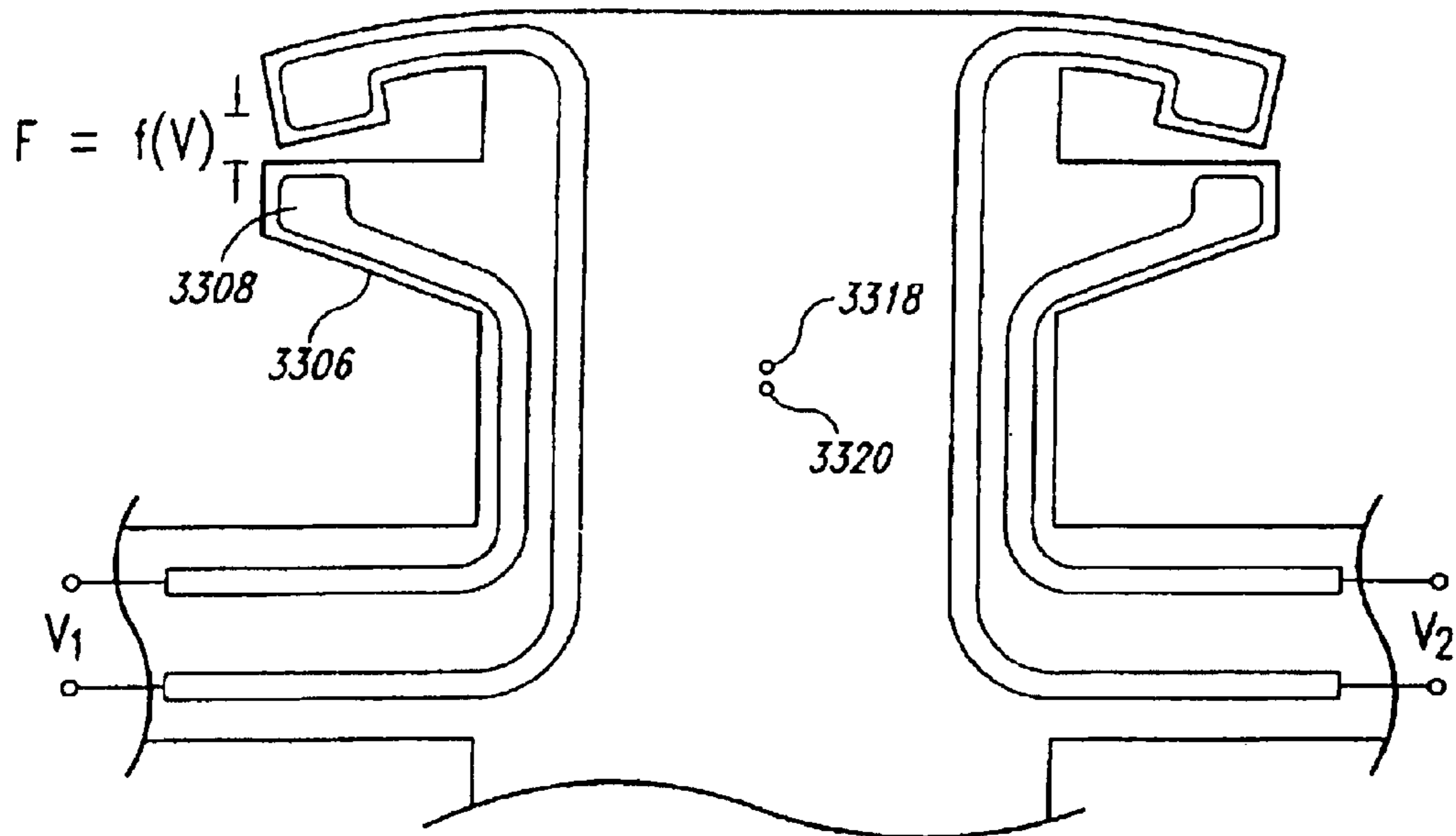


Fig. 34

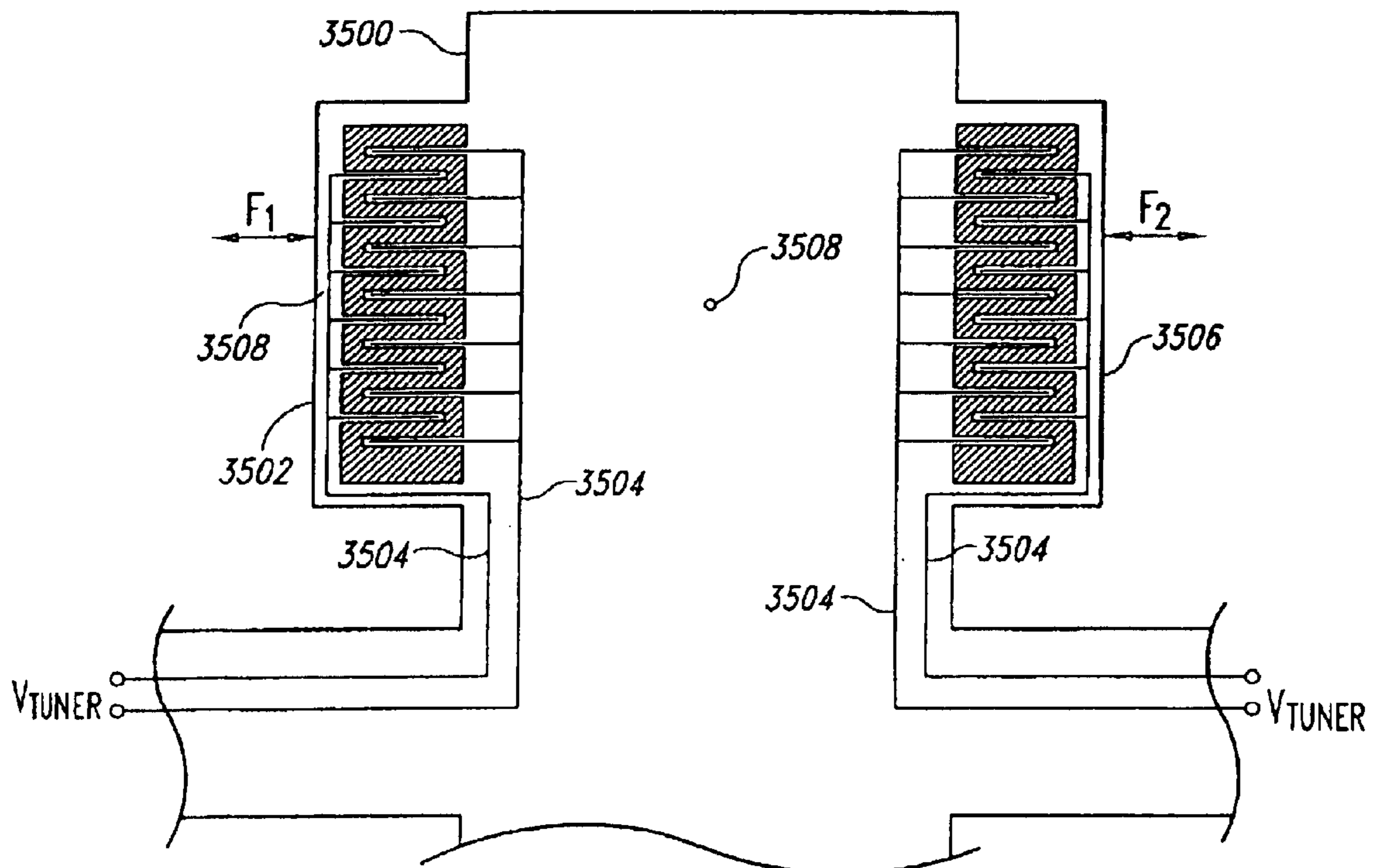


Fig. 35

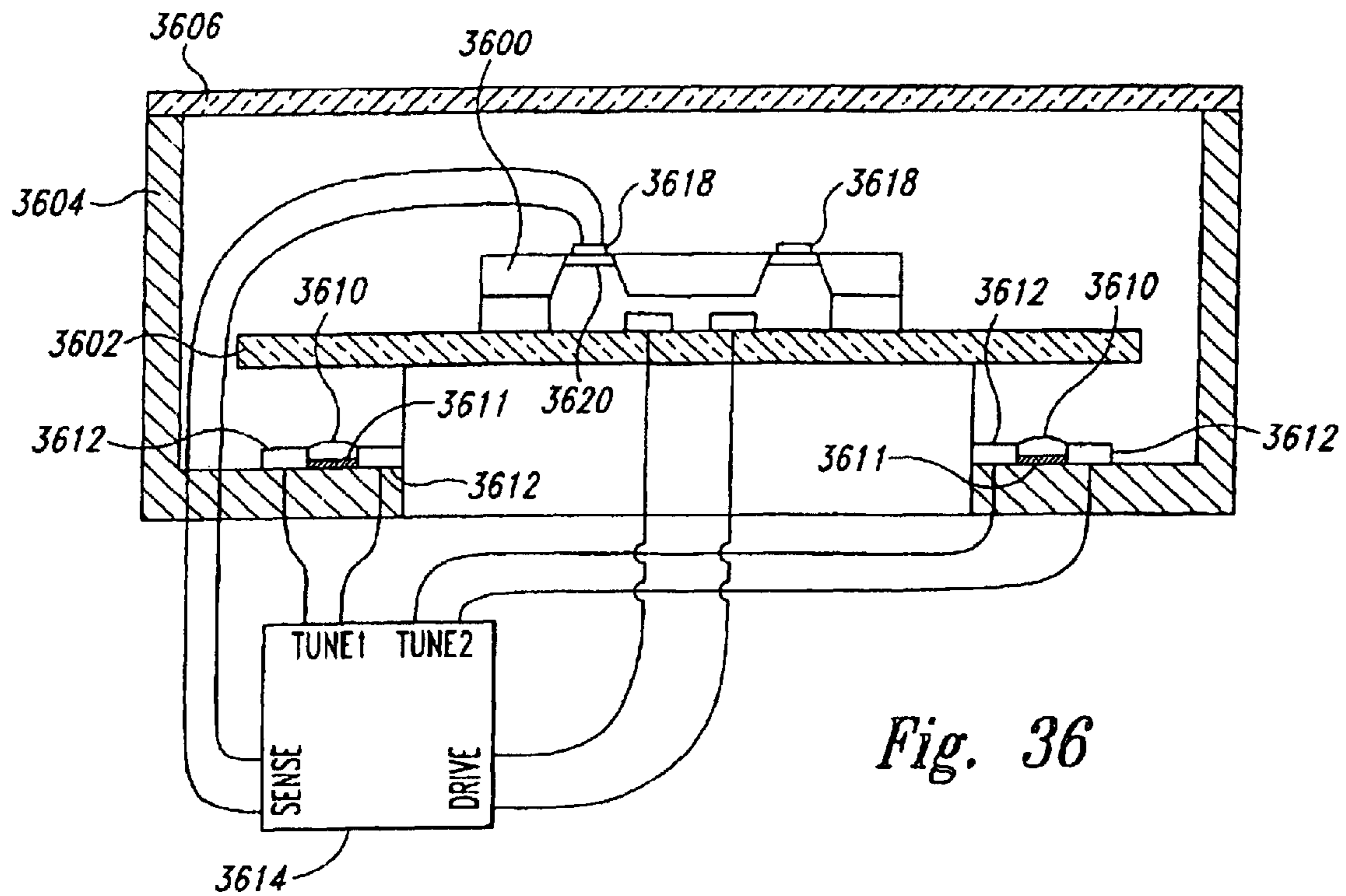


Fig. 36

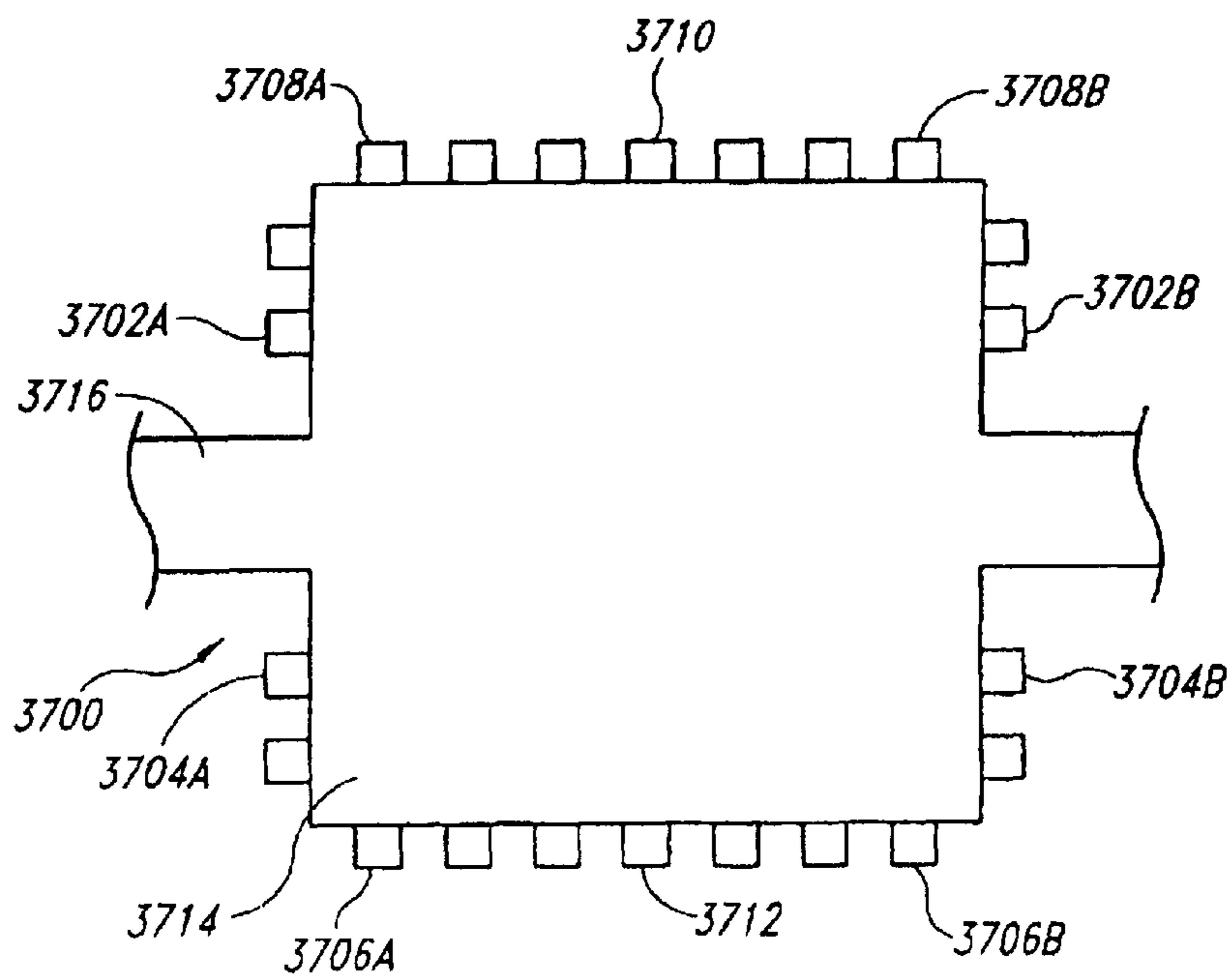


Fig. 37

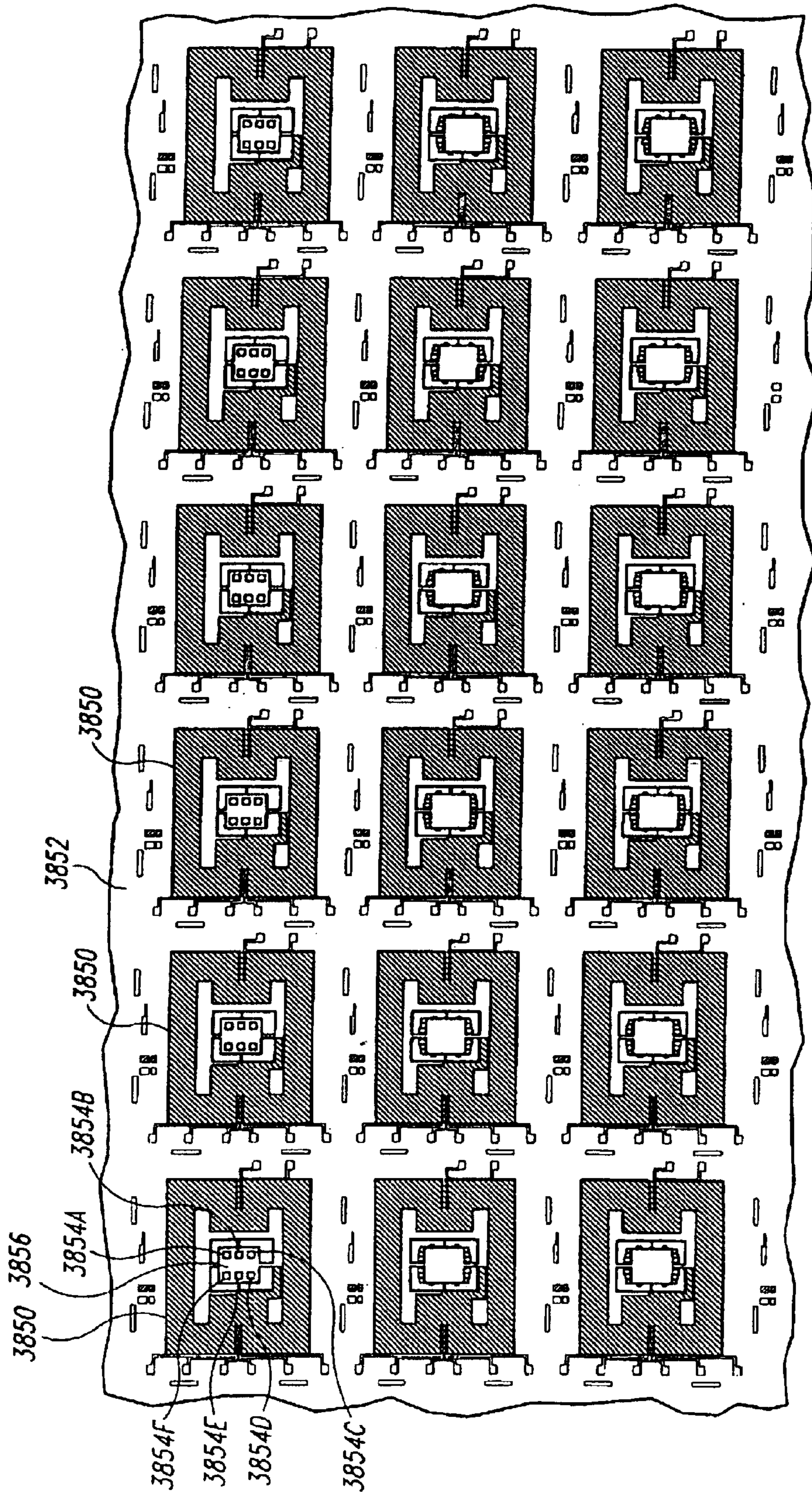


Fig. 38A

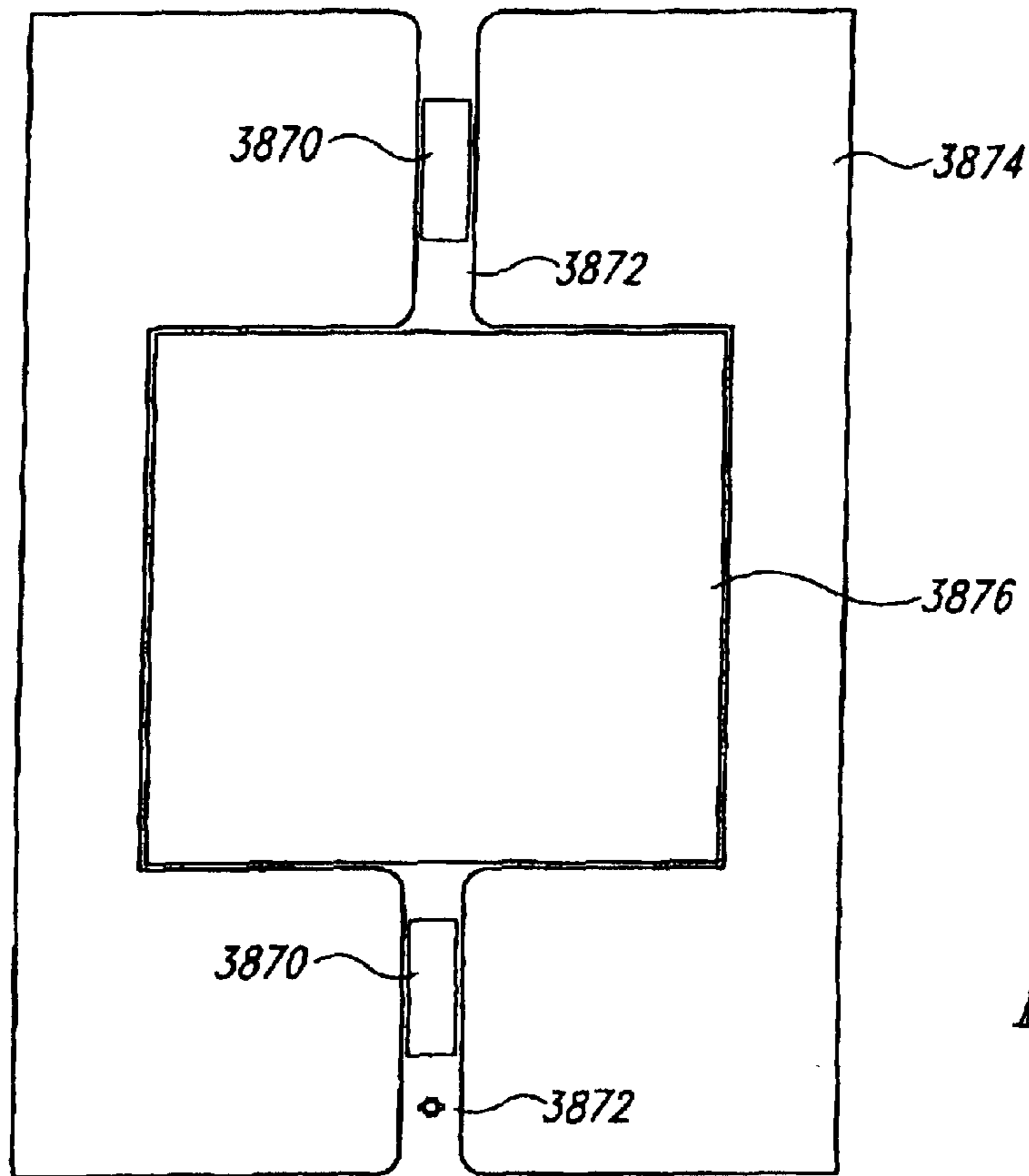


Fig. 38B

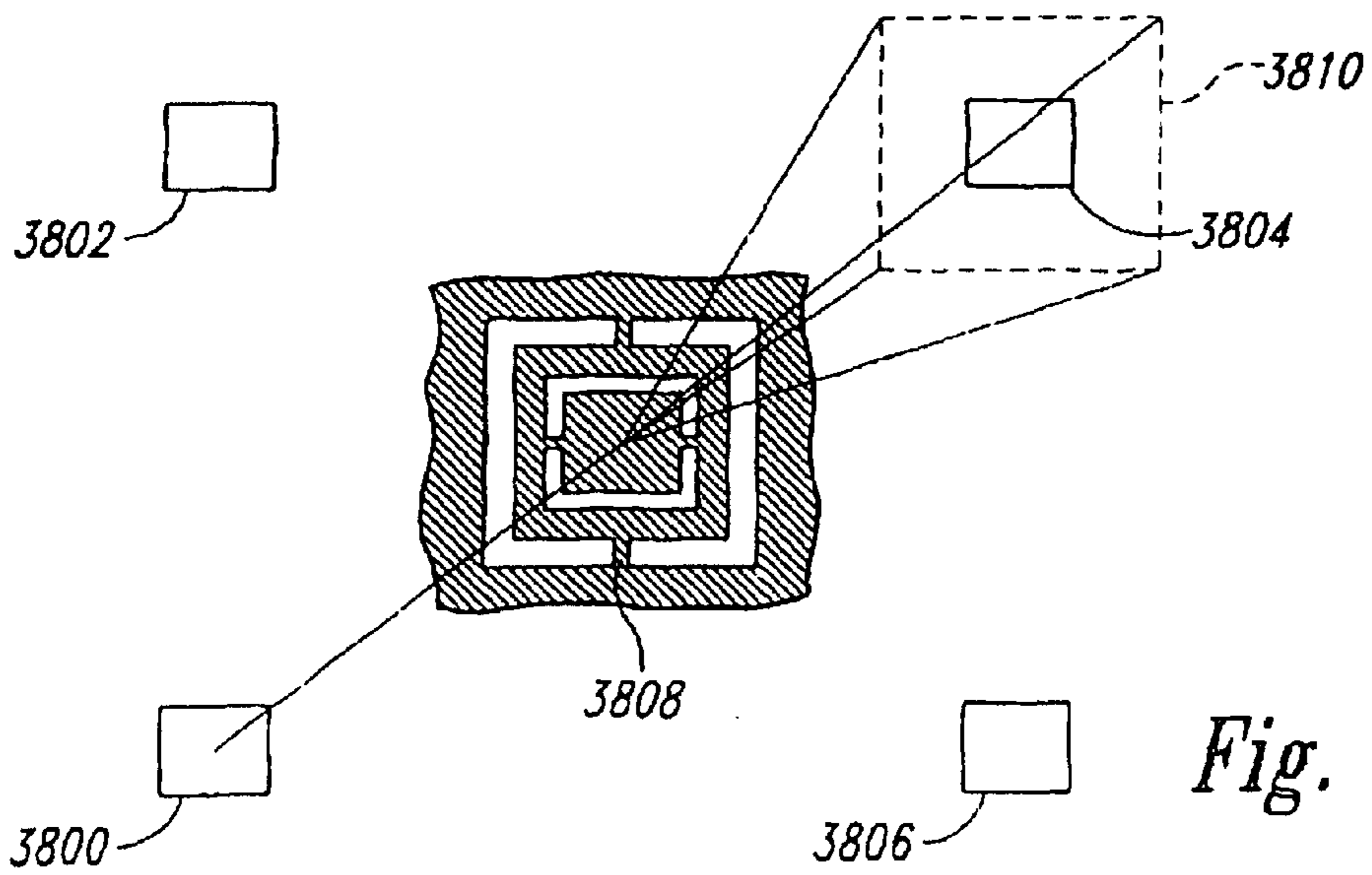


Fig. 39

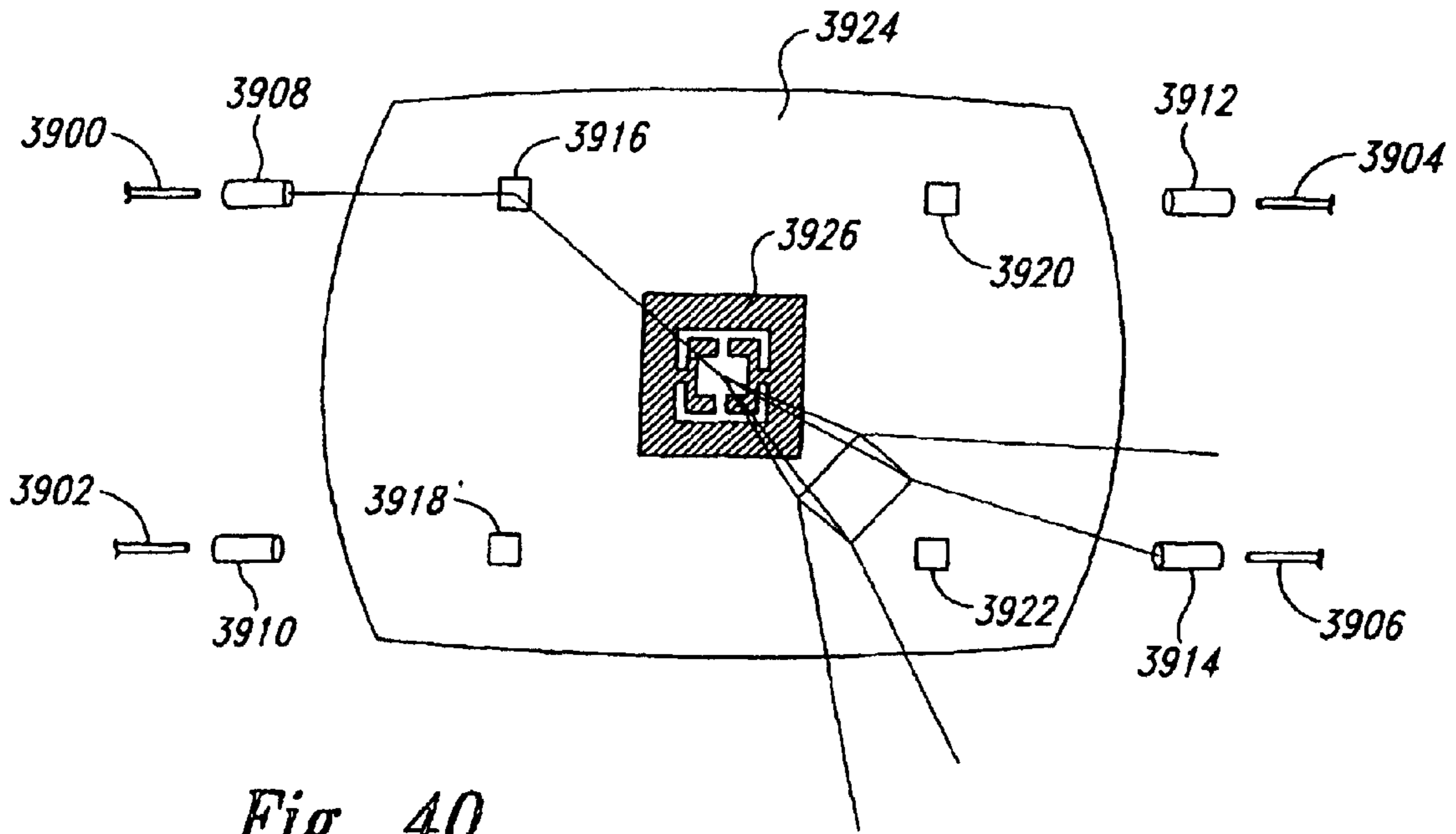


Fig. 40

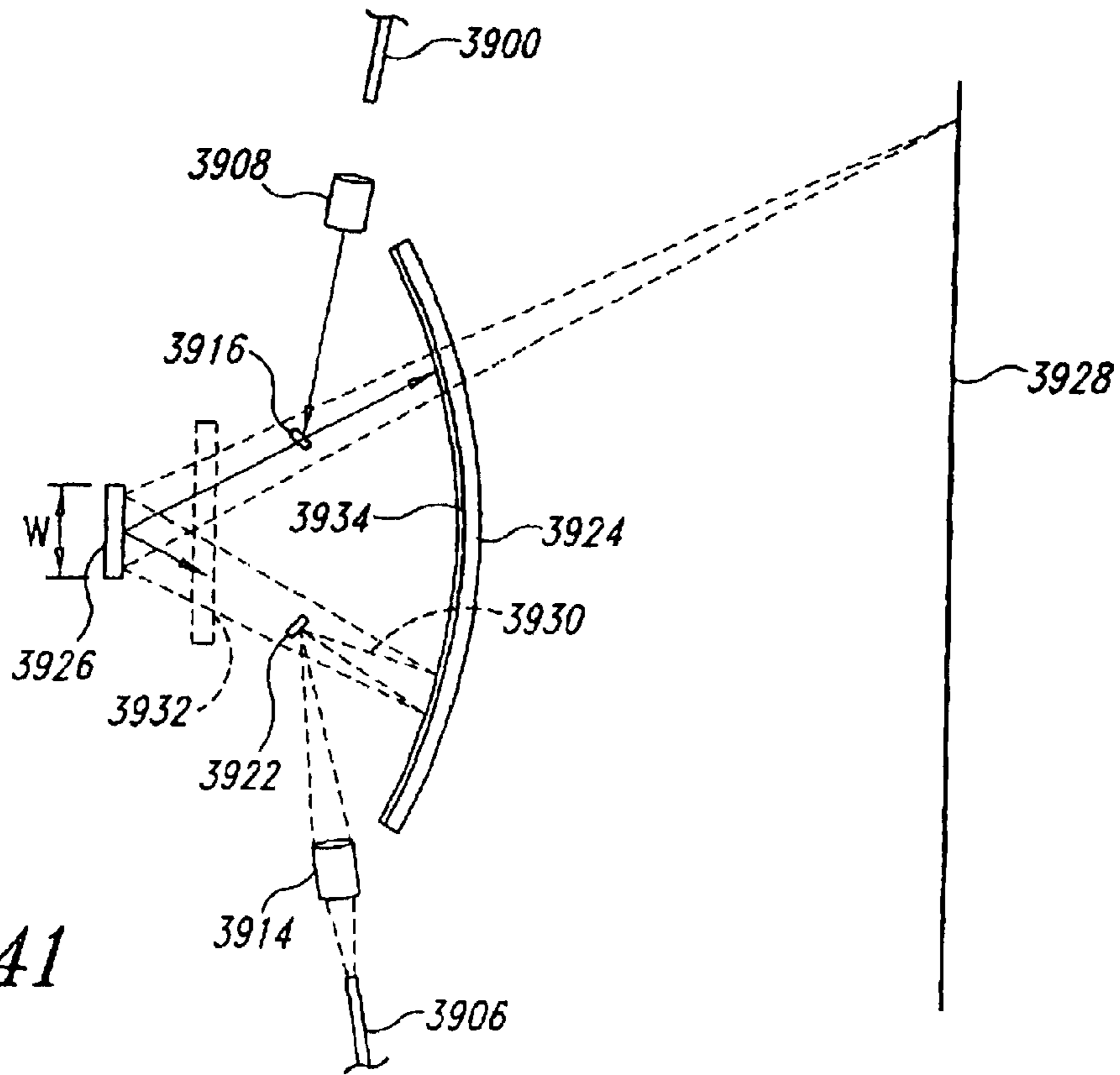
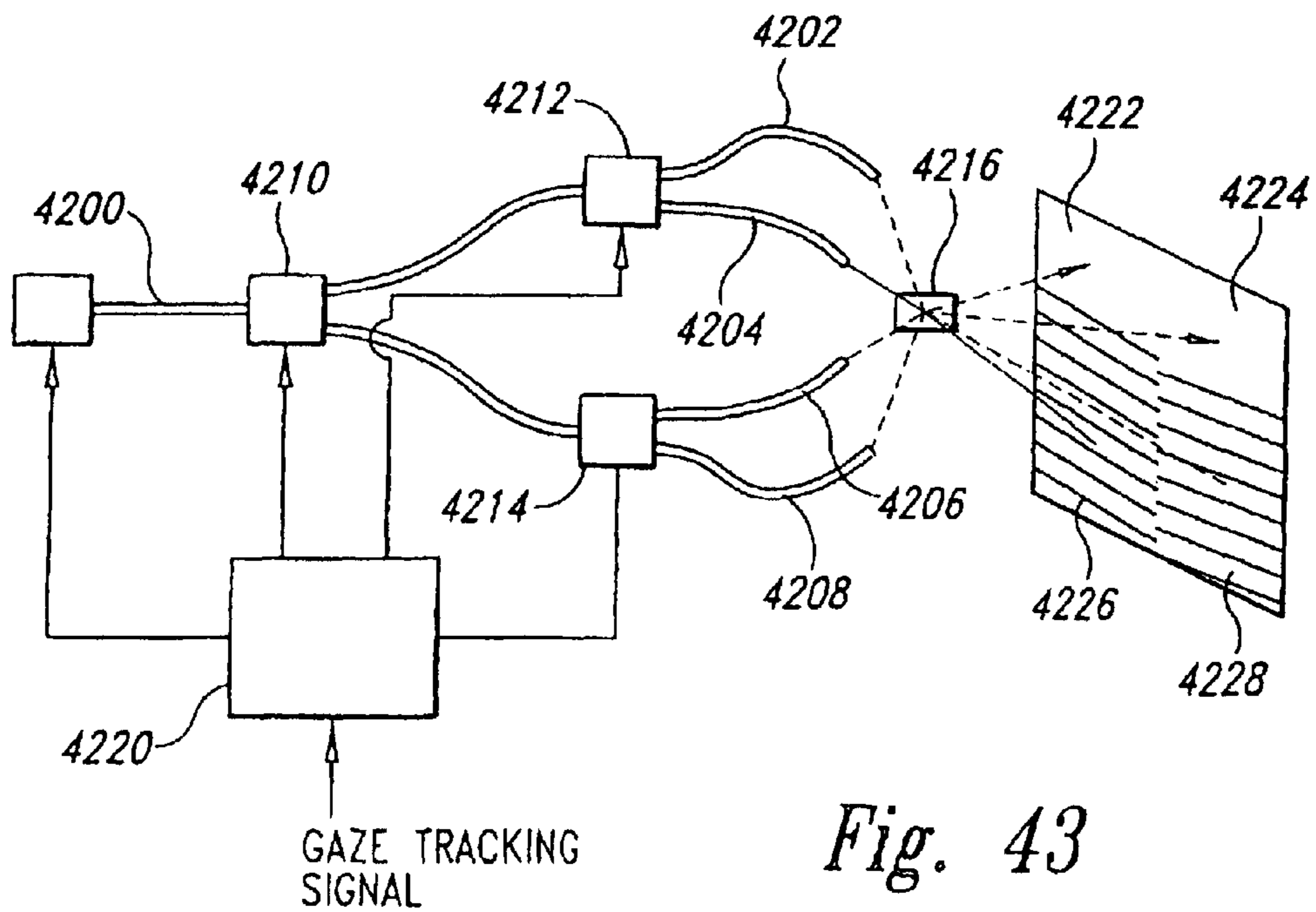
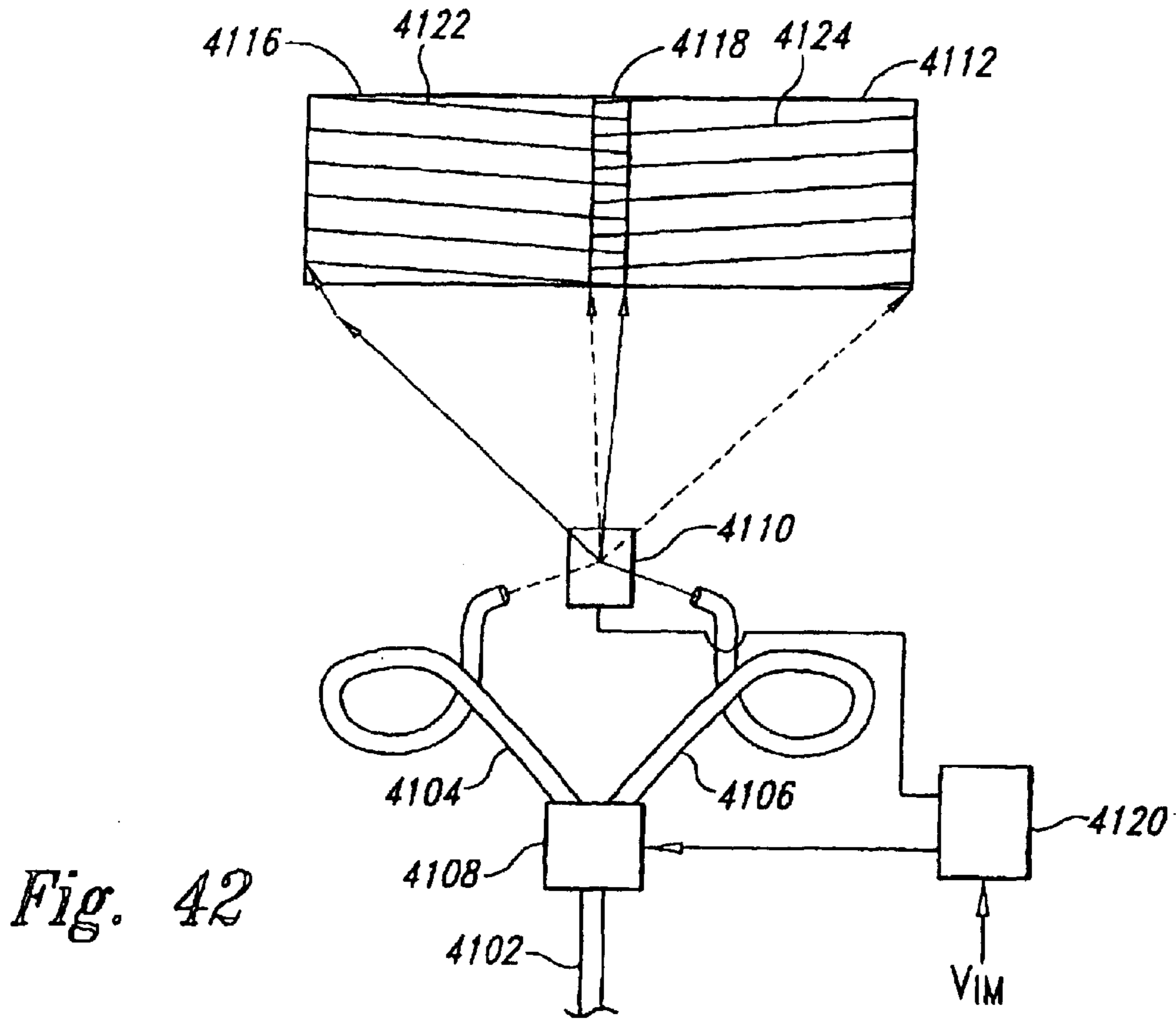


Fig. 41



FREQUENCY TUNABLE RESONANT SCANNER AND METHOD OF MAKING

Matter enclosed in heavy brackets [] appears in the original patent but forms no part of this reissue specification; matter printed in italics indicates the additions made by reissue.

CROSS REFERENCE TO RELATED APPLICATIONS

This application is *reissue of U.S. patent application Ser. No. 10/304,724, filed on Nov. 25, 2002, now U.S. Pat. No. 6,653,621; which is a division of U.S. patent application Ser. No. 09/816,809 filed Mar. 23, 2001, now U.S. Pat. No. 6,515,278; which is a division of U.S. patent application Ser. No. 09/369,674, filed Aug. 5, 1999, now U.S. Pat. No. 6,245,590.*

TECHNICAL FIELD

The present invention relates to scanned light devices and, more particularly, to scanned light beam displays and imaging devices for viewing or collecting images.

BACKGROUND OF THE INVENTION

A variety of techniques are available for providing visual displays of graphical or video images to a user. In many applications cathode ray tube type displays (CRTs), such as televisions and computer monitors produce images for viewing. Such devices suffer from several limitations. For example, CRTs are bulky and consume substantial amounts of power, making them undesirable for portable or head-mounted applications.

Matrix addressable displays, such as liquid crystal displays and field emission displays, may be less bulky and consume less power. However, typical matrix addressable displays utilize screens that are several inches across. Such screens have limited use in head mounted applications or in applications where the display is intended to occupy only a small portion of a user's field of view. Such displays have been reduced in size, at the cost of increasingly difficult processing and limited resolution or brightness. Also, improving resolution of such displays typically requires a significant increase in complexity.

One approach to overcoming many limitations of conventional displays is a scanned beam display, such as that described in U.S. Pat. No. 5,467,104 of Furness et al., entitled VIRTUAL RETINAL DISPLAY, which is incorporated herein by reference. As shown diagrammatically in FIG. 1, in one embodiment of a scanned beam display 40, a scanning source 42 outputs a scanned beam of light that is coupled to a viewer's eye 44 by a beam combiner 46. In some scanned displays, the scanning source 42 includes a scanner, such as scanning mirror or acousto-optic scanner, that scans a modulated light beam onto a viewer's retina. In other embodiments, the scanning source may include one or more light emitters that are rotated through an angular sweep.

The scanned light enters the eye 44 through the viewer's pupil 48 and is imaged onto the retina 59 by the cornea. In response to the scanned light the viewer perceives an image. In another embodiment, the scanned source 42 scans the modulated light beam onto a screen that the viewer observes. One example of such a scanner suitable for either type of display is described in U.S. Pat. No. 5,557,444 to Melville et al., entitled MINIATURE OPTICAL SCANNER FOR A

TWO-AXIS SCANNING SYSTEM, which is incorporated herein by reference.

Sometimes such displays are used for partial or augmented view applications. In such applications, a portion of the display is positioned in the user's field of view and presents an image that occupies a region 43 of the user's field of view 45, as shown in FIG. 2A. The user can thus see both a displayed virtual image 47 and background information 49. If the background light is occluded, the viewer perceives only the virtual image 47, as shown in FIG. 2B.

One difficulty that may arise with such displays is raster pinch, as will now be explained with reference to FIGS. 3-5. As shown diagrammatically in FIG. 3, the scanning source 42 includes an optical source 50 that emits a beam 52 of modulated light. In this embodiment, the optical source 50 is an optical fiber that is driven by one or more light emitters, such as laser diodes (not shown). A lens 53 gathers and focuses the beam 52 so that the beam 52 strikes a turning mirror 65 and is directed toward a horizontal scanner 56. The horizontal scanner 56 is a mechanically resonant scanner that scans the beam 52 periodically in a sinusoidal fashion. The horizontally scanned beam then travels to a vertical scanner 58 that scans periodically to sweep the horizontally scanned beam vertically. For each angle of the beam 52 from the scanners 58, an exit pupil expander 62 converts the beam 52 into a set of beams 63. Eye coupling optics 60 collect the beams 63 and form a set of exit pupils 65. The exit pupils 65 together act as an expanded exit pupil for viewing by a viewer's eye 64. One such expander is described in U.S. Pat. No. 5,701,132 of Kollin et al., entitled VIRTUAL RETINAL DISPLAY WITH EXPANDED EXIT PUPIL, which is incorporated herein by reference. One skilled in the art will recognize that, for differing applications, the exit pupil expander 62 may be omitted, may be replaced or supplemented by an eye tracking system, or may have a variety of structures, including diffractive or refractive designs. For example, the exit pupil expander 62 may be a planar or curved structure and may create any number or pattern of output beams in a variety of patterns. Also, although only three exit pupils are shown in FIG. 3, the number of pupils may be almost any number. For example, in some applications a 15 by 15 array may be suitable.

Returning to the description of scanning, as the beam scans through each successive location in the beam expander 62, the beam color and intensity is modulated in a fashion to be described below to form a respective pixel of an image. By properly controlling the color and intensity of the beam for each pixel location, the display 40 can produce the desired image.

Simplified versions of the respective waveforms of the vertical and horizontal scanners are shown in FIG. 4. In the plane 66 (FIG. 3), the beam traces the pattern 68 shown in FIG. 5. Though FIG. 5 shows only eleven lines of image, one skilled in the art will recognize that the number of lines in an actual display will typically be much larger than eleven. As can be seen by comparing the actual scan pattern 68 to a desired raster scan pattern 69, the actual scanned beam 68 is "pinched" at the outer edges of the beam expander 62. That is, in successive forward and reverse sweeps of the beam, the pixels near the edge of the scan pattern are unevenly spaced. This uneven spacing can cause the pixels to overlap or can leave a gap between adjacent rows of pixels. Moreover, because the image information is typically provided as an array of data, where each location in the array corresponds to a respective position in the ideal raster pattern 69, the displaced pixel locations can cause image distortion.

For a given refresh rate and a given wavelength, the number of pixels per line is determined in the structure of FIG. 3 by the mirror scan angle θ and mirror dimension D perpendicular to the axis of rotation. For high resolution, it is therefore desirable to have a large scan angle θ and a large mirror. However, larger mirrors and scan angles typically correspond to lower resonant frequencies. A lower resonant frequency provides fewer lines of display for a given period. Consequently, a large mirror and larger scan angle may produce unacceptable refresh rates.

One skilled in the art will recognize that scanning is an important function in such displays and in many other applications. For many applications it is desirable to have a small, high-performance, reliable scanning apparatus.

SUMMARY OF THE INVENTION

A display includes a primary scanning mechanism that simultaneously scans beams of light. In one embodiment of a display according to the invention, the scanning mechanism scans the beams along substantially continuous scan paths where each beam defines a discrete "tile" of an image. In the preferred embodiment, the scanning mechanism includes a mirror that pivots to sweep the beams horizontally.

In this tiled embodiment, optical sources are aligned to provide the beams of light to the scanning mechanism from respective input angles. The input angles are selected such that the scanning mechanism sweeps each beam of light across a respective distinct region of an image field. Because the respective regions are substantially non-overlapping, each beam of light generates a substantially spatially distinct region of the image. The respective regions are immediately adjacent or may overlap slightly, so that the spatially distinct regions are "tiled" to form a contiguous image. Because movement of the mirror produces movement of all of the beams, the display produces each of the spatially separate regions simultaneously. As described above, the scan angle θ and the mirror dimensions determine the number of pixels drawn for each beam. The total number of pixels in a line can thus substantially equal the number of pixels for each beam multiplied by the number of beams.

In one embodiment, the scanning mechanism scans in a generally raster pattern with a horizontal component and a vertical component. A mechanically resonant scanner produces the horizontal component by scanning the beam sinusoidally. A non-resonant or semi-resonant scanner typically scans the beam vertically with a substantially constant angular speed.

In one embodiment, the scanning mechanism includes a biaxial microelectromechanical (MEMs) scanner. The biaxial scanner uses a single mirror to provide both horizontal and vertical movement of each of the beams. In one embodiment, the display includes a buffer that stores data and outputs the stored data to each of the optical sources. A correction multiplier provides correction data that adjusts the drive signals to the optical sources in response to the stored data. The adjusted drive signals compensate for variations in output intensity caused by pattern dependent heating.

In one embodiment, the MEMs scanner is a resonant scanner that has a characteristic resonant frequency. Where the resonant frequency does not match the rate at which image data is supplied, data may be clocked into and out of the buffer at different rates.

In another embodiment of the MEMs scanner, the MEMs scanner may have a tunable resonant frequency that can be

adjusted to conform to the rate at which image data is provided. In one embodiment of such a MEMs scanner, a primary oscillatory body carries secondary masses that can be removed or added to, thereby shifting the amount of mass pivoting about a scan axis. The shifting amount of mass changes the resonant frequency and can be established by laser ablation, or other mass removal or addition techniques. By monitoring movement of the oscillatory body and comparing the monitored movement to the desired scanning frequency, a control circuit can control an automated fabrication system to tune several MEMs scanner.

In another embodiment of an actively tunable MEMs scanner, a torsion arm supports the oscillatory body and includes a migratory material. The torsion arms absorb the migratory material in response to heat or other stimuli and change their mechanical properties as the material migrates. Because the mechanical properties of the torsion arm affect the resonant frequency, the resonant frequency can be established by controlling the amount of migration.

In one embodiment, an imager acquires images in tiles by utilizing two separate detector and optical source pairs. One embodiment of the imager includes LEDs or lasers as the optical sources, where each of the optical sources is at a respective wavelength. The scanning assembly simultaneously directs light from each of the optical sources to respective regions of an image field. For each location in the image field, each of the detectors selectively detects light at the wavelength, polarization, or other characteristic of its corresponding source, according to the reflectivity of the respective location. The detectors output electrical signals to decoding electronics that store data representative of the image field.

In one embodiment, the imager includes a plurality of detector/optical source pairs at each of red, green, and blue wavelength bands. Each pair operates at a respective wavelength within its band. For example, a first of the red pairs operates at a first red wavelength and a second of the red pairs operates at a second red wavelength different from the first.

In one embodiment, a pair of optical sources alternately feed a single scanner from different angles. During forward sweeps of the scanner, a first of the sources emits light modulated according to one half of a line. During the return sweep, the second source emits light modulated according to the second half of the line. Because the second sweep is in the opposite direction from the first, data corresponding to the second half of the line is reversed before being applied to the second source so that light from the second source is modulated to write the second half of the line in reverse.

In one embodiment of the alternate feeding approach, a single light emitter feeds an input fiber that is selectively coupled to one of two separate fibers by an optical switch. During forward sweeps, the optical switch couples the input fiber to a first of the separate fibers so that the first separate fiber forms the first optical source. During reverse sweep, the optical switch feeds the second separate fiber so that the second separate fiber forms the second source. This embodiment thus allows a single light emitter to provide light for both optical sources.

The alternate feeding approach can be expanded to write more than just two tiles. In one approach, the input fiber is coupled to four fibers by a set of optical switches, where each fiber feeds the scanning assembly from a respective angle. The switches are activated according to the direction of the sweep and according to the tracked location of the user's vision. For example, when the user looks at the top

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half of the image, a first fiber, aligned to produce an image in the upper left tile feeds the scanner during the forward sweeps. A second fiber, aligned to produce an upper right tile feeds the scanner during reverse sweeps. When the user looks at the lower half of the image, a third fiber, aligned to produce the lower left tile, feeds scanner during forward sweeps. A fourth fiber, aligned to produce the lower right tile, feeds the scanner during reverse sweeps.

BRIEF DESCRIPTION OF THE FIGURES

FIG. 1 is a diagrammatic representation of a display aligned to a viewer's eye.

FIG. 2A is a combined image perceived by a user resulting from the combination of light from an image source and light from a background.

FIG. 2B is an image perceived by a user from the display of FIG. 1 where the background light is occluded.

FIG. 3 is a diagrammatic representation of a scanner and a user's eye showing bi-directional scanning of a beam and coupling to the viewer's eye.

FIG. 4 is a signal-timing diagram of a scan pattern scanner in the scanning assembly of FIG. 3.

FIG. 5 is a signal position diagram showing the path followed by the scanned beam in response to the signals of FIG. 4, as compared to a desired raster scan path.

FIG. 6 is a diagrammatic representation of a display according to the one embodiment invention including dual light beams.

FIG. 7 is an isometric view of a head-mounted scanner including a tether.

FIG. 8 is a diagrammatic representation of a scanning assembly within the scanning display of FIG. 6, including a correction mirror.

FIG. 9 is an isometric view of a horizontal scanner and a vertical scanner suitable for use in the scanning assembly of FIG. 8.

FIG. 10 is a diagrammatic representation of scanning with two input beams, showing slightly overlapped tiles.

FIG. 11 is a top plan view of a biaxial scanner showing four feeds at spatially separated locations.

FIG. 12 is a diagrammatic representation of four tiles produced by the four feed scanner of FIG. 11.

FIG. 13 is a schematic of a system for driving the four separate feeds of FIG. 11, including four separate buffers.

FIG. 14 is a signal-timing diagram comparing a ramp signal with a desired signal for driving the vertical scanner.

FIG. 15 is a signal timing diagram showing positioning error and correction for the vertical scanning position.

FIG. 16 is a side cross sectional view of a piezoelectric correction scanner.

FIG. 17A is a top plan view of a microelectromechanical (MEMs) correction scanner.

FIG. 17B is a side cross-sectional view of the MEMs correction scanner of FIG. 17A showing capacitive plates and their alignment to the scanning mirror.

FIG. 18 shows corrected scan position using a sinusoidally driven scanner through 90% of the overall scan.

FIG. 19 shows an alternative embodiment of a reduced error scanner where scan correction is realized by adding a vertical component to the horizontal mirror.

FIG. 20 is a position diagram showing the scan path of a beam deflected by the scanner of FIG. 19.

FIG. 21 is a diagrammatic view of a scanning system, including a biaxial microelectromechanical (MEMs) scanner and a MEMs correction scanner.

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FIG. 22 is a diagrammatic view of a correction scanner that shifts an input beam by shifting the position or angle of the input fiber.

FIG. 23 is a diagrammatic view of a correction scanner that includes an electro-optic crystal that shifts the input beam in response to an electrical signal.

FIG. 24 is a diagrammatic view of an imager that acquires external light from a target object.

FIG. 25 is a diagrammatic view of an alternative embodiment of the imager of FIG. 24 that also projects a visible image.

FIG. 26 is a signal timing diagram showing deviation of a sinusoidal scan position versus time from the position of a linear scan.

FIG. 27 is a diagram showing diagrammatically how a linear set of counts can map to scan position for a sinusoidally scan.

FIG. 28 is a system block diagram showing handling of data to store data in a memory matrix while compensating for nonlinear scan speed of the resonant mirror.

FIG. 29 is a block diagram of a first system for generating an output clock to retrieve data from a memory matrix while compensating for nonlinear scan speed of the resonant mirror.

FIG. 30 is a block diagram of an alternative embodiment of the apparatus of FIG. 29 including pre-distortion.

FIG. 31 is a detail block diagram of a clock generation portion of the block diagram of FIG. 29.

FIG. 32 is a representation of a data structure showing data predistorted to compensate for vertical optical distortion.

FIG. 33 is a top plan view of a MEMs scanner including structures for electronically controlling the center of mass of each mirror half.

FIG. 34 is a top plan view of the MEMs scanner of FIG. 32 showing flexing of protrusions in response to an applied voltage.

FIG. 35 is a top plan view of a MEMs scanner including comb structures for laterally shifting the center of mass of each mirror half.

FIG. 36 is a side cross sectional view of a packaged scanner including electrically controlled outgassing nodules.

FIG. 37 is a top plan view of a MEMs mirror including selectively removable tabs for frequency tuning.

FIG. 38A is a top plan view of a substrate including an array of scanners having removable material for on-substrate frequency tuning.

FIG. 38B is a top plan view of a uniaxial scanner having a block of a migrating impurity on its torsion arms for selective frequency tuning.

FIG. 39 is a diagrammatic view of a four source display showing overlap of scanning fields with optical sources.

FIG. 40 is a diagrammatic view of a four source display with small turning mirrors and offset optical sources.

FIG. 41 is a diagrammatic view of the display of FIG. 40 showing beam paths with the small turning mirrors and a common curved mirror.

FIG. 42 is a diagrammatic view of a single emitter display including switched optical fibers each feeding a separate tile.

FIG. 43 is a diagrammatic view of a display including four separate fibers feeding a scanner through a set of optical switches in response to a detected gaze direction to produce four separate tiles.

DETAILED DESCRIPTION OF THE INVENTION

As shown in FIG. 6, a scanned beam display 70 according to one embodiment of the invention is positioned for viewing by a viewer's eye 72. While the display 70 is presented herein as scanning light into the eye 72, the structures and concepts described herein can also be applied to other types of displays, such as projection displays that include viewing screens.

The display 70 includes four principal portions, each of which will be described in greater detail below. First, control electronics 74 provide electrical signals that control operation of the display 70 in response to an image signal V_{IM} from an image source 76, such as a computer, television receiver, videocassette player, DVD player, remote sensor, or similar device.

The second portion of the display 70 is a light source 78 that outputs modulated light beams 80, each having a modulation corresponding to information in the image signal V_{IM} . The light source 78 may utilize coherent light emitters, such as laser diodes or microlasers, or may use non-coherent sources such as light emitting diodes. Also, the light source 78 may include directly modulated light emitters such as the light emitting diodes (LEDs) or may include continuous light emitters indirectly modulated by external modulators, such as acousto-optic modulators.

The third portion of the display 70 is a scanning assembly 82 that scans the modulated beams 80 through two-dimensional scanning patterns, such as raster patterns. The scanning assembly 82 preferably includes a periodically scanning mirror or mirrors as will be described in greater detail below with reference to FIGS. 3-4, 8, 11, 19-22.

Lenses 84, 86 positioned on opposite sides of the scanning assembly 82 act as imaging optics that form the fourth portion of the display 70. The lenses 86 are cylindrical graded index (GRIN) lenses that gather and shape light from the light source 78. Where the light source 78 includes optical fibers that feed the lenses 86, the lenses 86 may be bonded to or integral to the fibers. Alternatively, other types of lenses, such as doublets or triplets, may form the lenses 86. Also, other types of optical elements such as diffractive elements may be used to shape and guide the light. Regardless of the type of element, the overall optical train may incorporate polarization sensitive materials, chromatic correction, or any other optical technique for controlling the shape, phase or other characteristics of the light.

The lens 84 is formed from a curved, partially transmissive mirror that shapes and focuses the scanned beams 80 approximately for viewing by the eye 72. After leaving the lens 84, the scanned beams 80 enter the eye 72 through a pupil 90 and strike the retina 92. As each beam of scanned modulated light strikes the retina 92, the viewer perceives a respective portion of the image as will be described below.

Because the lens 84 is partially transmissive, the lens 84 combines the light from the scanning assembly 82 with the light received from a background 89 to produce a combined input to the viewer's eye 72. Although the background 89 is presented herein as a "real-world" background, the background light may be occluded or may be produced by another light source of the same or different type. One skilled in the art will recognize that a variety of other optical elements may replace or supplement the lenses 84, 86. For example, diffractive elements such as Fresnel lenses may replace either or both of the lenses 84, 86. Additionally, a beamsplitter and lens may replace the partially transmissive mirror structure of the lens 84. Moreover, various other optical elements, such as polarizers, color filters, exit pupil

expanders, chromatic correction elements, eye-tracking elements, and background masks may also be incorporated for certain applications.

Although the elements of FIG. 6 are presented diagrammatically, one skilled in the art will recognize that the components are typically sized and configured for the desired application. For example, where the display 70 is intended as a mobile personal display the components are sized and configured for mounting to a helmet or similar frame as a head-mounted display 70, as shown in FIG. 7. In this embodiment, a first portion 171 of the display 70 is mounted to a head-borne frame 174 and a second portion 176 is carried separately, for example in a hip belt. The portions 174, 176 are linked by a fiber optic and electronic tether 178 that carries optical and electronic signals from the second portion to the first portion. An example of a fiber-coupled scanner display is found in U.S. Pat. No. 5,596,339 of Furness et al., entitled VIRTUAL RETINAL DISPLAY WITH FIBER OPTIC POINT SOURCE which is incorporated herein by reference.

An exemplary embodiment of the scanning assembly 82 will be described next with reference to FIG. 8. The scanning assembly 82 includes several components that correspond to the scanning source 42 of FIG. 3, where components common to the scanning assembly 82 and scanning source 42 are numbered the same. Additionally, only central rays 55 are presented for the beams 52 for clarity of presentation.

In this embodiment, a pair of fibers 50 emit light from the light sources 78 (not shown) and the lens 84 is represented as a common refractive lens rather than as a partially transmissive mirror. Unlike the scanning source 42 of FIG. 3, the scanning assembly 82 includes an active correction mirror 100 that can pivot to scan the light beam 80 along the vertical axis. As will be explained below, the correction mirror 100 produces a varying corrective shift along the vertical axis during each sweep (forward or reverse) of the horizontal scanner 56. The corrective shift offsets vertical movement of the beams 80 caused by the vertical scanner 58 to reduce the overall deviation of the scanning pattern from the desired pattern shown in broken lines in FIG. 5.

Before describing the effects of the correction mirror 100 and the relative timing of the various signals, exemplary embodiments of mechanically resonant scanner 200, 220 suitable for use as the horizontal scanner 56 and vertical scanner 58 will be described with reference to FIG. 9.

The principal scanning component of the horizontal scanner 200 is a moving mirror 202 mounted to a spring plate 204. The dimensions of the mirror 202 and spring plate 204 and the material properties of the spring plate 204 have a high Q with a natural oscillatory ("resonant") frequency on the order of 1-100 kHz, where the selected resonant frequency depends upon the application. For VGA quality output with a 60 Hz refresh rate and no interlacing, the resonant frequency is preferably about 15-20 kHz. As will be described below, the selected resonant frequency or the achievable resolution may be changed through the use of a plurality of feeds.

A ferromagnetic material mounted with the mirror 202 is driven by a pair of electromagnetic coils 206, 208 to provide motive force to mirror 202, thereby initiating and sustaining oscillation. The ferromagnetic material is preferably integral to the spring plate 204 and body of the mirror 202. Drive electronics 218 provide electrical signals to activate the coils 206, 208, as described above. Responsive to the electrical signals, the coils 206, 208 produce periodic electromagnetic

fields that apply force to the ferromagnetic material, thereby causing oscillation of the mirror **202**. If the frequency and phase of the electric signals are properly synchronized with the movement of the mirror **202**, the mirror **202** oscillates at its resonant frequency with little power consumption.

The vertical scanner **220** is structured very similarly to the resonant scanner **200**. Like the resonant scanner **201**, the vertical scanner **220** includes a mirror **222** driven by a pair of coils **224**, **226** in response to electrical signals from the drive electronics **218**. However, because the rate of oscillation is much lower for vertical scanning, the vertical scanner **220** is typically not resonant. The mirror **222** receives light from the horizontal scanner **201** and produces vertical deflection at about 30–100 Hz. Advantageously, the lower frequency allows the mirror **222** to be significantly larger than the mirror **202**, thereby reducing constraints on the positioning of the vertical scanner **220**. The details of virtual retinal displays and mechanical resonant scanning are described in greater detail in U.S. Pat. No. 5,467,104, of Furness III, et al., entitled VIRTUAL RETINAL DISPLAY which is incorporated herein by reference.

One skilled in the art will recognize a variety of other structures that may scan a light beam through a generally raster pattern. For example, spinning polygons or galvanometric scanners may form either or both of the scanners **56**, **58** in some applications.

In another embodiment, a bi-axial microelectromechanical (MEMs) scanner may provide the primary scanning. Some such scanners are described in U.S. Pat. No. 5,629,790 to Neukermanns et al., entitled MICROMACHINED TORSIONAL SCANNER, which is incorporated herein by reference. While the scanner of the '790 patent is the presently preferred embodiment, a variety of other MEMs scanners may also be appropriate for certain applications. For example, surface micromachined biaxial scanners and other MEMs scanners have been described by various authors.

Like the scanning system described above, the horizontal components of the MEMs scanners are typically defined by mechanical resonances of their respective structures, as will be described in greater detail below with reference to FIGS. **17A–B** and **21**. Like the two scanner system described above with reference to FIGS. **3** and **8**, such biaxial scanners may suffer similar raster pinch problems due to movement along the slower scan axis during sweeps along the faster scan axis. Other scanning approaches may also apply. For example, acousto-optic scanners, electrooptic scanners, spinning polygons, or some combination of scanning approaches can provide the scanning function. Some of these approaches may not require pinch correction.

Returning to FIGS. **6**, **8** and **9**, the fibers **50** output light beams **80** that are modulated according to the image signal from the drive electronics **218**. At the same time, the drive electronics **218** activate the coils **206**, **208**, **224**, **226** to oscillate the mirrors **202**, **222**. The modulated beams of light strike the oscillating horizontal mirror **202** (of the horizontal scanner **56**), and are deflected horizontally by an angle corresponding to the instantaneous angle of the mirror **202**. The deflected beams then strike the vertical mirror **222** (of the vertical scanner **58**) and are deflected at a vertical angle corresponding to the instantaneous angle of the vertical mirror **222**. After expansion by the beam expander **62**, the beams **52** pass through the lens **84** to the eye. As will also be described below, the modulation of the optical beams is synchronized with the horizontal and vertical scans so that, at each position of the mirrors, the beam color and intensity correspond to a desired virtual image. Each beam therefore “draws” a portion of the virtual image directly upon the user’s retina.

One skilled in the art will recognize that several components of the scanning assembly **82** have been omitted from the FIG. **9** for clarity of presentation. For example, the horizontal and vertical scanners **200**, **220** are typically mounted to a frame. Additionally, lenses and other optical components for gathering, shaping, turning, focusing, or collimating the beams **80** have been omitted. Also, no relay optics are shown between the scanners **200**, **220**, although these may be desirable in some embodiments. Moreover, the scanner **200** typically includes one or more turning mirrors that direct the beam such that the beam strikes each of the mirrors a plurality of times to increase the angular range of scanning. Further, in some embodiments, the scanners **200**, **220** are oriented such that the beam can strike the scanning mirrors a plurality of times without a turning mirror.

Turning to FIGS. **10** and **11**, the effect of the plurality of beams **80** will now be described. As is visible in FIG. **10**, two fibers **50** emit respective light beams **80**. The GRIN lenses **86** gather and focus the beams **80** such that the beams **80** become converging beams **80A**, **80B** that strike a common scanning mirror **1090**.

For clarity of presentation, the embodiment of FIG. **10** eliminates the mirror **84**, as is desirable in some applications. Also, the embodiment of FIG. **10** includes a single mirror **1090** that scans biaxially instead of the dual mirror structure of FIG. **9**. Such a biaxial structure is described in greater detail below with reference to FIGS. **11**, **17A–B** and **21**. One skilled in the art will recognize that a dual mirror system may also be used, though such a system would typically involve a more complex set of ray traces and more complex compensation for differing optical path lengths.

Also, although the fibers **50** and lenses **84** of FIG. **10** appear positioned in a common plane with the scanning mirror **1090**, in many applications, it may be desirable to position the fibers **50** and lenses **84** off-axis, as is visible in FIG. **11**. Moreover, where four fiber/lens pairs are used, as in FIG. **11**, a beam splitter or other optical elements can allow the fiber/lens pairs to be positioned where they do not block beams **80A–D** from other fiber/lens pairs. Alternatively, other approaches, such as small turning mirrors can permit repositioning of the fiber/lens pairs in non-blocking positions with little effect on the image quality. Such approaches are described in greater detail below with reference to FIGS. **11** and **38A–41**.

After exiting the lens **86**, the first beam **80A** strikes the scanning mirror **1090** and is reflected toward an image field **1094**. The second beam **80B** is also reflected by the scanning mirror **1090** toward the image field **1094**. As shown by the ray tracing of FIG. **10**, the horizontal position of the beams **80A–B** in the image field **1094** will be functions of the angular deflection from the horizontal scanner **56** and the position and orientation of the lens **86** and fiber **50**.

At the image field **1092**, the first beam **80A** illuminates a first region **1092** of the image field **1094** and the second beam **80B** illuminates a second region **1096** that is substantially non-overlapping with respect to the first region **1092**. To allow a smooth transition between the two regions **1092**, **1096**, the two regions **1092**, **1096** overlap slightly in a small overlap region **1098**. Thus, although the two regions are substantially distinct, the corresponding image portions may be slightly “blended” at the edges, as will be described below with reference to FIGS. **12** and **13**.

While only two beams **80A–B** are visible in FIG. **10**, more than two fiber/lens pairs can be used and the fiber/lens pairs need not be coplanar. For example, as can be seen in FIG. **11**, four separate lenses **86** transmit four separate beams **80A–D**

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from four spatially separated locations toward the mirror **1090**. As shown in FIG. **12**, the mirror **1090** reflects each of the four beams **80A–D** to a respective spatially distinct region **1202A–D** of the image field **1094**.

Thus, the four beams **80A–D** each illuminate four separate “tiles” **1202A–D** that together form an entire image. One skilled in the art will recognize that more than four tiles may form the image. For example, adding a third set of fiber/lens pairs could produce a 2-by-3 tile image or a 3-by-2 tile image.

To produce an actual image, the intensity and color content of each of the beams **80A–D** is modulated with image information as the mirror **1090** sweeps through a periodic pattern, such as a raster pattern. FIG. **13** shows diagrammatically one embodiment where the beams **80A–D** can be modulated in response to an image signal V_{IM} to produce the four tiles **1202A–D**.

The image signal V_{IM} drives an A/D converter **1302** that produces corresponding data to drive a demultiplexer **1304**. In response to the data and a clock signal CK from the controller **74** (FIG. **8**), the demultiplexer **1304** produces four output data streams, where each data stream includes data corresponding to a respective image tile **1202A–D**. For example, the demultiplexer **1304** outputs data corresponding to the first half of the first line of the image to a first buffer **1306A** and the data corresponding to the second half of the first line to a second buffer **1306B**. The demultiplexer **1304** then outputs data corresponding to the second line of the image to the second lines of the first two buffers **1306A, B**. After the first two buffers **1306A, B** contain data representing the upper half of the image, the demultiplexer **1304** then begins filling third and fourth buffers **1306C, D**. Once all of the buffers **1306A–D** are full, an output clock CKOUT clocks data simultaneously from all of the buffers **1306A–D** to respective D/A converters **1308A–D**. The D/A converters **1308A–D** then drive respective light sources **78** to produce light that is scanned into the respective regions **2102A–D**, as described above. The actual timing of the pixel output is controlled by the output clock CKOUT, as described below with reference to FIGS. **28–31**.

One skilled in the art will recognize that, although the system of FIG. **13** is described for four separate regions **1201A–D**, a larger or smaller number of regions may be used. Also, where some overlap of the regions **1202A–D** is desired, common data can be stored in more than one buffer **1202A–D**. Because the sets of common data will duplicate some pixels in the overlapping region, the data may be scaled to limit the intensity to the desired level.

One approach to improving image quality that is helpful in “matching” the image portions **1202A–D** to each other will now be described with reference to FIGS. **14** and **15**. Because the angle of the beams **80A–D** is determined by the angles of the vertical and horizontal scanner (for the uniaxial, two scanner system) or the horizontal and vertical angles of the single mirror (for the biaxial scanner), the actual vector angle of the beams **80A–D** at any point in time can then be determined by vector addition. In most cases, the desired vertical portions of the scan patterns will be a “stair step” scan pattern, as shown by the broken line in FIG. **14**.

If the turning mirror **100** (FIG. **8**) is disabled, the pattern traced by the ray will be the same as that described above with respect to FIGS. **3–5**. As represented by the solid line in FIG. **14**, the actual vertical scan portion of the pattern, shown in solid line, will be an approximate ramp, rather than the desired stair step pattern.

One approach to providing the stair step pattern would be to drive the vertical scanner **58** with the stair step voltage.

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However, because the vertical mirror is a physical system and the stair step involves discontinuous motion, the vertical mirror will not follow the drive signal exactly. Instead, as the vertical mirror attempts to follow the stair step pattern, the vertical mirror will move at a maximum rate indicated largely by the size and weight of the vertical mirror, the material properties of the mirror support structure, the peak voltage or current of the driving signal, and electrical properties of the driving circuitry. For typical vertical scan mirror size, configuration, scan angle and driving voltage, the vertical scanner **58** is limited to frequencies on the order of 100 to 3000 Hz. The desired scan pattern has frequency components far exceeding this range. Consequently, driving the vertical scanner **58** with a stair step driving signal can produce a vertical scan pattern that deviates significantly from the desired pattern.

To reduce this problem, the scanning assembly **82** of FIG. **8** separates the vertical scan function into two parts. The overall vertical scan is then a combination of a large amplitude ramp function at about 60 Hz and a small amplitude correction function at twice the horizontal rate (e.g., about 30 kHz). The vertical scanner **58** can produce the large amplitude ramp function, because the 60 Hz frequency is well below the upper frequency limit of typical scanning mirrors. Correction mirrors **100** replace the turning mirrors **100** and provide the small amplitude corrections. The correction mirrors **100** operate at a much higher frequency than the vertical scanner; however, the overall angular swings of the correction mirrors **100** are very small.

As can be seen from the signal timing diagram of FIG. **15**, the correction mirror **100** travels from approximately its maximum negative angle to its maximum positive angle during the time that the horizontal scanner scans from the one edge of the field of view to the opposite edge (i.e. from time t_1 to t_2 in FIG. **15**). The overall correction angle, as shown in FIGS. **14** and **15**, is defined by the amount of downward travel of the vertical scan mirror during a single horizontal scan. The correction angle will vary for various configurations of the display; however, the correction angle can be calculated easily.

For example, for a display where each image region **1202A–D** has 1280 vertical lines and a total mechanical vertical scan angle of 10 degrees, the angular scan range for each line is about 0.008 degrees ($10/1280=0.0078125$). Assuming the vertical scanner **58** travels this entire distance during the horizontal scan, an error correction to be supplied by the correction mirror **100** is about plus or minus 0.0039 degrees. The angular correction is thus approximately θ/N , where θ is the vertical scan angle and N is the number of horizontal lines. This number may be modified in some embodiments. For example, where the horizontal scanner **56** is a resonant scanner, the correction angle may be slightly different, because the horizontal scanner **56** will use some portion of the scan time to halt and begin travel in the reverse direction, as the scan reaches the edge of the field of view. The correction angle may also be modified to correct for aberrations in optical elements or optical path length differences. Moreover, the frequency of the correction scanner **100** may be reduced by half if data is provided only during one half of the horizontal scanner period (“unidirectional scanning”), although raster pinch is typically not problematic in unidirectional scanning approaches.

As can be seen from the timing diagrams of FIGS. **14** and **15**, the correction mirror **100** will translate the beam vertically by about one half of one line width at a frequency of twice that of the horizontal scanner **56**. For a typical display at SVGA image quality with bi-directional scanning (i.e.,

data output on both the forward and reverse sweeps of the horizontal scanner 56), the horizontal scanner 56 will resonate at about 15 kHz. Thus, for a typical display, the correction scanner 100 will pivot by about one-tenth of one degree at about 30 kHz. One skilled in the art will recognize that, as the resolution of the display increases, the scan rate of the horizontal scanner 56 increases. The scan rate of the correction mirror 100 will increase accordingly; but, the pivot angle will decrease. For example, for a display having 2560 lines and an overall scan of 10 degrees, the scan rate of the correction mirror 100 will be about 60 kHz with a pivot angle of about 0.002 degrees. One skilled in the art will recognize that, for higher resolution, the minimum correction mirror size will typically increase where the spot size is diffraction limited.

FIG. 16 shows a piezoelectric scanner 110 suitable for the correction mirror 100 in some embodiments. The scanner 110 is formed from a platform 112 that carries a pair of spaced-apart piezoelectric actuators 114, 116. The correction mirror 100 is a metallized, substantially planar silicon substrate that extends between the actuators 114, 116. The opposite sides of the piezoelectric actuators 114, 116 are conductively coated and coupled to a drive amplifier 120 such that the voltage across the actuators 114, 116 are opposite. As is known, piezoelectric materials deform in the presence of electric fields. Consequently, when the drive amplifier 120 outputs a voltage, the actuators 114, 116 apply forces in opposite directions to the correction mirror 100, thereby causing the correction mirror 100 to pivot. One skilled in the art will recognize that, although the piezoelectric actuators 114, 116 are presented as having a single set of electrodes and a single layer of piezoelectric material, the actuators 114, 116 would typically be formed from several layers. Such structures are used in commercially available piezoelectric devices to produce relatively large deformations.

A simple signal generator circuit 122, such as a conventional ramp generator circuit, provides the driving signal for the drive amplifier 120 in response to the detected position of the horizontal scanner 56. The principal input to the circuit 122 is a sense signal from a sensor coupled to the horizontal scanner 56. The sense signal can be obtained in a variety of approaches. For example, as described in U.S. Pat. No. 5,648,618 to Neukermanns et al., entitled MICROMACHINED HINGE HAVING AN INTEGRAL TORSIONAL SENSOR, which is incorporated herein by reference, torsional movement of a MEMs scanner can produce electrical outputs corresponding to the position of the scanning mirror. Alternatively, the position of the mirror may be obtained by mounting piezoelectric sensors to the scanner, as described in U.S. Pat. No. 5,694,237 to Melville, entitled POSITION DETECTION OF MECHANICAL RESONANT SCANNER MIRROR, which is incorporated herein by reference. In other alternatives, the position of the beam can be determined by optically or electrically monitoring the position of the horizontal or vertical scanning mirrors or by monitoring current induced in the mirror drive coils.

When the sense signal indicates that the horizontal scanner 56 is at the edge of the field of view, the circuit 122 generates a ramp signal that begins at its negative maximum and reaches its zero crossing point when the horizontal scanner reaches the middle of the field of view. The ramp signal then reaches its maximum value when the horizontal scan reaches the opposite edge of the field of view. The ramp signal returns to its negative maximum during the interval when the horizontal scan slows to a halt and begins to return sweep. Because the circuit 122 can use the sense signal as

the basic clock signal for the ramp signal, timing of the ramp signal is inherently synchronized to the horizontal position of the scan. However, one skilled in the art will recognize that, for some embodiments, a controlled phase shift of the ramp signal relative to the sense signal may optimize performance. Where the correction mirror 100 is scanned resonantly, as described below with reference to FIG. 18, the ramp signal can be replaced by a sinusoidal signal, that can be obtained simply by frequency doubling, amplifying and phase shifting the sense signal.

The vertical movements of the beams 80A–D induced by the correction mirrors 100 offset the movement of the beams 80A–D caused by the vertical scanner 58, so that the beams 80A–D remain stationary along the vertical axis during the horizontal scan. During the time the horizontal scan is out of the field of view, the beams 80A–D travel vertically in response to the correction mirrors 100 to the nominal positions of the next horizontal scan.

As can be seen from the above discussion, the addition of the piezoelectrically driven correction mirrors 100 can reduce the raster pinching significantly with a ramp-type of motion. However, in some applications, it may be undesirable to utilize ramp-type motion. One alternative embodiment of a scanner 130 that can be used for the correction mirror 100 is shown in FIGS. 17A and 17B.

The scanner 130 is a resonant micromechanical (MEMs) scanner, fabricated similarly to the uniaxial embodiment described in the Neukermanns '790 patent. Alternatively, the scanner 130 can be a mechanically resonant scanner very similar to the horizontal scanner 54 of FIG. 9; however, in such a scanner it is preferred that the dimensions and material properties of the plate and mirror be selected to produce resonance at about 30 kHz, which is twice the resonant frequency of the horizontal scanner 200. Further, the materials and mounting are preferably selected so that the scanner 130 has a lower Q than the Q of the horizontal scanner 56. The lower Q allows the scanner 130 to operate over a broader range of frequencies, so that the scanner 130 can be tuned to an integral multiple of the horizontal scan frequency.

The use of the resonant scanner 130 can reduce the complexity of the electrical components for driving the scanner 130 and can improve the scanning efficiency relative to previously described approaches. Resonant scanners tend to have a sinusoidal motion, rather than the desired ramp-type motion described above. However, if the frequency, phase, and amplitude of the sinusoidal motion are selected appropriately, the correction mirror 100 can reduce the pinch error significantly. For example, FIG. 18 shows correction of the raster signal with a sinusoidal motion of the correction mirror where the horizontal field of view encompasses 90 percent of the overall horizontal scan angle. One skilled in the art will recognize that the error in position of the beam can be reduced further if the field of view is a smaller percentage of the overall horizontal scan angle. Moreover, even further reductions in the scan error can be realized by adding a second correction mirror in the beam path, although this is generally undesirable due to the limited improvement versus cost. Another approach to reducing the error is to add one or more higher order harmonics to the scanner drive signal so that the scanning pattern of the resonant correction scanner 130 shifts from a sinusoidal scan closer to a sawtooth wave.

Another alternative embodiment of a reduced error scanner 140 is shown in FIG. 19 where the scan correction is realized by adding a vertical component to a horizontal mirror 141. In this embodiment, the horizontal scanner 140 is a

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MEMs scanner having an electrostatic drive to pivot the scan mirror. The horizontal scanner **140** includes an array of locations **143** at which small masses **145** may be formed. The masses **145** may be deposited metal or other material that is formed in a conventional manner, such as photolithography. Selected ones of the masses **143** are removed to form an asymmetric distribution about a centerline **147** of the mirror **141**. The masses **145** provide a component to scan the correction along the vertical axis by pivoting about an axis orthogonal to its primary axis. As can be seen in FIG. **20**, the vertical scan frequency is double the horizontal scan frequency, thereby producing the Lissajous or "bow-tie" overall scan pattern of FIG. **20**. The masses **145** may be actively varied (e.g. by laser ablation) to tune the resonant frequency of the vertical component. This embodiment allows correction without an additional mirror, but typically requires matching the resonant frequencies of the vibration and the horizontal scanner.

To maintain matching of the relative resonant frequencies of the horizontal scanner **56** and the correction scanner **100**, the resonant frequency of either or both scanners **56**, **100** may be tuned actively. Various frequency control techniques are described below with reference to FIGS. **33-36**. Where the Q of the scanners **56**, **100** are sufficiently low or where the scanners **56**, **100** are not resonant, simply varying the driving frequency may shift the scanning frequency sufficiently to maintain synchronization.

As shown in FIG. **21**, another embodiment of a scanner **150** according to the invention employs a biaxial scanner **152** as the principal scan component, along with a correction scanner **154**. The biaxial scanner **152** is a single mirror device that oscillates about two orthogonal axes. Design, fabrication and operation of such scanners are described for example in the Neukermanns '790 patent, in Asada, et al, Silicon Micromachined Two-Dimensional Galvano Optical Scanner, IEEE Transactions on Magnetics, Vol. 30, No. 6, 4647-4649, November 1994, and in Kiang et al, Micromachined Microscanners for Optical Scanning, SPIE proceedings on Miniaturized Systems with Micro-Optics and Micro-machines II, Vol. 3008, Feb. 1997, pp. 82-90 each of which is incorporated herein by reference. The bi-axial scanner **152** includes integral sensors **156** that provide electrical feedback of the mirror position to terminals **158**, as is described in the Neukermanns '618 patent.

The correction scanner **154** is preferably a MEMs scanner such as that described above with reference to FIGS. **17A-B**, although other types of scanners, such as piezoelectric scanners may also be within the scope of the invention. As described above, the correction scanner **154** can scan sinusoidally to remove a significant portion of the scan error; or, the correction mirror can scan in a ramp pattern for more precise error correction.

Light from the light source **78** strikes the correction scanner **154** and is deflected by a correction angle as described above. The light then strikes the biaxial scanner **152** and is scanned horizontally and vertically to approximate a raster pattern, as described above with reference to FIGS. **3-5**.

Another embodiment of a display according to the invention, shown in FIG. **23**, eliminates the correction mirror **100** by physically shifting the input beam laterally relative to the input of an optical system **500**. In the embodiment of FIG. **23**, a piezoelectric driver **502** positioned between a frame **504** and an input fiber **506** receives a drive voltage at a frequency twice that of the horizontal scan frequency. Responsive to the drive voltage, the piezoelectric driver **502** deforms. Because the fiber **506** is bonded to the piezoelectric

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driver **502**, deformation of the piezoelectric driver **502** produces corresponding shifting of the fiber **506** as indicated by the arrow **508** and shadowed fiber **510**. One skilled in the art will recognize that, depending upon the characteristics of the optical system **500**, the piezoelectric driver **502** may produce lateral translation of the fiber **506** or angular shifting of the fiber **506** output. The optical system **500** then translates movement of the fiber output into movement of the perceived pixel location as in the previously described embodiments. While the embodiment of FIG. **23** translates a fiber, the invention is not so limited. For example some applications may incorporate translation of other sources, such as LEDs or laser diodes, may translate the position of the lens **50**, or may translate or rotate an entire scanner, such as a biaxial MEMs scanner.

Although the embodiment of FIG. **23** shifts the input beam by shifting the position of the input fiber, other methods of shifting the input beam may be within the scope of the invention. For example, as shown in FIG. **24**, an electro-optic crystal **300** shifts the input beam **83** in response to an electrical signal. In this embodiment, the beam **83** enters a first face **302** of a trapezoidally shaped electrooptic crystal **300**, where refraction causes a shift in the direction of propagation. When the beam **83** exits through a second face **304**, refraction produces a second shift in the direction of propagation. At each face, the amount of changes in the direction or propagation will depend upon difference in index of refraction between the air and the crystal **300**.

As is known, the index of refraction of electro-optical crystals is dependent upon the electric field through the crystal. A voltage applied across the crystal **300** through a pair of electrodes **306** can control the index of refraction of the crystal **300**. Thus, the applied voltage can control the index of refraction of the crystal **300**. Thus the applied voltage can control the angular shift of the beam **83** as it enters and exits the crystal **300** as indicated by the broken line **83a**. The amount of shift will correspond to the applied voltage. Accordingly, the amount of shift can be controlled by controlling the voltage applied to the electrodes **306**. The crystal **300** thus provides a voltage controlled beam shifter that can offset raster pinch.

Although the embodiments described herein have been displays, other devices or methods may be within the scope of the invention. For example, as shown in FIG. **24**, an imager **600** includes a biaxial scanner **602** and correction scanner **604** that are very similar to the scanners **152**, **154** of FIG. **21**. The imager **600** is an image collecting device that may be the input element of a digital camera, bar code reader, two dimensional symbol reader, document scanner, or other image acquisition device. To allow the imager **600** to gather light efficiently, the imager **600** includes gathering optics **606** that collect and transmit light from a target object **608** outside of the imager **600** onto the correction scanner **604**. The gathering optics **606** are configured to have a depth of field, focal length, field of view and other optical characteristics appropriate for the particular application. For example, where the imager **600** is a two dimensional symbology reader, the gathering optics **606** may be optimized for red or infrared light and the focal length may be on the order of 10-50 cm. For reading symbols at a greater distance, the focusing optics may have longer focusing distance or may have a variable focus. The optics may be positioned at other locations along the optical path to allow smaller, cheaper components to be used.

The correction scanner **604** redirects light received from the gathering optics **606** as described above for the display embodiments, so that the gathered light has a correction

component before it reaches the biaxial scanner 602. The biaxial scanner 602 scans through a generally raster pattern to collect light arriving at the gathering optics 606 from a range of angles and to redirect the light onto a group of stationary photodetectors 610, each positioned at a respective location and orientation, such that it images a respective “tile” of the image field.

Movement of the biaxial scanner 602 thus translates to imaging successive points of the target object 608 onto the photodetectors 610. The photodetectors 610 convert light energy from the scanner 602 into electrical signals that are received by decoding electronics 612. Where the imager 600 is a symbology reader, the decoding electronics 612 may include symbol decoding and storing circuitry and further electronics for assembling the image from the stored files. Where the imager is a portion of a camera, the decoding electronics 612 may include digital-to-analog converters, memory devices and associated electronics for storing a digital representation of the scanned tile and further electronics for assembling the image from the stored files. One skilled in the art will recognize that, although the correction scanner 604 is positioned before the bi-axial scanner 602, it may be desirable to position the correction scanner 604 following the bi-axial scanner 602 in some applications.

Another feature of the imager 600 shown in FIG. 24 is a set of illumination sources 614 that provide light for illuminating respective locations on a target object. The illumination sources 614 are preferably of different wavelengths to ease differentiation of beams, although in some applications common wavelength devices may be used. In one example of a multiwavelength structure where imager 600 is a symbol reader, the illumination sources 614 may include infrared or red light emitters that emit beams of light into a beam splitter 616. The beam splitter 616 directs the illuminating light beams into the bi-axial scanner 602 where the illuminating light is redirected to the correction scanner 604. Because the illuminating light beams are collinear with the paths of light from the target object 608, the illuminating light beams strike the target object 608 at the same locations that are imaged by the photodetectors 610. The illuminating light beams are reflected by the target object 608 in pattern corresponding to the reflectivity of the respective regions of the target object 608. The reflected illuminating light travels to the photodetectors 610 to image the respective regions of light that can be used only by the photodetectors 610 to image the respective regions of the target object 608. For high resolution, the area illuminated by the sources 614 or imaged by the photodetectors 610 may be made small through a variety of known optical techniques. One skilled in the art will recognize that, although FIG. 24 shows the correction scanner 604 positioned after the horizontal scanner 602, it will often be preferable to position the correction scanner 604 between the beam splitter 616 and the horizontal scanner 602. This allows for the mirror of the correction scanner 604 to be made small.

Alternatively, the photodetectors 610 may be mounted externally to the scanners 602, 604 and oriented to capture light directly from their respective tiles. Because each photodetector 610 is wavelength matched to its respective source and because the photodetectors 610 are aligned to spatially distinct regions, crosstalk between signals from the respective tiles may be adequately suppressed.

In one application of the imager 600 of FIG. 24, one or more of the illumination sources 614 includes a visible, directly modulated light source, such as a red laser diode or a visible wavelength light emitted diode (LED). As shown in FIG. 25, the visible illumination source 614 can thus pro-

duce a visible image for the user. In the exemplary embodiment of FIG. 25, the imager can operate as a symbology scanner to identify information contained in a symbol on the target object 608. Once the decoding electronics 612 identifies a desired image to be viewed, such as an item price and identity, the decoding electronics 612 modulates the drive current of the illumination sources 614 to modulate the intensity of the emitted light according to the desired image. When the user directs the imager 600 toward a screen 619 (or the target object), the illuminating light is scanned onto the screen 619 as described above. Because the illuminating light is modulated according to the desired image, the visible light reflected from the screen 619 is spatially modulated according to the desired image. The imager 600 thus acts as an image projector in addition to acquiring image data. In addition to, or as an alternative to, modulating the diode to produce an image, the diodes corresponding to each of the regions of the target object 608 may also output continuous or pulsed beams of light that fill the entire field of view of the imager 600. The imager 600 thus provides a spotter frame 618 that indicates the field of view to the user. Similarly, the illumination sources 614 can be modified to outline the field of view or to produce other indicia of the field of view, such as cross hatching or fiducials, to aid the user in aligning the imager 600 to the target object 608.

In addition to compensating for raster pinch, one embodiment of the scanning system, shown in FIG. 28, also addresses effects of the nonlinearity of resonant and other nonlinear scanning systems. One skilled in the art will recognize that, although this correction is described for a single light source or single detector system, the approaches described herein are applicable to systems using more than one light source, as presented in FIG. 10 above. For example, in one application, the corrected output clock signal described below with reference to FIG. 28, drives all of the buffers 1306A–D (FIG. 13) to output data in parallel from buffers 1306A–D.

As shown by broken line in FIG. 26, the timing of incoming data is premised upon a linear scan rate. That is, for equally spaced subsequent locations in a line, the data arrive at constant intervals. A resonant scanner, however, has a scan rate that varies sinusoidally, as indicated by the solid line in FIG. 26. For a start of line beginning at time t_0 (note that the actual start of scan for a sinusoidal scan would likely be delayed slightly as described above with respect to FIG. 26), the sinusoidal scan initially lags the linear scan. Thus, if the image data for position P_1 arrive at time t_{1A} , the sinusoidal scan will place the pixel at position P_2 .

To place the pixel correctly, the system of FIG. 28 delays the image data until time t_{1B} , as will now be described. As shown in FIG. 28, arriving image data V_{IM} are clocked into a line or frame buffer 2200 by a counter circuit 2202 in response to a horizontal synchronization component of the image data signal. The counter circuit 2202 is a conventional type circuit, and provides an input clock signal having equally spaced pulses to clock the data into the buffer 2200. In the multisource system of FIG. 13, the four buffers 1306A–D, and demultiplexer 1304 replace the frame buffer and the image data are clocked sequentially through the demultiplexer 1304 into the four buffers 1306A–D, rather than being clocked into a single frame buffer or line buffer.

A feedback circuit 2204 controls timing of output from the buffer 2200 (or buffers 1306A–D of FIG. 13). The feedback circuit 2204 receives a sinusoidal or other sense signal from the scanning assembly 82 and divides the period of the sense signal with a high-speed second counter 2206. A logic circuit 2208 produces an output clock signal in response to the counter output.

Unlike the input clock signal, however, pulses of the output clock signal are not equally spaced. Instead, the pulse timing is determined analytically by comparing the timing of the linear signal of FIG. 26 to the sinusoidal signal. For example, for a pixel to be located at position P_1 , the logic circuit 2208 provides an output pulse at time t_{1B} , rather than time t_{1A} , as would be the case for a linear scan rate.

The logic circuit 2208 identifies the count corresponding to a pixel location by accessing a look-up table in a memory 2210. Data in the look-up table 2210 are defined by dividing the scanning system period into many counts and identifying the count corresponding to the proper pixel location. FIG. 27 shows this evaluation graphically for a 35-pixel line. One skilled in the art will recognize that this example is simplified for clarity of presentation. A typical line may include hundreds or even thousands of pixels. As can be seen, the pixels will be spaced undesirably close together at the edges of the field of view and undesirably far apart at the center of the field of view. Consequently, the image will be compressed near the edges of the field of view and expanded near the middle, thereby forming a distorted image.

As shown by the upper line, pixel location varies nonlinearly for pixel counts equally spaced in time. Accordingly, the desired locations of each of the pixels, shown by the upper line, actually correspond to nonlinearly spaced counts. For example, the first pixel in the upper and lower lines arrives at the zero count and should be located in the zero count location. The second pixel arrives at the 100 count, but, should be positioned at the 540 count location. Similarly, the third pixel arrives at count 200 and is output at count 720. One skilled in the art will recognize that the figure is merely representative of the actual calculation and timing. For example, some output counts will be higher than their corresponding input counts and some counts will be lower. Of course, a pixel will not actually be output before its corresponding data arrives. To address this condition, the system of FIG. 28 actually imposes a latency on the output of data, in a similar fashion to synchronous memory devices. For the example of FIG. 27, a single line latency (3400 count latency) would be ample. With such a latency, the first output pixel would occur at count 3400 and the second would occur at count 3940.

FIG. 29 shows an alternative approach to placing the pixels in the desired locations. This embodiment produces a corrected clock from a pattern generator rather than a counter to control clocking of output data. A synch signal stripper 2500 strips the horizontal synchronization signal from an arriving image signal V_{IM} . Responsive to the synch signal, a phase locked loop 2502 produces a series of clock pulses that are locked to the synch signal. An A/D converter 2504, driven by the clock pulses, samples the video portion of the image signal to produce sampled input data. The sampling rate will depend upon the required resolution of the system. In the preferred embodiment, the sampling rate is approximately 40 Mhz. A programmable gate array 2506 conditions the data from the A/D converter 2504 to produce a set of image data that are stored in a buffer 2508. One skilled in the art will recognize that, for each horizontal synch signal, the buffer will receive one line of image data. For a 1480x1024 pixel display, the system will sample and store 1480 sets of image data during a single period of the video signal.

Once each line of data is stored in the buffer 2508, the buffer is clocked to output the data to a RAMDAC 2509 that includes a gamma correction memory 2510 containing corrected data. Instead of using the buffer data as a data input to the gamma correction memory 2510, the buffer data is used

to produce addressing data to retrieve the corrected data from the gamma correction memory 2510. For example, a set of image data corresponding to a selected image intensity I_1 identifies a corresponding location in the gamma correction memory 2510. Rather than output the actual image data, the gamma correction memory 2510 outputs a set of corrected data that will produce the proper light intensity at the user's eye. The corrected data is determined analytically and empirically by characterizing the overall scanning system, including the transmissivity of various components, the intensity versus current response of the light source, diffractive and aperture effects of the components and a variety of other system characteristics.

In one embodiment shown in FIG. 30 according to the invention, the data may be corrected further for temperature-versus-intensity or age-versus-intensity variations of the light source. Reference data drives the light source while the vertical and horizontal position is out of the user's field of view. For example, at the edge of the horizontal scan, the reference data is set to a predetermined light intensity. A detector 2519 monitors the power out of the light source 2516 and a temperature compensation circuit 2521. If the intensity is higher than the predetermined light intensity, a gain circuit 2523 scales the signal from the RAMDAC 2506 by a correction factor that is less than one. If the intensity is higher than the predetermined light intensity, the correction factor is greater than one. While the embodiments described herein pick off a portion of the unmodulated beam or sample the beam during non-display portions of the scanning period, the invention is not so limited. For example, a portion of the modulated beam can be picked off during the display portion of the scanning period or continuously. The intensity of the picked off portion of the modulated beam is then scaled and compared to the input video signal to determine shifts in the relative intensity of the displayed light versus the desired level of the displayed light to monitor variations.

In addition to monitoring the intensity, the system can also compensate for pattern dependent heating through the same correction data or by multiplying by a second correction factor. For example, where the displayed pattern includes a large area of high light intensity, the light source temperature will increase due to the extended period of high level activation. Because data corresponding to the image signal is stored in a buffer, the data is available prior to the actual activation of the light source 2516. Accordingly, the system can "look-ahead" to predict the amount of heating produced by the pattern. For example, if the light source will be highly activated for the 50 pixels preceding the target pixel, the system can predict an approximate pattern dependent heat effect. The correction factor can then be calculated based upon the predicted pattern dependent heating. Although the correction has been described herein for the intensity generally, the correction in many embodiments can be applied independently for red, green and blue wavelengths to compensate for different responses of the emitters and for variations in pattern colors. Compensating for each wavelength independently can help limit color imbalance due to differing variations in the signal to intensity responses of the light emitters.

Returning to FIG. 29, the corrected data output from the gamma correction memory 2510 (as it may be modified for intensity variations) drives a signal shaping circuit 2514 that amplifies and processes the corrected analog signal to produce an input signal to a light source 2516. In response, the light source 2516 outputs light modulated according to the corrected data from the gamma correction memory 2510. The modulated light enters a scanner 2518 to produce scanned, modulated light for viewing.

The clock signal that drives the buffer **2508**, correction memory **2510**, and D/A converter **2512** comes from a corrected clock circuit **2520** that includes a clock generator **2522**, pattern memory **2524** and rising edge detector **2526**. The clock generator **2522** includes a phase locked loop (PLL) that is locked to a sense signal from the scanner **2518**. The PLL generates a high frequency clock signal at about 80 MHz that is locked to the sense signal. The high frequency clock signal clocks data sequentially from addresses in the pattern memory **2524**.

The rising edge detector **2526** outputs a pulse in response to each 0-to-1 transition of the data retrieved from the pattern memory **2524**. The pulses then form the clock signal CKOUT that drives the buffer output, gamma correction memory **2510**, and D/A converter **2512**.

One skilled in the art will recognize that the timing of pulses output from the edge detector **2526** will depend upon the data stored in the pattern memory **2524** and upon the scanning frequency f_{SCAN} of the scanner **2518**. FIG. **31** shows a simplified example of the concept. One skilled in the art will recognize that, in FIG. **31**, the data structure is simplified and addressing and other circuitry have also been omitted for clarity of presentation.

In the example of FIG. **31**, if the scanning frequency f_{SCAN} is 20 kHz and clock generator **2522** outputs a clock signal at 4000 times the scanning frequency f_{SCAN} , the pattern memory **2524** is clocked at 80 MHz. If all bits in an addressed memory location **2524A** are 0, no transitions of the output clock occur for 16 transitions of the generator clock. For the data structure of location **2524B**, a single transition of the output clock occurs for 16 transitions of the generator clock. Similarly, location **2524C** provides two pulses of the generator clock in one period of the scan signal and location **2524E** provides eight pulses of the generator clock in one period.

The number and relative timing of the pulses is thus controlled by the data stored in the pattern memory **2524**. The frequency of the generator clock on the other hand depends upon the scanner frequency. As the scanner frequency varies, the timing of the pulses thus will vary, yet will depend upon the stored data in the pattern memory.

The approaches of FIGS. **29** and **30** are not limited to sinusoidal rate variation correction. The clock pattern memory **2524** can be programmed to address many other kinds of nonlinear effects, such as optical distortion, secondary harmonics, and response time idiosyncrasies of the electronic and optical source.

Moreover, the basic structure of FIG. **29** can be modified easily to adapt for vertical scanning errors or optical distortion, by inserting a bit counter **2530**, look up table **2532**, and vertical incrementing circuit **2534** before the buffer **2508**, as shown in FIG. **30**. The counter **2530** addresses the look up table **2532** in response to each pulse of the input clock to retrieve two bits of stored data. The retrieved data indicate whether the vertical address should be incremented, decremented or left unaffected. The data in the look up table **2532** is determined empirically by measuring optical distortion of the scanning system and optics or is determined analytically through modeling. If the address is to be incremented or decremented, the incrementing circuit increments or decrements the address in the buffer **2508**, so that data that was to be stored in a nominal memory location are actually stored in an alternate location that is one row higher or lower than the nominal location.

A graphical representation of one such data structure is shown in the simplified example FIG. **32**. In this example,

the first three sets of data bits **3202** for the first line of data (line 0) are stored in the first memory row, the next three sets of data bits **3204** for the first line are stored in the second memory row, and the last three sets of data bits are stored in the third memory row. One skilled in the art will recognize that this example has been greatly simplified for clarity of presentation. An actual implementation would include many more sets of data and may utilize decrementing of the row number as well as incrementing.

The result is that some portion of the data for one line is moved to a new line. The resulting data map in the buffer **2508** is thus distorted as can be seen from FIG. **32**. However, distortion of the data map can be selected to offset vertical distortion of the image caused by scanning and optical distortion. The result is that the overall system distortion is reduced. Although the embodiment of FIG. **30** shows correction of vertical distortion by adjusting the position of data stored in the buffer **2508**, other approaches to this correction may be implemented. For example, rather than adjusting the addresses of the storage locations, the addresses used for retrieving data from the buffer **2508** to the RAMDAC **2509** can be modified.

As noted above, in many applications, it is desirable to control the scanning frequencies of one or more scanners. In non-resonant or low Q applications, simply varying the frequency of the driving signal can vary the scanning frequency. However, in high Q resonant applications, the amplitude response of the scanners may drop off dramatically if the driving signal differs from the resonant frequency of the scanner. Varying the amplitude of the driving signal can compensate somewhat, but the magnitude of the driving signal may become unacceptably high in many cases. Consequently, it is undesirable in many applications to try to control the scanner frequency f_{SCAN} simply by controlling the driving signal frequency and/or amplitude.

One approach to controlling the frequency f_{SCAN} is shown in FIGS. **33** and **34** for a MEMs scanner **3300**. The scanner **3300** includes four tuning tabs **3302A-D** positioned at corners of a mirror body **3304**. The tuning tabs **3302A-D** are flexible projections that are integral to the mirror body **3304**. Fixed rigid projections **3305** project from the mirror body **3304** adjacent to the tuning tabs **3302A-D**, leaving a small gap therebetween.

Each of the tuning tabs **3302A-D** carries a ground electrode **3306** coupled by a conductor **3310** to an external electrode **3312** to form an electrical reference plane adjacent to the respective tab **3302A-D**. Each of the rigid projections **3306A-D** carries a respective hot electrode **3308** controlled by a respective external electrode **3316A-D**, that allows control of the voltage difference between each tuning tab **3302A-D** and its corresponding rigid projection **3306A-D**.

Each flexible tab **3302A-D** is dimensioned so that it bends in response to an applied voltage difference between the tab **3302A-D** and the adjacent rigid projection **3306**, as shown in FIG. **34**. The amount of bending will depend upon the applied voltage, thereby allowing electrical control of tuning tab bending.

One skilled in the art will recognize that the resonant frequency of the scanner **3300** will be a function of the mass of the mirror **3304**, the dimensions and mechanical properties of torsion arms **3317** supporting the mirror **3304**, and the locations **3318** of the centers of mass of each half of the mirror **3304** (including its tabs **3302A-D** and rigid projections **3306**) relative to the axis of rotation of the mirror **3304**. Bending the flexible tabs shifts the centers of mass slightly inwardly from the original locations **3318** to new locations

3320. Because the centers of mass are located closer to the axis of rotation, the scanning frequency increases slightly. Increasing the voltage on the fixed projections **3306** thus can increase the resonant frequency of the scanner **3300**.

The use of electronically controlled elements to control resonance in a scanner is not limited to controlling the horizontal scanning frequency. For example, in the embodiment of FIG. **35**, a mirror body **3500** has interdigitated comb drives **3502** that extend from the body's edges. Comb driven actuators are known structures, being described for example in Tang, et al., ELECTROSTATIC-COMB DRIVE OF LATERAL POLYSILICON RESONATORS, Transducers '89, Proceedings of the 5th International Conference on Solid State Sensors and Actuators and Eurosensors III, Vol. 2, pp. 328-331, June 1990, which is incorporated herein by reference.

Respective conductors **3504** extend from each of the comb drives **3502** to allow tuning voltages V_{tune1} , V_{tune2} to control the comb drives **3502**. As is known, applied voltages produces lateral forces F_1 , F_2 in the comb drives **3502**. Flexible arms **3506** at the distal ends of the comb drives **3502** bend in response to the forces F_1 , F_2 , thereby shifting the mass of the flexible arms **3506** relative to the center of mass **3508** of the respective half of the mirror body. Because the position shift is parallel to the axis of rotation of the mirror body **3500**, the horizontal resonant frequency does not shift significantly. However, if the voltages are set such that the flexible arms experience different position shifts, the mirror body **3500** can be made slightly unbalanced. The mirror body **3500** will then begin to approximate the Lissajous pattern of FIG. **20**. Adjusting the tuning voltages V_{tune1} , V_{tune2} produces a corresponding adjustment in the scan pattern. Where the masses of the flexible portions **3506** and the voltages V_{tune1} , V_{tune2} are chosen appropriately, the resonant frequency of vibrations from the unbalanced mirror body will be an integral multiple of the horizontal scanning frequency and the Lissajous pattern will be stable. By monitoring the scan pattern and adjusting the tuning voltages V_{tune1} , V_{tune2} accordingly, the Lissajous pattern can be kept stable. Thus, the electronically controlled structures can assist in pinch correction.

FIG. **36** shows an alternative approach to controlling the resonant frequency of a scanner **3600**. In this embodiment, the scanner **3600** is housed on a platform **3602** in a sealed package **3604** having a transparent lid **3606**. The package **3604** also contains a gas, such as a helium or argon mix, at a low pressure. The resonant frequency of the scanner **3600** will depend, in part, upon the pressure of within the package **3602** and the properties of the gas, as is described in Baltes et. al., THE ELECTRONIC NOSE IN LILLIPUT, IEEE Spectrum, Sept. 1998, pp. 35-39, which is incorporated here by reference. Unlike conventional sealed packages, the package **3602** includes a pair of outgassing nodules **3610** concealed beneath the platform **3602**.

The nodules **3610** are formed from an outgassing material, such as isopropanol in a polymer, atop a resistive heater **3611**. Electrical current causes resistive heating of the heater **3611**, which, in turn causes the nodule **3610** to outgas. An electronic frequency controller **3614**, controls the amount of outgassing by applying a controlled current through pairs of electrodes **3612** positioned on opposite sides of each of the nodules **3610**. The increased gas concentration reduces the resonant frequency of the scanner **3600**. For greater frequency variation, absorptive polymer segments **3618** coat the scanners torsion arms **3620** to "amplify" the absorptive effect on resonant frequency.

Typically, the above-described variable or "active" tuning approaches are most desirable for producing small fre-

quency variations. For example, such small frequency adjustments can compensate for resonant frequency drift due to environmental effects, aging, or internal heat buildup. To reduce the difficulty of active tuning approaches or to eliminate active tuning entirely, it is desirable in many applications to "tune" the resonant frequency of a scanner to minimize the difference between the scanner's uncompensated resonant frequency and the desired scan frequency. Such frequency differences may be caused by processing variations, material property variations, or several other effects.

FIG. **37** shows one approach to tuning the scanner's uncompensated resonant frequency, in which a scanner **3700** is fabricated with integral tuning tabs **3702A-B**, **3704A-B**, **3706A-B**, **3708A-B**, **3710**, and **3712**. Initially, the scanner's mirror body **3714** and torsional arms **3716** are dimensioned to produce a resonant frequency (with all of the tuning tabs **3702A-B**, **3704A-B**, **3706A-B**, **3708A-B**, **3710**, and **3712** attached) that is slightly below the desired resonant frequency. Once the scanner **3700** is assembled, the resonant frequency can be measured in a variety of fashions. For example, the scanner **3700** can be driven in one of the techniques described previously and the mirror response can be monitored optically. Alternatively, impedance versus frequency measurements may also provide the resonant frequency relatively quickly.

The determined resonant frequency is then compared to the desired resonant frequency to identify a desired frequency compensation. Based upon the identified frequency compensation some of the tuning tabs **3702A-B**, **3704A-B**, **3706A-B**, **3708A-B**, **3710**, and **3712** can be removed, for example by laser trimming or mechanical force to reduce the mass of the mirror body **3714**. As is known, lowering the mass of the mirror body **3714** (in the absence of other variations) will increase the resonant frequency. The number and position of the tabs to be removed for the identified frequency compensation can be determined through modeling or empirical data. Preferably, the removed tuning tabs are positioned symmetrically relative to the center of mass of the respective half of the mirror body and with respect to the axis of rotation of the mirror body **3714**. To make this symmetry easier, the tuning tabs **3702A-B**, **3704A-B**, **3706A-B**, **3708A-B**, **3710**, and **3712** are positioned in the symmetric locations about the mirror body **3714**. For example, tuning tabs **3702A-B** and **3704A-B** form a quartet of tabs that would typically be removed as a group. Similarly, tuning tabs **3710** and **3712** form a pair of tabs that would typically be removed as a pair.

While the tuning tabs **3702A-B**, **3704A-B**, **3706A-B**, **3708A-B**, **3710**, and **3712** in FIG. **37** are shown as equally sized for ease of presentation, it is not always necessary or even desirable to make them the same size. In some applications, such tabs may be variably sized to allow greater flexibility in tuning. In such an embodiment, the sizing of the tabs will be selected to correspond roughly to desired tuning increments.

As is known for MEMs devices, several MEMs scanners **3700** are typically formed on a single substrate. It is therefore desirable and some circumstances to tune the resonant frequency before the substrate is diced. Advantageously, the MEMs scanners **3700** may be tuned while still part of the substrate. In this application, a probe station monitors and outputs from the piezoresistive position sensors to determine the resonant frequency of the scanner **3700**. A microprocessor based controller is coupled to the probe station and determines the difference between the measured resonant frequency and the desired resonant frequency. A software

program in the controller then identifies the corresponding set of tuning tabs **3702A–B**, **3704A–B**, **3706A–B**, **3708A–B**, **3710**, and **3712** and the identified tuning tabs are then removed, for example, through laser ablation. Because each stage of the tuning can be automated, the scanners **3700** can be automatically tuned prior to dicing of the substrate.

As shown in FIG. **38A**, another approach to tuning the resonant frequency of the scanners can be performed before the scanners are separated. In this approach, several scanners **3850** are located on a wafer **3852**. Although only a 18 scanners **3850** are shown on a portion of the wafer **3852**, one skilled in the art will recognize that the entire wafer **3852** may hold many more scanners **3850**. Each of the upper six scanners **3850** includes a set of distributed masses **3854A–F** on an upper surface of its mirror **3856**. (The remaining scanners **3850** include tuning tabs, as described above with reference to FIG. **37**.) As described above, the resonant frequency of each of the respective scanners **3850** will depend upon several factors, including the amount of mass that is offset from the scanner's pivot axis. The masses **3854A–F** will therefore tend to reduce the resonant frequency of the scanners **3850** relative to scanners without such masses.

Once the wafer **3852** is processed to the stage shown in FIG. **38A**, an electrical probe station monitors the resonant frequency of each scanner **3850**. The measured resonant frequency is then compared (either by an automated test program or by a user) to the desired resonant frequency. The user or a test program on a computer then determines the approximate amount of mass to be removed to shift the resonant frequency to the desired resonant frequency.

In one embodiment where the masses **3854A–F** are formed from thin or thick film metals, the determined portions of the masses **3854A–F** are removed by laser ablation. Preferably, the removed portions of the masses **3854A–F** are symmetrically distributed over the face of the mirror **3856** to limit off-axis vibration. In another embodiment, the masses **3854A–F** are formed from a material that outgases in response to an applied heat, such as certain types of commercially available organic polymers. In this embodiment, a heating coil is formed on the mirror surface to heat the material or an input optical beam can be applied to cause heating. Alternatively, where the mirror carries a conductive coil for actuation such as that described in U.S. Pat. No. 5,606,447 to Asada et al. entitled Planar Type Mirror Galvanometer and Method of Manufacture, passing a current through the coil may provide sufficient heat to cause the material to outgas. One skilled in the art will recognize other approaches to removing or adding material to the mirror **3856**, such as selectively depositing a material on the mirror's upper surface. Also, although the process is described as being incremental, i.e., the removed portion of mass is calculated then removed, the process can be continuous. In such an approach, the scanner **3850** is activated and the resonant frequency is monitored while material is removed or added. The material continues to be removed or added until the measured resonant frequency matches the desired resonant frequency.

In another approach to frequency tuning, a block **3870** of a migrating material such as a copper or chromium is formed on each torsion arm **3872** of scanner **3874**. The block can be formed according to conventional integrated circuit processing techniques. As is known, such materials tend to migrate into silicon when heated and change the mechanical properties of the silicon. Thus, the mechanical properties of the torsion arms **3872** will change as the material and silicon are heated, for example through optical energy input by heating the scanner **3874**. Typically, heating the entire scanner **3874**

would be performed after the substrate was diced so that the migration could be controlled independently for individual devices. As the mechanical properties of the torsion arms **3872** change, the resonant frequency of oscillation of a mirror **3876** changes. As with the general procedure described above with respect to FIG. **38A**, a probe station and electronic or user controlled fabrication station can thus shift the resonant frequency from an initial value toward a desired value. In both of the approaches described with reference to FIGS. **38A–B**, an automatic probe station and microprocessor controlled mass removal or heating can automate the process of tuning the resonant frequency of the devices on the wafers, as may be desirable in some applications such as very high volume production.

As described above with respect to FIG. **12**, tiling in two dimensions can allow a large, high resolution display with less demand upon a scanner. FIG. **40** shows one difficulty that may arise when four separate sources **3800**, **3802**, **3804**, **3806** feed a common scanner **3808**. As can be seen from the ray tracing for the lower left scanner **3800**, the upper right source **3804** is positioned within an expected scanning field **3810** of the lower left source **3800**. With no further adjustment, the upper right source **3804** would be expected to occlude a portion of the image from the lower left source **3800**, producing an unilluminated region in the corresponding tile.

FIG. **41** shows one approach in which the effects of overlapping of sources and beams can be reduced. In this embodiment, light arrives through separate fibers **3900**, **3902**, **3904**, **3906** and is gathered and focused by respective GRIN lenses **3908**, **3910**, **3912**, **3914** onto respective turning mirrors **3916**, **3918**, **3920**, **3922**. As is visible for two of the mirrors **3916**, **3922** in FIG. **41**, the turning mirrors **3916**, **3922** are very small mirrors that redirect light from their respective GRIN lenses **3908**, **3914** toward a curved, partially reflective mirror **3924**. The mirror **3924** returns the incident light toward a centrally positioned scanner **3926** that scans periodically, as described previously. The scanned light passes through the partially transmissive mirror **3924** toward an image field **3928** where an image can be viewed.

As can be seen in FIG. **41**, the GRIN lenses **3908**, **3914** gather diverging light from the respective fibers **3900**, **3906** and reduce the beam width to substantially its minimum diameter at the respective turning mirror **3916**, **3922**. The beam **3930** then expands as it travels to the curved mirror **3924**. The curved mirror **3924** converts the expanding beam **3930** into a substantially collimated or slightly converging beam **3932** having a diameter slightly smaller than the mirror width W of the scanner **3926**.

It can be seen in FIG. **41** that the turning mirrors **3916**, **3918**, **3920**, **3922** will block light from other turning mirrors during a portion of their scans. However, because the turning mirrors block only small section of the beams and because the beams converge at the image field **3924**, the effect will be a slight dimming of the corresponding pixel. Uncompensated, this might produce a slight variation from the desired pixel intensity. However, the programmable gate array **2506** described above with respect to FIG. **29** can pre-weight the intensity to offset the dimming effects of the turning mirrors **3916**, **3918**, **3920**, **3922**.

To further improve efficiency the display of FIGS. **39** and **41** can also take advantage of properties of polarized light. In some applications, the fibers **3900**, **3902**, **3904**, **3906** (or other light sources such as laser diodes) emit polarized light. A polarization dependent reflector **3934**, such as 3M's Dual Brightness Enhancement Film coats the inner surface of the

mirror and reflects the polarized incident beam **3930**. As the reflected beam **3932** travels to the scanner **3926**, the beam **3932** passes through a quarter wave plate that rotates the polarization by 45 degrees. The beam **3932** is then reflected by the scanner **3926** and passes through the quarter wave plate once again, so that the polarization rotates by a total of 90 degrees and is orthogonal to the original beam **3930**. The orthogonally polarized beam passes efficiently through the polarization dependent reflector **3934** and travels to the image field **3928**.

FIG. **42** shows how the use of a tiling approach can reduce raster pinch without a correction scanner. In this embodiment, modulated light from an input fiber **4102** enters one or the other of a pair of transmission fibers **4104**, **4106** as dictated by an optical switch **4108**. Light exits the transmission fibers **4104**, **4106** and strikes a common scanner **4110** that scans light from the first fiber **4104** onto a first region **4112** of an image field **4114** and scans light from the second fiber **4106** onto a second region **4116** of the image field **4114**. The fibers **4104**, **4106** are oriented so that the first and second regions **4112**, **4116** overlap very slightly in an overlap area **4118**.

During forward sweeps of the scanner **4110**, an electronic controller **4120** activates the switch **4108** so that light passes through the second fiber **4106**. The scanner **4110** thus redirects the light along a first scan line **4122** in the second region **4116**. At the end of the forward sweep, the controller **4120** activates the switch **4108** so that light now passes through the first fiber **4104** and is scanned along a first scan line **4124** in the first region **4112**. For each subsequent sweep of the scanner **4110**, the controller **4120** activates the switch to produce sets of lines in each of the regions **4112**, **4116**. Because the vertical scan continues during the forward sweeps, the lines may be slightly tilted, as shown in FIG. **42**. While such tilt is typically not observable by a viewer, if desired, custom optics can produce a "counter"-tilt that offsets the scanning tilt. Alternatively, the image data may be pre-distorted by the programmable gate array **2506** described above with respect to FIG. **29** to compensate.

This structure is not limited to two horizontal tiles or to a single light emitter. For example, as shown in FIG. **43**, light from two fibers can be switched into four fibers to produce a 2-by-2 tiled image.

In this approach, an input fiber **4200** is coupled to four fibers **4202**, **4204**, **4206**, **4208** by a set of optical switches **4210**, **4212**, **4214**, where each fiber feeds a scanning assembly **4216** from a respective angle. A switch controller **4220** activates the switches **4210**, **4212**, **4214** according to the direction of the sweep and according to the tracked location of the user's gaze, as provided by a gaze tracker (not shown). The gaze tracker may be any known apparatus for determining gaze direction.

For example, when the user looks at the top half of the image, a first fiber **4206**, aligned to produce an image in the upper left tile **4222** feeds the scanning assembly **4216** during the forward sweeps. A second fiber **4208**, aligned to produce an upper right tile **4224** feeds the scanning assembly **4216** during reverse sweeps. When the user looks at the lower half of the image, a third fiber **4204**, aligned to produce the lower left tile **4226**, feeds scanning assembly **4216** during forward sweeps. A fourth fiber **4202**, aligned to produce the lower right tile **4228**, feeds the scanning assembly **4216** during reverse sweeps. While each of the fibers **4200**, **4206**, **4208**, **4204** is represented as a single fiber, in some applications each fiber **4200**, **4206**, **4208**, **4204** may actually include a plurality of fibers **4200**, **4206**, **4208**, **4204**. In such applica-

tions each fiber **4200**, **4206**, **4208**, **4204** is fed by a plurality of input fibers **4200** and a corresponding plurality of switch sets. Such an embodiment advantageously allows a plurality of lines to be written simultaneously. Writing a plurality of lines simultaneously reduces the frequency of the horizontal scanner relative to the single line writing approaches described above, thereby reducing the difficulty of scanning. Also, providing light simultaneously from a plurality of light emitters reduces the amount of light energy required from each source for a given display brightness and reduces the modulation frequency of the beam. This reduces the performance requirements of the light sources, thereby decreasing the cost and complexity of the overall display.

While the embodiments of FIGS. **42** and **43** have been described herein using fibers and optical switches, in some applications, discrete light sources, such as laser diodes, LEDs, microlasers, or gas lasers may replace each fiber. In such applications, electrical switches (e.g., transistors) selectively control drive currents to the respective sources or control external modulators aligned with the respective sources to control feeding of light during forward and reverse sweeps of the mirror.

Although the invention has been described herein by way of exemplary embodiments, variations in the structures and methods described herein may be made without departing from the spirit and scope of the invention. For example, the varying resonant frequency approaches described herein, both active and passive, may be applied to a variety of MEMs devices other than scanners. Such tuning may be useful in gyroscopes, matched filters, optical switches, or any of a number of other MEMs applications. Additionally, the approaches to varying the mechanical properties of the MEMs material during processing or of shifting the position or amount of mass relative to a fixed point can be applied to variety of devices including non-resonant devices.

Similarly, the positioning of the various components may also be varied in the various imaging systems described herein. In one example of repositioning, the correction scanners can be positioned in the optical path either before or after the other scanners. Also, an exit pupil expander may be added or omitted in many applications. In such embodiments, conventional eye tracking may be added to ease coupling of the scanned beam to the eye. Moreover, the scanning system can be used for projection displays, optical storage and a variety of other scanned light beam applications, in addition to scanned retinal displays. Further, a variety of other timing control mechanisms, such as programmable delays, may be used to compensate for the variable speed of the scanner in place of the approaches described with reference to FIGS. **24-31**. Additionally, in some applications it may be desirable for ease of positioning or for other reasons to use a plurality of scanners, each of which may be fed by one or more beams. In such a structure, each scanner and its corresponding light sources produce respective sets of tiles. The overall image is then formed by combining the sets of tiles from each of the scanners, either by adjacent positioning or by overlapping. Although overlapping is generally preferred only where each scanner is used for a respective wavelength, in some applications overlapping may be used for interlacing or other approaches to image combination.

In another alternative approach to timing and distortion correction, the memory map may be undistorted and addressed at a constant rate. To compensate for nonlinearity of the scanner, the data for each location is derived from the retrieved image data and output at fixed increments. Referring to FIG. **27**, for example, data would be output at a time

1500, even though this time did not correspond directly to a pixel time. To compensate, the buffer 2508 is addressed at the 10th and 11th locations for this line. Then, the output data is a weighted average of the data from the 10th and 11th locations. Thus, the buffer 2508 is clocked at a constant rate and pixels are output at a constant rate. Yet, by controlling the addressing circuitry carefully and performing a weighted averaging, the output data is sinusoidally corrected. Also, although the light emitters and light sources described herein utilize laser diodes or LEDs, with or without fibers, a variety of other light emitters such as microlasers, gas lasers, or other light emitting devices may be desirable in some applications. Moreover, although the exemplary scanning assemblies described herein utilize torsionally mounted mirrors, other scanning assembly structures, such as spinning polygons, comb drive mirrors, acousto-optic scanners, and other scanning structures may be within the scope of the invention. Also, while the beams are shown as converging upon a single scanner, in some applications it may be desirable to use separate scanners for each beam of light or to use a plurality of scanners that each reflect a plurality of beams. Accordingly, the invention is not limited except as by the appended claims.

What is claimed is:

1. An apparatus for producing a plurality of resonant optical MEMS scanners from a single wafer, each MEMS scanner having a movable body that moves at a desired resonant frequency and carries one or more removable masses, comprising:

a first electrical signal source configured for coupling to each respective MEMS scanner while the MEMS scanner is an integral part of the wafer, the first signal source being operative to produce a first input signal for activating the respective optical scanner;

a position sensor coupled to the movable body of the respective MEMS scanner and operative to produce an electrical signal indicative of movement of the movable body while the MEMS scanner is an integral part of the wafer;

a reference signal source operative to produce a reference signal at the desired resonant frequency;

an electronic controller coupled electrically to the position sensor and the reference signal source, the controller

being operative to produce an error signal indicative of a difference between a frequency of movement of the movable body and the desired resonant frequency; and a mass removal apparatus responsive to the electronic controller to remove selected portions of the removable masses while the respective MEMS scanner is an integral part of the wafer.

2. The optical scanner of claim 1 wherein the removable masses are formed from a deposited material on respective exposed regions of the movable masses.

3. The optical scanner of claim 1 wherein the wafer comprises is a semiconductor.

4. The optical scanner of claim 1 wherein the removable masses are formed from an organic polymer.

5. A method of producing a plurality of resonant optical MEMS scanners from a wafer, each MEMS scanner having a movable body, comprising:

photolithographically patterning the wafer to define a plurality of the moving bodies;

activating each of the defined movable bodies for periodic motion while the movable body is attached to the wafer;

monitoring a resonant frequency for each of the activated movable bodies while the movable body is activated;

for each of the monitored movable bodies, determining a deviation of the monitored resonant frequency from a desired resonant frequency; and

for each of the monitored movable bodies, removing a portion of the respective movable body, wherein the mass of the removed portion is a function of the determined deviation of the monitored resonant frequency from the desired resonant frequency.

6. The method of claim 5 wherein removing a portion of the respective movable body includes laser ablation.

7. The method of claim 5 further including defining a set of discrete elements on each of the photolithographically defined moving bodies, and wherein removing a portion of the respective movable body includes removing selected ones of the discrete elements.

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